

# The World's Most Trusted





Test Probes and Interconnect Products









**2023 CATALOG** 





# **Customer Service and Shipping and Delivery**

#### **Customer Service**

The QA support team, equipped with extensive customer, industry and product experience, provides highly personalized advice and guidance in all aspects of product support including design, quality, applications and orders. We pride ourselves in responding to customer questions with information and solutions in a timely and professional manner.

### For technical support, call us at (603) 926-1193 For direct sales assistance, call (603) 926-0348



Steve Kayal General Manager



Jeff Smith Director of Global Sales



Gabriel Gonzalez Regional Sales Manager



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Kara Mathews **Customer Service** Coordinator



Wendy Bongers Marketing Specialist



Matt Parker Product Engineer



Leah Hudson Product Design Engineer



Mike Cestone Quality Manager



Jeff Brown Product Engineer, integraMate

## Shipping and Delivery

QA recognizes speed of delivery as a critical factor in our customer's success. Our bar code and order verification system enables us to ship our products quickly and accurately. Most orders are shipped the same day and can be delivered within 24 hours.

Our shipping department is designed to expedite the delivery of customer orders by utilizing virtually any carrier. Our volumes guarantee competitive discount rates both domestically and internationally.

QA's capabilities include "in-house" tracking of FedEx®, UPS®, DHL® or any other carrier you choose.

Our products are double packaged for safe delivery. We are also capable of meeting certain customer packaging specifications.

Call customer service at (603) 926-0348 for more information.

## **Typical Shipping Weights for Cost Comparison**

PROBES	WEIGHT		
1,000 pcs.	less than 1.0 lb. [0.45 kg]		
3,000 pcs.	less than 2.0 lb. [0.91 kg]		
5,000 pcs.	less than 5.0 lb. [2.27 kg]		
10,000 pcs.	less than 10 lb. [4.54 kg]		
SOCKETS	WEIGHT		
3,000 pcs.	less than 2.0 lb. [0.91 kg]		
10,000 pcs.	less than 10 lb. [4.52 kg]		

## **Payment Methods**











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WILCIESS ICIIIIIIAUUIIS		



## integraMate® Hyperboloid Contacts



QA Technology's integraMate® hyperboloid contacts are designed to meet the demanding requirements of connector manufacturers, cable assemblers and OEMs in today's military and aerospace, medical equipment, scientific instrument, telecommunications and other industries – where the reliability of signal and power connections is non-negotiable.

## **More Compact**

integraMate's reduced diameter allows them to fit into today's smaller connector platforms. Discrete contacts are available for connectors in mating pin sizes from 0.4mm diameter up to 1.5mm diameter (1.0A to 12.0A), for mounting spacing as small as 1.0mm from center to center. Contacts are also available in a family of latching circular connectors with 3, 7, 9 and 14 positions.

## **More Dependable**

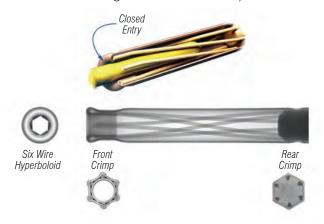
integraMate® contacts are extraordinarily resistant to shock and vibration. A single wall, deep drawn tube with an integral "return" delivers better protection of the hyperbolic wire cage. Lower, more uniform insertion and extraction forces mean high pin count connectors can be mated by hand. integraMate contacts also have low electrical resistance, a longer cycle life, and high resistance to fretting corrosion.

#### **More Choice**

QA Technology's automated assembly system enables a wide range of insulator design, termination needs and preferences for contact retention and loading. ICS contacts can be configured to be fixed, removable, loaded from the mating face or rear loaded. Terminations can include solder cup, crimp, straight and right-angle PCB, square post, etc.

#### SIGNAL CONTACTS

integraMate ICS series signal contacts are shorter and smaller in diameter than earlier hyperboloid contacts. The simplified, less expensive design allows ICS sockets to be used in high density board-level connectors (as well as in circular and rectangular I/O Connectors).



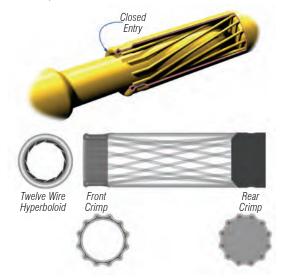


#### **APPLICATIONS**

- Medical and Dental Equipment
- Scientific Instruments
- Industrial Equipment
- Transportation Equipment
- ATE Interfaces
- Military and Aerospace
- Telecommunications and **Data Communications**

#### POWER CONTACTS

integraMate® ICO Series Power contacts use a 12-wire cage to provide higher current carrying and very low insertion/extraction force.



## **Termination and Mounting Flexibility**

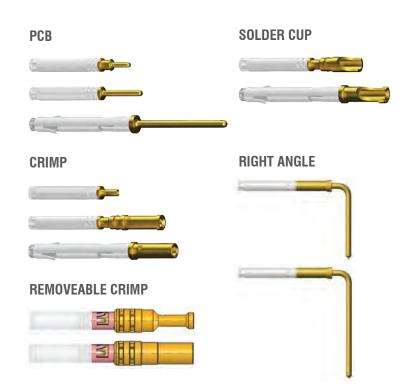
Custom terminations to suit specific applications can be readily available due to QA's "state of the art" automation equipment.

Contacts are available for front and rear loaded connector designs and in removable versions. Please contact QA Technology integraMate® Applications Engineering for assistance with your next high performance connector design.

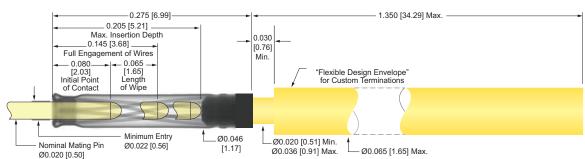
You will be pleasantly surprised to see how easy it is to use the best pin and socket design for your new connector.

#### **MATCHING MATING PINS**

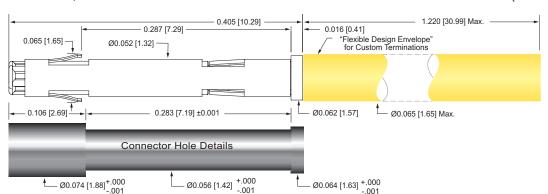
Matching screw machined pins with custom terminations are also available for your connector design. QA's in-house CNC Swiss turning capability means design flexibility and fast turnaround times.



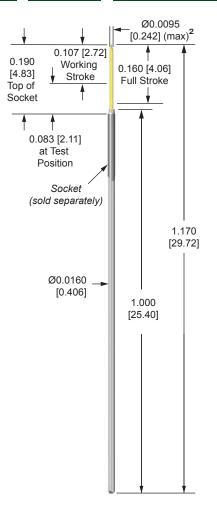
## PRESS-FIT SOCKET – FLEXIBLE DESIGN ENVELOPE FOR CUSTOM TERMINATIONS (TYPICAL)

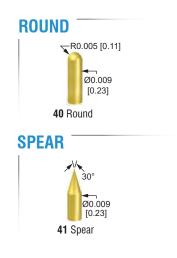


#### REMOVABLE SOCKET, REAR LOADED – FLEXIBLE DESIGN ENVELOPE FOR CUSTOM TERMINATIONS (TYPICAL)

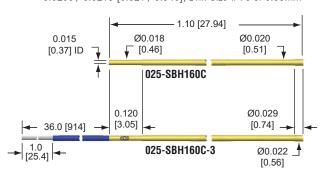








Suggested mounting holes and drill sizes in AT7000, G10/FR4 or similar materials should be gauged at: 0.0205 / 0.0215 [0.521 / 0.546]; Drill Size #75 or 0.55mm



## **SOCKET P/N 025-SBH160C-** example: 025-SBH160C-3

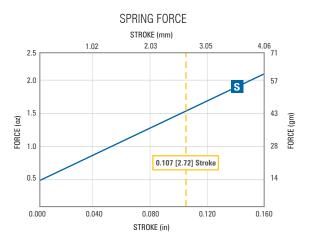
Tube	Letter	Material/Finish
르	Н	Phos Bronze/ID & OD precious metal clad
Term.		Material/Finish
<u>le</u>	С	Crimp
		Spring Force
Option	3	30 AWG Blue Kynar insulated solid wire 36 [914] length pre-attached with 1.0 [25.4] stripped end.
	(Blank)	No option required

US Patent No. 4,885,533

## **PROBE P/N 025-PRP16** example: 025-PRP1641S

Tube	Letter	Material/Finish		Average Resistance	Current Rating AMPS <sup>1</sup> 120°C (204°C) <sup>3</sup>						
-	Р	Nickel silver/ID	precious metal clad	< 100  mOhms	2.7 (3.7)3						
yle	Digits	Material/Finish									
Tip Style	See Tips	Heat treated BeCu/plated gold over nickel									
Spring	Letter	Spring Force	Preload	@ 0.107 [2.72] Stroke	Material	Cycle Life @ 0.107 [2.72] Stroke					
Š	S	Standard	0.5 [14g/0.14N]	1.6 [45g/0.44N]	MW	1,000,000					
		Description									
Option	N	No probe lubrication. Removing lubrication greatly reduces cycle life and should only be used in applications outside of the working temperature range, see Testing in Extreme Working Temperatures application note for more details. <sup>3</sup>									
	(Blank)	No option requ	ired								

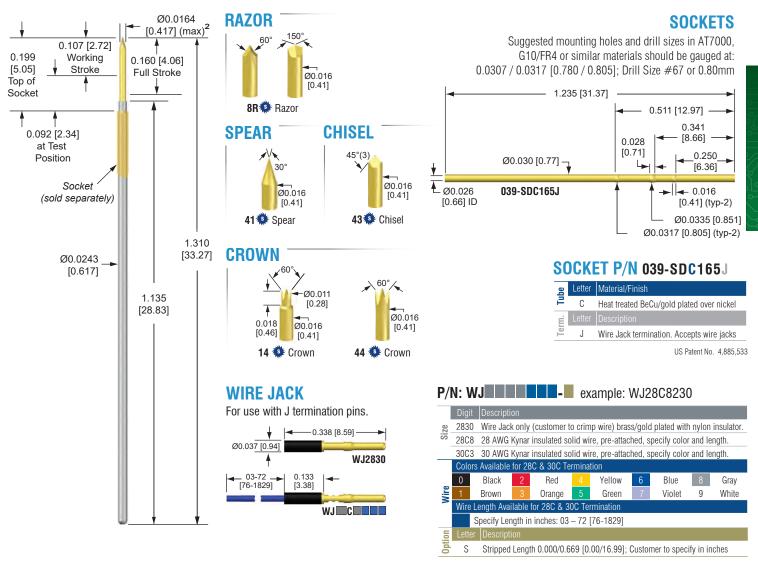
<sup>&</sup>lt;sup>1</sup> Current rating is affected by spring material and lubrication choice. Please refer to Current Carrying Capacity and Testing in Extreme Working Temperature applications notes for more details.



#### **TOOLS & ACCESSORIES**

<sup>&</sup>lt;sup>2</sup> Maximum plunger OD should be used to calculate minimum guide plate clearance holes.

<sup>&</sup>lt;sup>3</sup> Working Temperature Range: -5°C to 120°C with lubrication. SS springs can be used up to 204°C without lubrication.

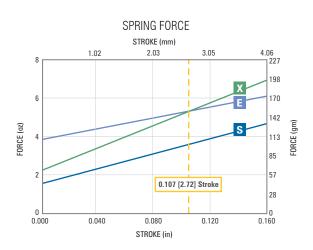


## **PROBE P/N 039-PRP16** example: 039-PRP1643X-S

Tube	Letter	Material/Finish		Average Resistance	Current Rating AMPS <sup>1</sup> 120°C (204°C) <sup>3</sup>	
_	Р	Nickel silver/ID	precious metal clad	t	< 165  mOhms	3.1 (4.2)3
yle	Digits	Material/Finish				
Tip Style	See Tips	Heat treated ste	eel/plated gold over			
	Letter	Spring Force	Preload	@ 0.107 [2.72] Stroke	Material	Cycle Life @ 0.107 [2.72] Stroke
Springs	S	Standard	1.5 [43g/0.42N]	3.6 [102g/1.00N]	MW	1,000,000
S	Χ	Extra	2.2 [62g/0.61N]	5.4 [153g/1.50N]	MW	75,000
	Ε	High Preload	3.8 [108g/1.06N]	5.4 [153g/1.50N]	MW	100,000
		Description				
Option	N	applications ou		orication greatly reduces emperature range, see T		
	S	Heat treate	d steel/plated gold o	over nickel (see tip style	for availability)	
	(Blank)	No option requ	ired			

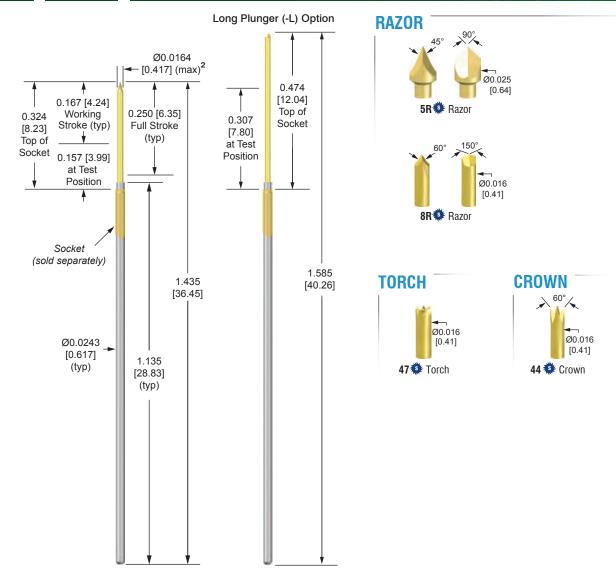
<sup>&</sup>lt;sup>1</sup> Current rating is affected by spring material and lubrication choice. Please refer to Current Carrying Capacity and Testing in Extreme Working Temperature applications notes for more details

<sup>&</sup>lt;sup>3</sup> Working Temperature Range: -45°C to 120°C with lubrication. SS springs can be used up to 204°C without lubrication.



#### **TOOLS & ACCESSORIES**

<sup>&</sup>lt;sup>2</sup> Maximum plunger OD should be used to calculate minimum quide plate clearance holes.



# **PROBE P/N 039-PRP25** example: 039-PRP2543H-S

Tube	Letter	Material/Finish	ı		Average Resistance	Current Rating AMPS <sup>1</sup> 120°C (204°C) <sup>3</sup>					
_	Р	Nickel silver/I	D precious metal cla	ad	< 65 m0hms	3.1 (4.3)3					
yle	Digits	Material/Finish	1								
Tip Style	See Tips	Standard material is heat treated BeCu/plated gold over nickel. (see S option for steel plungers)									
		Spring Force	Preload	@ 0.167 [4.24] Stroke	Material	Cycle Life @ 0.167 [4.24]Stroke					
Springs	S	Standard	1.5 [43g/0.42N]	3.6 [102g/1.00N]	MW	1,000,000					
Spr	Н	High	2.2 [62g/0.62N]	5.4 [153g/1.50N]	SS	50,000					
	Υ	Elevated	1.5 [43g/0.42N]	8.0 [227g/2.22N]	SS	25,000					
	Letter	Description									
	L	Long plunger.	Must select from 03	39-40 tip styles							
Option	N	No probe lubrication. Removing lubrication greatly reduces cycle life and should only be used in applications outside of the working temperature range, see Testing in Extreme Working Temperatures application note for more details. <sup>3</sup>									
	S	# Heat treate	ed steel/plated gold	over nickel (see tip style	e for availability	')					
	(Blank)	No option requ	uired								

<sup>&</sup>lt;sup>1</sup> Current rating is affected by spring material and lubrication choice. Please refer to Current Carrying Capacity and Testing in Extreme Working Temperature applications notes for more details.

#### SPRING FORCE STROKE (mm) 0.00 1.27 5.08 6.35 10 283 227 FORCE (oz) 170 113 57 0.167 [4.24] Stroke 0.000 0.050 0.250 STROKE (in)

Ø0.016

[0.41]

Ø0.016

R0.008 [0.20]

Ø0.016

[0.41]

40 Round

[0.41]

6R Razor

9R Razor

**ROUND** 

#### **TOOLS & ACCESSORIES**

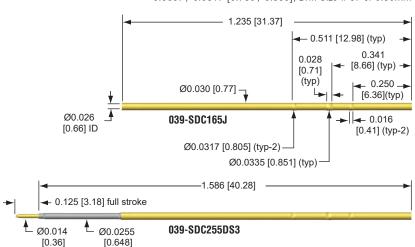
<sup>&</sup>lt;sup>2</sup> Maximum plunger OD should be used to calculate minimum guide plate clearance holes.

<sup>&</sup>lt;sup>3</sup> Working Temperature Range: -45°C to 120°C with lubrication. SS springs can be used up to 204°C without lubrication.

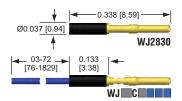
#### **CHISEL** 45°(3) 25°(3) Ø0.016 Ø0.016 [0.41] [0.41] 43 🏶 Chisel 63 🏶 Chisel

#### **SOCKETS**

Suggested mounting holes and drill sizes in AT7000, G10/FR4 or similar materials should be gauged at: 0.0307 / 0.0317 [0.780 / 0.805]; Drill Size #67 or 0.80mm



## **WIRE JACK** For use with J termination pins.



## P/N: WJ example: WJ28C8230

	Digit	Descripti	Description									
ize	2830	Wire Jacl	Wire Jack only (customer to crimp wire) brass/gold plated with nylon insulator.									
S	28C8	28 AWG	28 AWG Kynar insulated solid wire, pre-attached, specify color and length.									
	30C3	30 AWG	30 AWG Kynar insulated solid wire, pre-attached, specify color and length.									
	Color	s Available	for 28	C & 30C Te	rmina	tion						
	0	Black	2	Red		Yellow	6	Blue	8	Gray		
Wire	1	Brown	3	Orange	5	Green	7	Violet	9	White		
_	Wire	Length Avai	lable	for 28C & 30	OC Te	rmination						
		Specify Ler	igth in	inches: 03	- 72	[76-1829]						
lon	1 7 0											
Option	S	Stripped	Lengt	h 0.000/0.6	69 [0	.00/16.99];	Custor	mer to speci	fy in ir	nches		

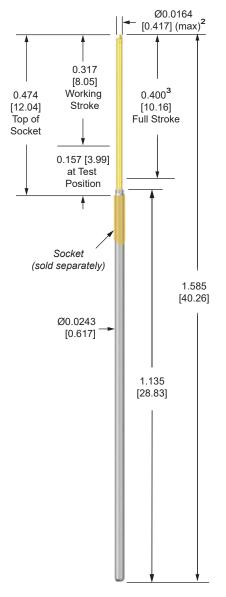
## **SOCKET P/N**

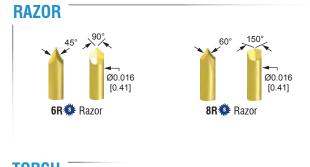
US Patent No. 4,885,533

**039-SDC165** example: 039-SDC165J

Tube	Letter	Material/Finish
₽	С	Heat treated BeCu/gold plated over nickel
Term.	DS3	Double-ended for wireless testing. See page 42 for ordering details.
_	J	Wire Jack termination. Accepts wire jacks





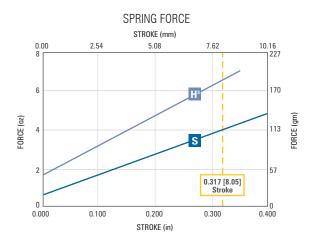




## PROBE P/N 039-PRP40 example: 039-PRP406RS-S

Tube	Letter	Material/Finisl	າ		Average Resistance	Current Rating AMPS <sup>1</sup> 120°C (204°C) <sup>4</sup>				
_	Р	Nickel silver/II	O precious metal cl	ad	< 75 m0hms	2.6 (3.6)4				
yle	Digits	Material/Finisl								
Tip Style	See Tips	Heat treated steel/plated gold over nickel								
S	Letter	Spring Force	Preload	@ 0.317 [8.05] Stroke	Material	Cycle Life @ 0.317 [8.05]Stroke				
Springs	S	Standard	0.7 [20g/0.19N]	4.0 [113g/1.11N]	SS	50,000				
S	H <sup>3</sup>	High	1.8 [51g/0.50N]	6.0 [170g/1.67N]	SS	50,000				
		Description								
Option	N	No probe lubrication. Removing lubrication greatly reduces cycle life and should only be used in applications outside of the working temperature range, range, see Testing in Extreme Working Temperatures application note for more details.4								
0	S	# Heat treate	ed steel/plated gold	over nickel (see tip style	for availability)					
	(Blank)	No option requ	uired							

<sup>&</sup>lt;sup>1</sup> Current rating is affected by spring material and lubrication choice. Please refer to Current Carrying Capacity and Testing in Extreme Working Temperature applications notes for more details.



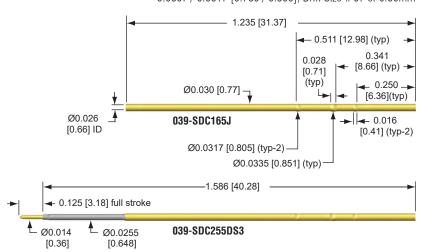
#### **TOOLS & ACCESSORIES**

<sup>&</sup>lt;sup>2</sup> Maximum plunger OD should be used to calculate minimum guide plate clearance holes.

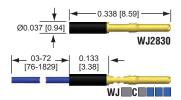
<sup>3 0.350 [8.89]</sup> max stroke for H spring.

<sup>&</sup>lt;sup>4</sup> Working Temperature Range: -45°C to 120°C with lubrication. SS springs can be used up to 204°C without lubrication.

Suggested mounting holes and drill sizes in AT7000, G10/FR4 or similar materials should be gauged at: 0.0307 / 0.0317 [0.780 / 0.805]; Drill Size #67 or 0.80mm



## **WIRE JACK** For use with J termination pins.



## P/N: WJ example: WJ28C8230

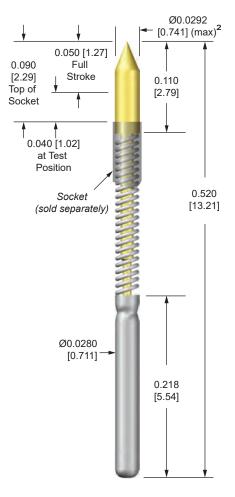
	Digit	Descripti	Description									
ize	2830	Wire Jacl	Wire Jack only (customer to crimp wire) brass/gold plated with nylon insulator.									
S	28C8	28 AWG	28 AWG Kynar insulated solid wire, pre-attached, specify color and length.									
	30C3	30 AWG	30 AWG Kynar insulated solid wire, pre-attached, specify color and length.									
	Color	s Available	for 28	C & 30C Te	rmina	tion						
	0	Black	2	Red		Yellow	6	Blue	8	Gray		
Wire	1	Brown	3	Orange	5	Green	7	Violet	9	White		
_	Wire I	Length Avai	ilable f	for 28C & 30	OC Te	rmination						
		Specify Ler	ngth in	inches: 03	- 72	[76-1829]						
ion	Letter Description											
Option	S	Stripped	Lengt	h 0.000/0.6	69 [0	.00/16.99]; (	Custor	ner to speci	fy in i	nches		

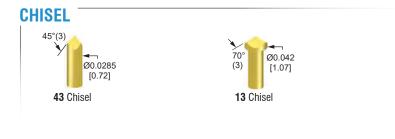
## **SOCKET P/N**

US Patent No. 4,885,533

**039-SDC165** example: 039-SDC165J

Tube	Letter	Material/Finish
₽	С	Heat treated BeCu/gold plated over nickel
erm.	DS3	Double-ended for wireless testing. See page 42 for ordering details.
	J	Wire Jack termination. Accepts wire jacks





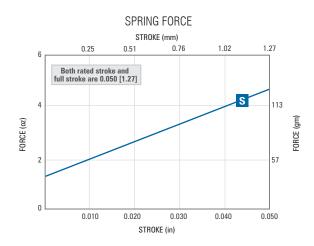




## PROBE P/N 050-PLP05 example: 050-PLP0513S

Tube	Letter	Material/Finish	ı		Average Resistance	Current Rating AMPS <sup>1</sup> 120°C (204°C) <sup>3</sup>				
_	Р	Nickel silver/I	D precious metal cla	ad	< 25 m0hms	3.7 (5.2)3				
yle	Digits	Material/Finish								
Tip Style	See Tips	Heat treated BeCu/plated gold over nickel								
Spring		Spring Force	Preload		Material	Cycle Life @ 0.050 [1.27] Stroke				
Sp	S	Standard	1.3 [37g/0.36N]	4.6 [130g/1.28N]	MW	1,000,000				
		Description								
Option	N	No probe lubrication. Removing lubrication greatly reduces cycle life and should only be used in applications outside of the working temperature range, see Testing in Extreme Working Temperatures application note for more details. <sup>3</sup>								
	(Blank)	No option requ	uired							

<sup>&</sup>lt;sup>1</sup> Current rating is affected by spring material and lubrication choice. Please refer to Current Carrying Capacity and Testing in Extreme Working Temperature applications notes for more details.

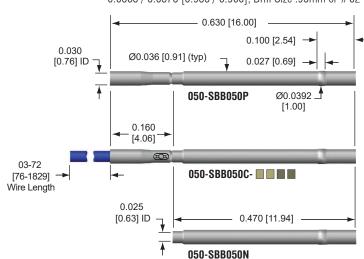


#### **TOOLS & ACCESSORIES**

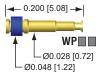
<sup>&</sup>lt;sup>2</sup> Maximum plunger OD should be used to calculate minimum guide plate clearance holes.

 $<sup>^3</sup>$  Working Temperature Range:  $-5^{\circ}$ C to  $120^{\circ}$ C with lubrication. SS springs can be used up to  $204^{\circ}$ C without lubrication.

Suggested mounting holes and drill sizes in AT7000, G10/FR4 or similar materials should be gauged at: 0.0368 / 0.0378 [0.935 / 0.960]; Drill Size .95mm or #62



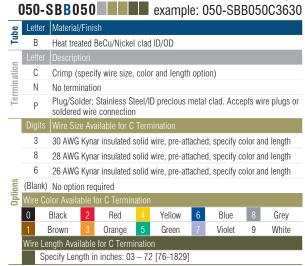
WIRE PLUG For use with P termination sockets.



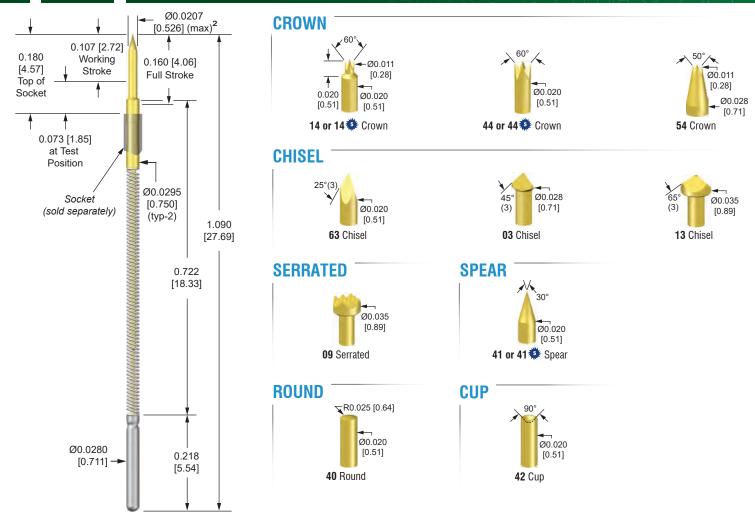
## P/N: WP example: WP30

	Digits	Description
ig Size	28	Brass/plated gold over nickel with red insulating sleeve.To accept 28 AWG Kynar insulated solid wire (not included), stripped at 0.120 [3.05]
Plug	30	Brass/plated gold over nickel with blue insulating sleeve. To accept 30 AWG Kynar insulated solid wire (not included), stripped at 0.120 [3.05]

## **SOCKET P/N**



US Patent No. 4.659.987 & 4.597.622

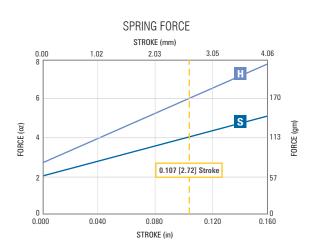


rent Rating AMPS 120°C (204°C)³
4.9 (7.4)3

Tip St	See Tips	Standard mate	Standard material is heat treated BeCu/plated gold over nickel (see S option for steel plungers)								
g						Cycle Life @ 0.107 [2.72] Stroke					
Spring	S	Standard	2.0 [57g/0.56N]	4.0 [113g/1.11N]	MW	1,000,000					
S	Н	High	2.7 [77g/0.75N]	6.1 [173g/1.70N]	MW	1,000,000					
		Description									
ption	N	applications o				should only be used in reme Working Temperatures					

(Blank) No option required <sup>1</sup> Current rating is affected by spring material and lubrication choice. Please refer to Current Carrying Capacity and Testing in Extreme Working Temperature applications notes for more details.

Heat treated steel/plated gold over nickel (see tip style for availability)

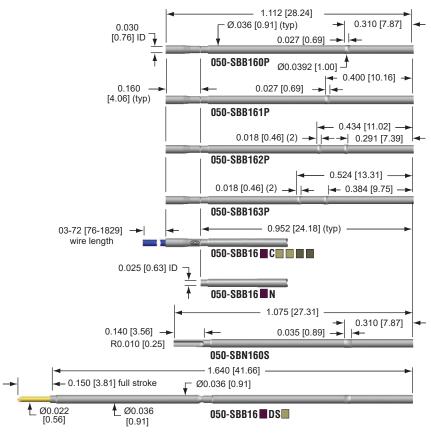


#### **TOOLS & ACCESSORIES**

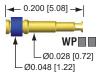
<sup>&</sup>lt;sup>2</sup> Maximum plunger OD should be used to calculate minimum guide plate clearance holes.

<sup>&</sup>lt;sup>3</sup> Working Temperature Range: -5°C to 120°C with lubrication. SS springs can be used up to 204°C without lubrication.

Suggested mounting holes and drill sizes in AT7000, G10/FR4 or similar materials should be gauged at: 0.0368 / 0.0378 [0.935 / 0.960]; Drill Size .95mm or #62



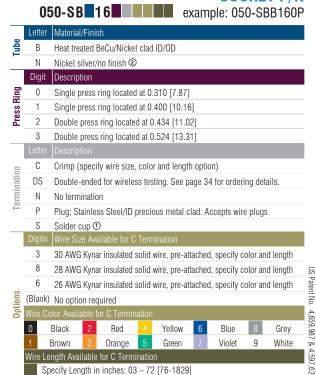
## WIRE PLUG For use with P termination sockets.



## P/N: WP example: WP30

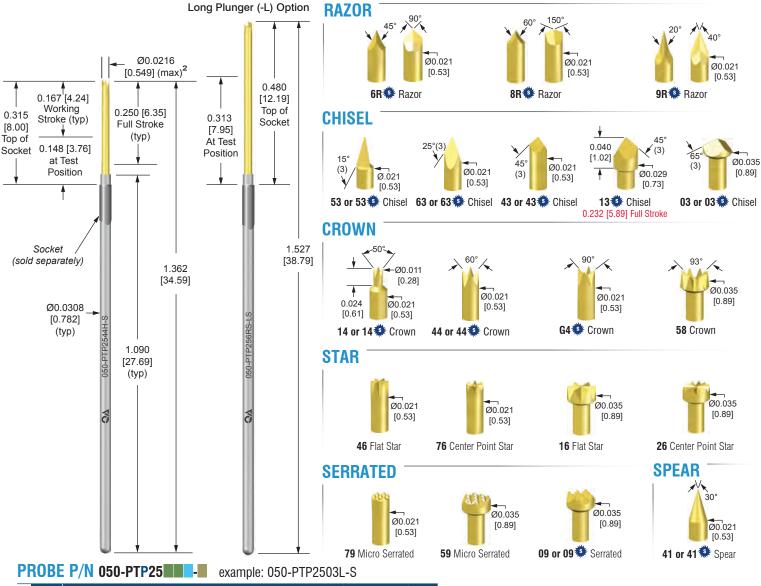
	Digits	Description
Plug Size	28	Brass/plated gold over nickel with red insulating sleeve. To accept 28 AWG Kynar insulated solid wire (not included), stripped at 0.120 [3.05]
	30	Brass/plated gold over nickel with blue insulating sleeve. To accept 30 AWG Kynar insulated solid wire (not included) stripped at 0.120 [3.05]

## **SOCKET P/N**



NOTES: ① Available only in N Tube Material ② Available only with S Termination

# **050-T25 Series** 0.050 [1.27] Centers | 0.250 [6.35] Full Stroke



Tube	Letter	Material/Finish	ı		Average Resistance	Current Rating AMPS <sup>1</sup> 120°C (204°C) <sup>3</sup>					
_	Р	Nickel silver/I	) precious metal clad	i	< 30 m0hms	4.5 (6.2)3					
yle	Digits	Material/Finish	1								
Tip Style	See Tips	Standard material is heat treated BeCu/plated gold over nickel. (see S option for steel plungers)									
	Letter	Spring Force	Preload	@ 0.167 [4.24] Stroke	Material	Cycle Life @ 0.167 [4.24] Stroke					
	L	Low	1.2 [34g/0.33N]	3.0 [85g/0.83N]	MW	1,000,000					
6	S	Standard	1.1 [31g/0.31N]	4.3 [122g/1.20N]	MW	1,000,000					
Spring	Н	High	2.4 [68g/0.67N]	5.6 [159g/1.56N]	MW	1,000,000					
03	Υ	Elevated	3.2 [91g/0.89N]	8.0 [227g/2.22N]	SS	25,000					
		High Preload S	Spring – <i>Only availab</i>	le with headless 🥵 ste	el tip styles.						
	Е	High Preload	4.2 [119g/1.17N]	8.0 [227g/2.22N]	SS	10,000					
		Description									
	L	Long plunger.	Must select from 05	0-T40 tip styles							
Option	N	No probe lubrication. Removing lubrication greatly reduces cycle life and should only be used in applications outside of the working temperature range, see Testing in Extreme Working Temperatures application note for more details. <sup>3</sup>									
	S	# Heat treate	d steel/plated gold o	over nickel (see tip style	for availability)						
	(Blank)	No option requ	iired								

STROKE (mm) 0.00 5.08 6.35 10 283 227 FORCE (oz) FORCE (gm 170 113 57 0.167 [4.24] Stroke 0.100 0.150 0.000 0.050 0.200 0.250 STROKE (in)

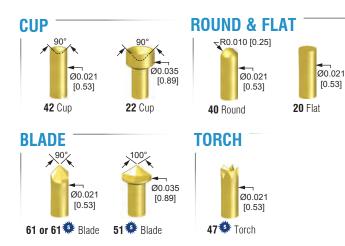
SPRING FORCE

#### **TOOLS & ACCESSORIES**

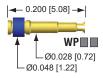
<sup>&</sup>lt;sup>1</sup> Current rating is affected by spring material and lubrication choice. Please refer to Current Carrying Capacity and Testing in Extreme Working Temperature applications notes for more details.

<sup>&</sup>lt;sup>2</sup> Maximum plunger OD should be used to calculate minimum guide plate clearance holes.

<sup>&</sup>lt;sup>3</sup> Working Temperature Range: -55°C to 120°C with lubrication. SS springs can be used up to 204°C without lubrication.



## WIRE PLUG For use with P termination sockets.



## P/N: WP example: WP30

	Digits	Description
g Size	28	Brass/plated gold over nickel with red insulating sleeve.To accept 28 AWG Kynar insulated solid wire (not included), stripped at 0.120 [3.05]
Plug	30	Brass/plated gold over nickel with blue insulating sleeve. To accept 30 AWG Kynar insulated solid wire (not included), stripped at 0.120 [3.05]

## WIRE GRIP SLEEVE For use with G termination sockets.

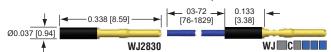


#### P/N: WG50

#### Description

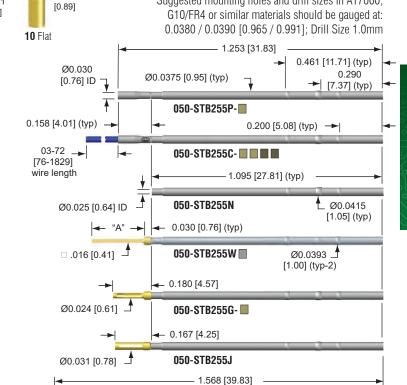
To accept customer supplied 28AWG or 30AWG Kynar solid insulated wire, stripped at 0.120 [3.05]. Nylon sleeve, white

## WIRE JACK For use with J termination pins.



#### P/N: WJ example: WJ28C8230

- GAGITIPIC. W02000200										
	Digit	Descripti	on							
Size	2830	Wire Jack only (customer to crimp wire) brass/gold plated with nylon insulator.								
S	28C8	28 AWG Kynar insulated solid wire, pre-attached, specify color and length.								
	30C3	30C3 30 AWG Kynar insulated solid wire, pre-attached, specify color and length.								
	Colors	Available	for 28	C & 30C Te	rmina	tion				
	0	Black	2	Red	4	Yellow	6	Blue	8	Gray
Wire	1	Brown	3	Orange	5	Green	7	Violet	9	White
_	Wire L	ength Avai	lable f	or 28C & 3	OC Tei	mination				
	Specify Length in inches: 03 – 72 [76-1829]									
ion	Letter	Descripti	ion							
Option	S	Stripped	Lengtl	h 0.000/0.6	69 [0.	00/16.99]; (	Custor	ner to speci	fy in in	ches



050-STB255DS

0.150 [3.81] full stroke

Ø0.036

[0.91]

Ø0.022

[0.56]

Ø0.035

#### **SOCKET P/N**

SOCKETS

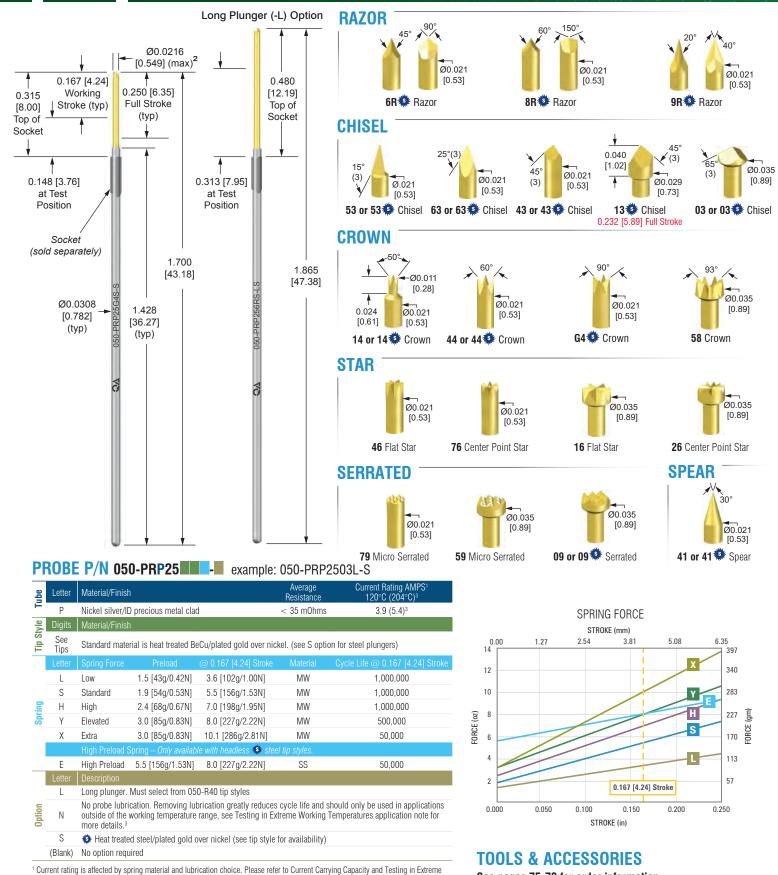
Suggested mounting holes and drill sizes in AT7000,

CTD 2FF

U	50-8	TB255			exampl	e: (	)50-ST	B25	5C363C	
pe	Letter	Material/Fini:	sh							
Tube	В	Heat treated	BeCu/Nickel	plat	ed					
	Letter									
	С	Crimp (specify wire size, color and length option)								
	DS	Double-ende	d for wireles	s tes	sting. See pa	ge 4	2 for orde	ring det	ails.	
ion	G	Wire grip; Bel	Cu/gold plate	d ov	er nickel. Ac	cepts	wire grip	sleeve.		
Termination	J	Wire jack; Be	Cu/gold plate	ed ov	er nickel. Ac	cepts	wire jacks	S.		
Leru.	N	No termination								
_	Р	Plug/Solder; Stainless Steel/ID precious metal clad. Accepts wire plugs or soldered wire connection								
	W	Square wire v	vrap pin; Be	Cu/g	old plated o	ver n	ickel	0.250	[6.35]	
	W1	Square wire v	vrap pin; Be	Cu/g	old plated o	ver n	ickel	0.400	[10.16]	
	Digits	Digits Description								
	Availabl	ole with P Termination Only								
	0	050-STB255P with WP30 wire plug								
	8	050-STB255P with WP28 wire plug								
		le with G Termination Only								
1	3	050-STB255G with WG50 wire grip sleeve								
	Digits	Wire Size Available for C Termination								
Options	3	30 AWG Kynar insulated solid wire, pre-attached, specify color and length								
d	8	28 AWG Kynar insulated solid wire, pre-attached, specify color and length								
	6	26 AWG Kyna		olid	wire, pre-atta	ache	d, specify	color an	d length	
		No option red								
	Wire Co	lor Available t	or C Termin	ation						
	0	Black 2	Red	4	Yellow	6	Blue	8	Grey	
		Brown 3	Orange	5	Green	7	Violet	9	White	
		ngth Available								
	Sp	ecify Length i	n inches: 03	- /2	2 [/6-1829]					

US Patent No. 4,885,533 & 4,597,622

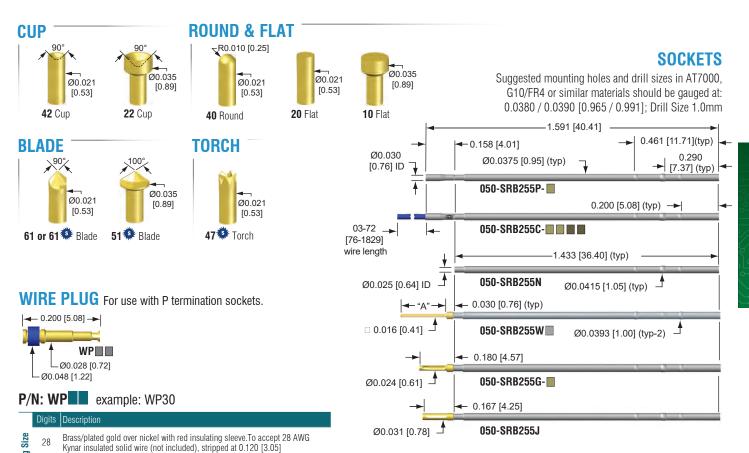
# 050-R25 Series 0.050 [1.27] Centers | 0.250 [6.35] Full Stroke



Working Temperature applications notes for more details.

<sup>&</sup>lt;sup>2</sup> Maximum plunger OD should be used to calculate minimum guide plate clearance holes.

<sup>&</sup>lt;sup>3</sup> Working Temperature Range: -55°C to 120°C ith lubrication. SS springs can be used up to 204°C without lubrication.



## WIRE GRIP SLEEVE For use with G termination sockets.

Kynar insulated solid wire (not included), stripped at 0.120 [3.05]

Brass/plated gold over nickel with blue insulating sleeve. To accept 30 AWG



#### P/N: WG50

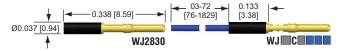
#### Description

Plug

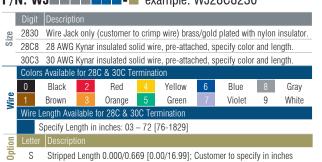
30

To accept customer supplied 28AWG or 30AWG Kynar solid insulated wire, stripped at 0.120 [3.05]. Nylon sleeve, white

## WIRE JACK For use with J termination pins.



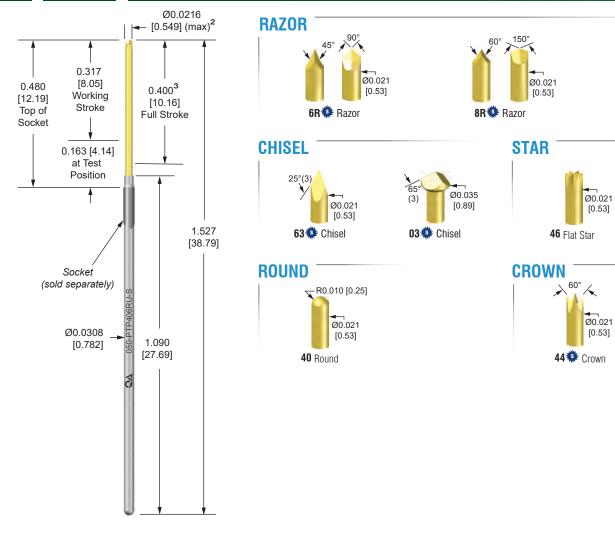
#### **P/N: WJ** example: WJ28C8230



#### SOCKET P/N



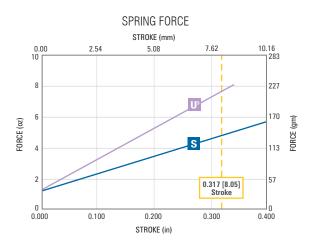
US Patent No. 4,885,533 & 4,597,622



<b>PROBE P/N 050-PTP40</b> example: 050-P
---

Tube	Letter	Material/Finis	h		Average Resistance	Current Rating AMPS <sup>1</sup> 120°C (204°C) <sup>4</sup>							
_	Р	Nickel silver/l	D precious metal cl	lad	< 35 m0hms	4.3 (5.9)4							
yle	Digits	Material/Finis	h										
Tip Style	See Tips	Standard material is heat treated BeCu/plated gold over nickel (see S option for steel plungers)											
St		Spring Force		@ 0.317 [8.05] Stroke		Cycle Life @ 0.317 [8.05] Stroke							
Springs	S	Standard	1.2 [34g/0.33N]	4.8 [136g/1.33N]	SS	100,000							
S	$U^3$	Ultra	1.3 [37g/0.36N]	7.5 [213g/2.09N]	SS	10,000							
		Description											
Option	N	No probe lubrication. Removing lubrication greatly reduces cycle life and should only be used in applications outside of the working temperature range, see Testing in Extreme Working Temperatures application note for more details.4											
0	S	Heat treat	ed steel/plated gold	d over nickel (see tip styl	e for availability	/)							
	(Blank)	No option req	uired	No option required									

<sup>&</sup>lt;sup>1</sup> Current rating is affected by spring material and lubrication choice. Please refer to Current Carrying Capacity and Testing in Extreme Working Temperature applications notes for more details.



9R Razor

Ø0 021

[0.53]

Ø0.021

[0.53]

76 Center Point Star

G4 Crown

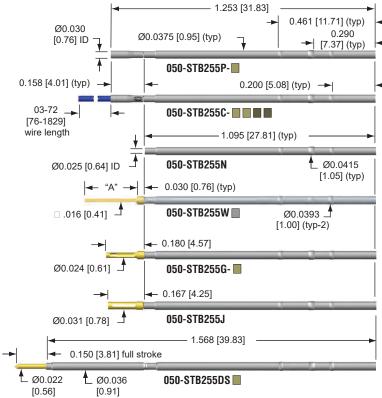
#### **TOOLS & ACCESSORIES**

<sup>&</sup>lt;sup>2</sup> Maximum plunger OD should be used to calculate minimum guide plate clearance holes.

<sup>3 0.350 [8.89]</sup> max stroke for U spring.

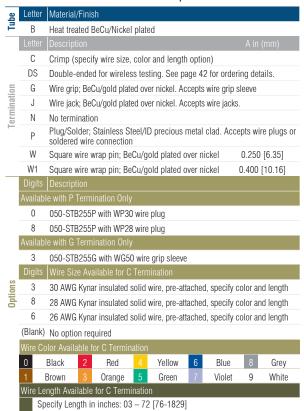
<sup>&</sup>lt;sup>4</sup> Working Temperature Range: -55°C to 120°C with lubrication. SS springs can be used up to 204°C without lubrication.

Suggested mounting holes and drill sizes in AT7000, G10/FR4 or similar materials should be gauged at: 0.0380 / 0.0390 [0.965 / 0.991]; Drill Size 1.0mm



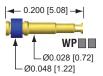
## **SOCKET P/N**

## **050-STB255** example: 050-STB255C3630



US Patent No. 4,885,533 & 4,597,622

## WIRE PLUG For use with P termination sockets.



## P/N: WP example: WP30

	Digits	Description
Plug Size	28	Brass/plated gold over nickel with red insulating sleeve.To accept 28 AWG Kynar insulated solid wire (not included), stripped at 0.120 [3.05]
	30	Brass/plated gold over nickel with blue insulating sleeve. To accept 30 AWG Kynar insulated solid wire (not included), stripped at 0.120 [3.05]

## WIRE GRIP SLEEVE For use with G termination sockets.

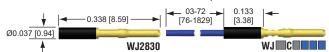


#### P/N: WG50

#### Description

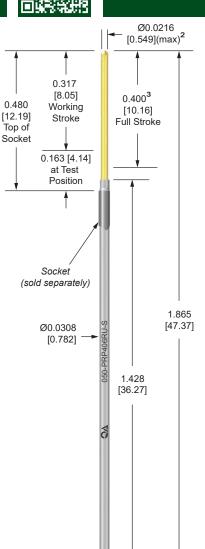
To accept customer supplied 28AWG or 30AWG Kynar solid insulated wire, stripped at 0.120 [3.05]. Nylon sleeve, white

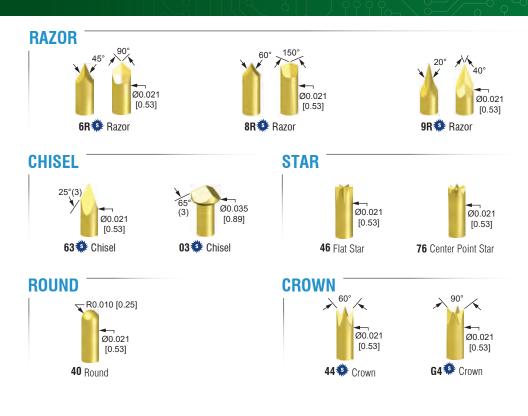
## WIRE JACK For use with J termination pins.



## **P/N: WJ** example: WJ28C8230







## PROBE P/N 050-PRP40 example: 050-PRP406RS-S

_				<u> </u>					
Tube	Letter	Material/Finis	h		Average Resistance	Current Rating AMPS <sup>1</sup> 120°C (204°C) <sup>4</sup>			
_	Р	Nickel silver/l	D precious metal c	lad	< 35 m0hms	3.7 (5.0)4			
Style	Digits	Material/Finis							
Tip St	See Tips	Standard mate	erial is heat treated	tion for steel plungers)					
	Letter	Spring Force	Preload	@ 0.317 [8.05] Stroke	Material	Cycle Life @ 0.317 [8.05] Stroke			
Springs	S	Standard	1.5 [43g/0.42N]	6.0 [170g/1.67N]	SS	250,000			
Spri	$H^3$	High	1.7 [48g/0.47N]	7.0 [198g/1.95N]	SS	300,000			
	U <sup>3</sup>	Ultra	2.3 [65g/0.64N]	9.0 [255g/2.50N]	SS	100,000			
		Description							
Option .	N	No probe lubrication. Removing lubrication greatly reduces cycle life and should only be used in applications outside of the working temperature range, see Testing in Extreme Working Temperatures application note for more details. <sup>4</sup>							
0	S	Heat treat	ed steel/plated gol	d over nickel (see tip styl	e for availability	/)			
	(Blank)	No option req	uired						

<sup>&</sup>lt;sup>1</sup> Current rating is affected by spring material and lubrication choice. Please refer to Current Carrying Capacity and Testing in Extreme Working Temperature applications notes for more details.

#### SPRING FORCE STROKE (mm) 0.00 7.62 10.16 2.54 5.08 10 283 227 FORCE (oz) FORCE (gm) 170 113 57 0.317 [8.05] Stroke 0.100 0.200 0.300 0.400 0.000 STROKE (in)

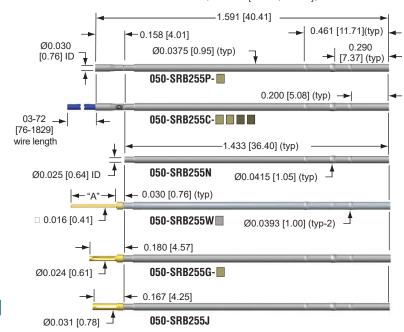
#### **TOOLS & ACCESSORIES**

<sup>&</sup>lt;sup>2</sup> Maximum plunger OD should be used to calculate minimum guide plate clearance holes.

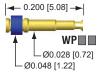
<sup>3 0.350 [8.89]</sup> max stroke for H & U spring

<sup>&</sup>lt;sup>4</sup> Working Temperature Range: -55°C to 120°C with lubrication. SS springs can be used up to 204°C without lubrication.

Suggested mounting holes and drill sizes in AT7000, G10/FR4 or similar materials should be gauged at: 0.0380 / 0.0390 [0.965 / 0.991]; Drill Size 1.0mm



## WIRE PLUG For use with P termination sockets.



## P/N: WP example: WP30

Plug Size	Digits	Description
	28	Brass/plated gold over nickel with red insulating sleeve.To accept 28 AWG Kynar insulated solid wire (not included), stripped at 0.120 [3.05]
	30	Brass/plated gold over nickel with blue insulating sleeve. To accept 30 AWG Kynar insulated solid wire (not included), stripped at 0.120 [3.05]

## WIRE GRIP SLEEVE For use with G termination sockets.

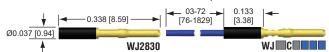


#### P/N: WG50

#### Description

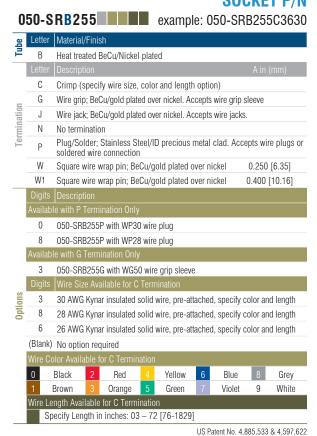
To accept customer supplied 28AWG or 30AWG Kynar solid insulated wire, stripped at 0.120 [3.05]. Nylon sleeve, white

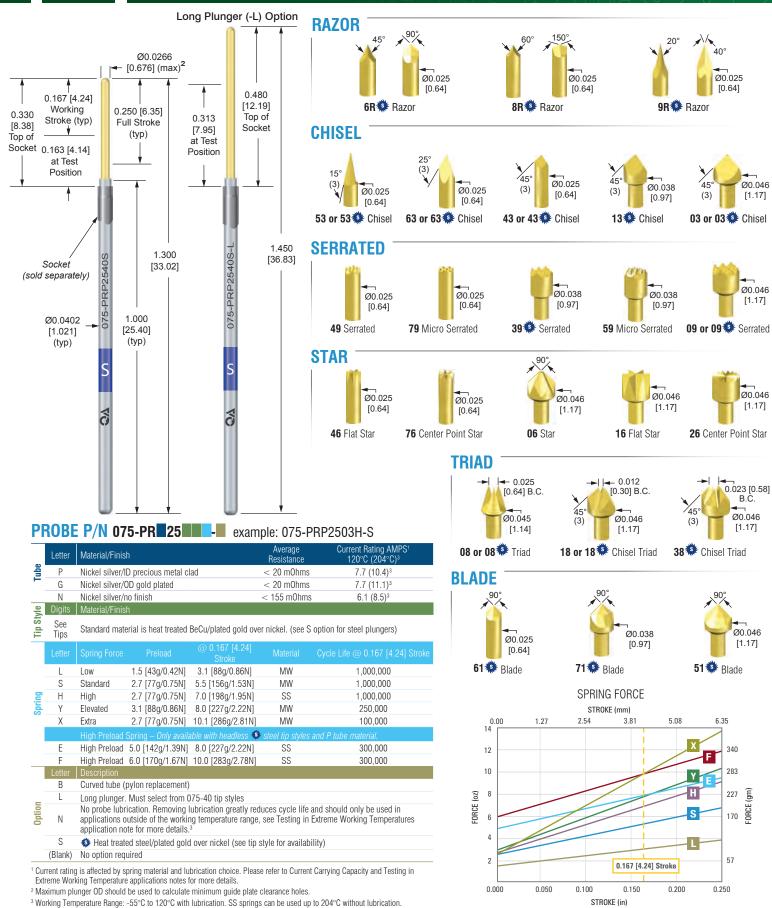
## WIRE JACK For use with J termination pins.



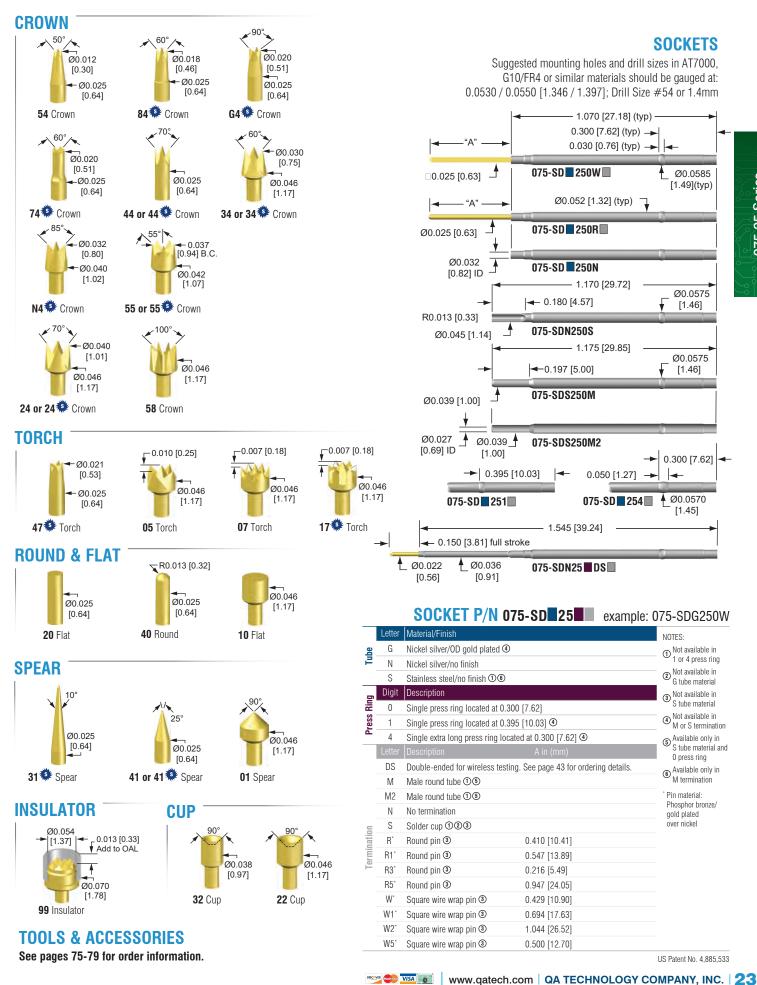


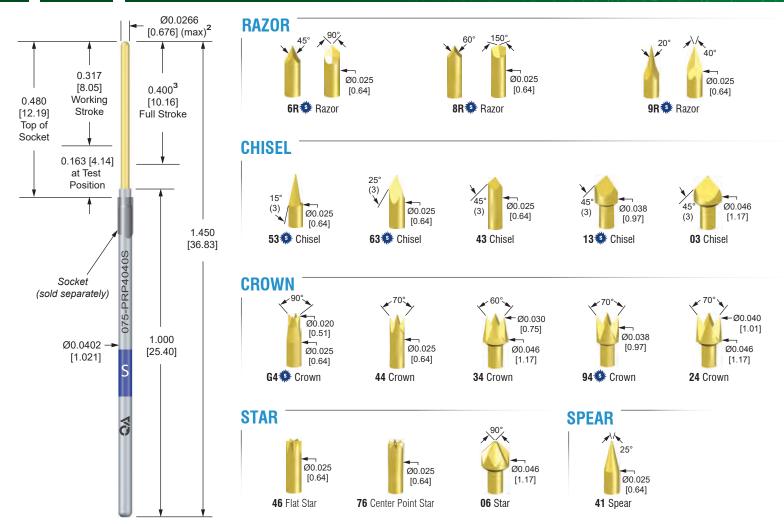
## SOCKET P/N





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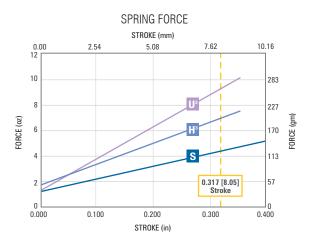




## PROBE P/N 075-PR 40 example: 075-PRP4003S

	Letter	Material/Finis	h		Average Resistance	Current Rating AMPS <sup>1</sup> 120°C (204°C) <sup>4</sup>	
Tube	Р	Nickel silver/l	D precious metal cl	ad	< 20 m0hms	7.3 (10.0)4	
=	G	Nickel silver/OD gold plated			< 25 m0hms	7.2 (9.0)4	
	N	Nickel silver/r	no finish		< 210 m0hms	6.1 (9.1)4	
yle	Digits	Material/Finis	h				
Tip Style	See Tips	Standard mate	erial is heat treated	BeCu/plated gold over nic	kel. (see S optio	on for steel plungers)	
				@ 0.317 [8.05] Stroke		Cycle Life @ 0.317 [8.05] Stroke	
Spring	S	Standard	1.2 [34g/0.33N]	4.3 [122g/1.20N]	SS	500,000	
쿬	$H^3$	High	1.7 [48g/0.47N]	7.0 [198g/1.95N]	SS	300,000	
	$U^3$	Ultra	1.3 [37g/0.36N]	9.3 [264g/2.59N]	MW	10,000	
		Description					
	В	Curved tube (pylon replacement)					
Option	N	No probe lubrication. Removing lubrication greatly reduces cycle life and should only be used in applications outside of the working temperature range, see Testing in Extreme Working Temperatures application note for more details. <sup>4</sup>					
	S	Heat treat	ed steel/plated gold	l over nickel (see tip style	for availability)		
	(Blank)	No option req	uired				

<sup>&</sup>lt;sup>1</sup> Current rating is affected by spring material and lubrication choice. Please refer to Current Carrying Capacity and Testing in Extreme Working Temperature applications notes for more details.

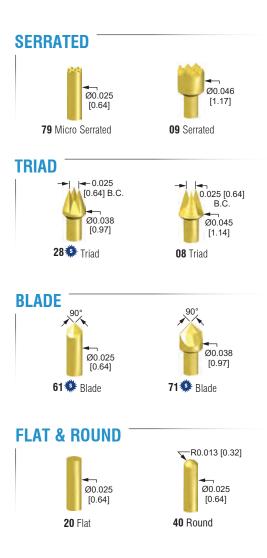


#### **TOOLS & ACCESSORIES**

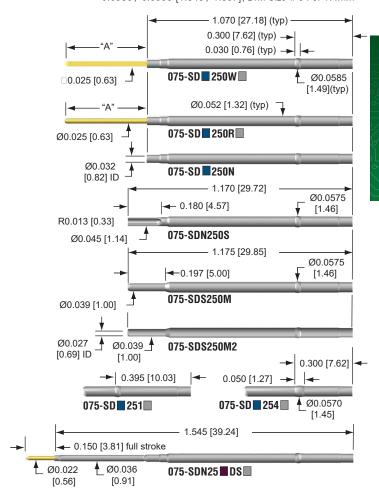
<sup>&</sup>lt;sup>2</sup> Maximum plunger OD should be used to calculate minimum guide plate clearance holes.

<sup>3 0.350 [8.89]</sup> max stroke for H & U spring.

<sup>4</sup> Working Temperature Range: -55°C to 120°C with lubrication. SS springs can be used up to 204°C without lubrication.



Suggested mounting holes and drill sizes in AT7000, G10/FR4 or similar materials should be gauged at: 0.0530 / 0.0550 [1.346 / 1.397]; Drill Size #54 or 1.4mm

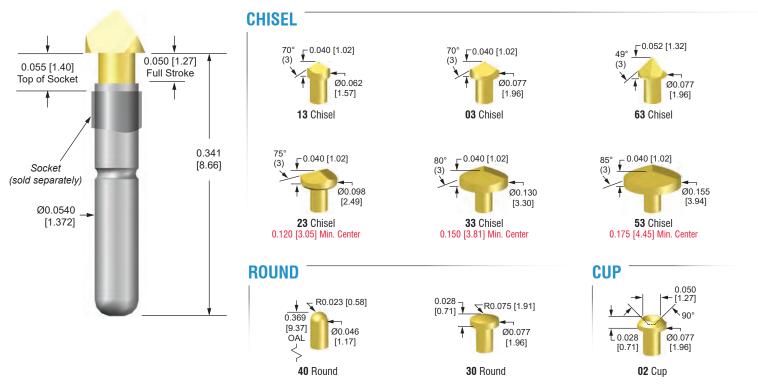


## **SOCKET P/N 075-SD 25** example: 075-SDG250W



US Patent No. 4,885,533

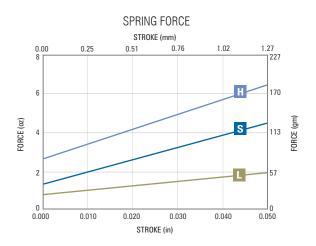




## **PROBE P/N 100-PL 05** example: 100-PLP0503L

Tube	Letter	Material/Finist	ı		Average Resistance	Current Rating AMPS <sup>1</sup> 120°C (204°C) <sup>3</sup>
	$P^2$	Nickel silver/II	O precious metal cl	lad	< 45 m0hms	13.2 (18.1) <sup>3</sup>
	N	Nickel silver/no finish $< 65 \text{ mOhms}$ 12.0 (18.5) <sup>3</sup>				
Tip Style	Digits	Material/Finish	1			
	See Tips	Heat treated BeCu/plated gold over nickel.				
		Spring Force	Preload	@ 0.050 [1.27] Stroke	Material	Cycle Life @ 0.050 [1.27] Stroke
Spring	L	Low	0.7 [20g/0.19N]	2.0 [57g/0.56N]	SS	1,000,000
Spr	S	Standard	1.3 [37g/0.36N]	4.5 [128g/1.25N]	MW	1,000,000
	Н	High	2.7 [77g/0.75N]	6.5 [184g/1.81N]	SS	1,000,000

<sup>1</sup> Current rating is affected by spring material and lubrication choice. Please refer to Current Carrying Capacity and Testing in Extreme Working Temperature applications notes for more details.



#### **TOOLS & ACCESSORIES**

<sup>&</sup>lt;sup>2</sup> P tube has Ø0.016 [0.41] hole in end for identification only.

<sup>&</sup>lt;sup>3</sup> Working Temperature Range: up to 120°C. SS springs can be used up to 204°C.

#### DISTANCE FROM TOP OF SOCKET TO TIP OVERALL PROBE LENGTH **HEAD LENGTH TIP STYLE** 0.369 [9.37] 02 0.028 [0.71] 0.083 [2.11] 03 0.040 [1.02] 0.095 [2.41] 0.381 [9.68] 13 0.040 [1.02] 0.095 [2.41] 0.381 [9.68] 23 0.040 [1.02] 0.095 [2.41] 0.381 [9.68] 30 0.028 [0.71] 0.083 [2.11] 0.369 [9.37] 33 0.040 [1.02] 0.095 [2.41] 0.381 [9.68]

0.083 [2.11]

0.095 [2.41]

0.107 [2.72]

0.369 [9.37]

0.381 [9.68]

0.393 [9.98]

40

53

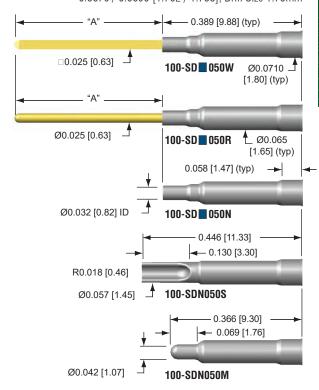
63

0.040 [1.02]

0.052 [1.32]

#### **SOCKETS**

Suggested mounting holes and drill sizes in AT7000, G10/FR4 or similar materials should be gauged at: 0.0670 / 0.0690 [1.702 / 1.753]; Drill Size 1.75mm



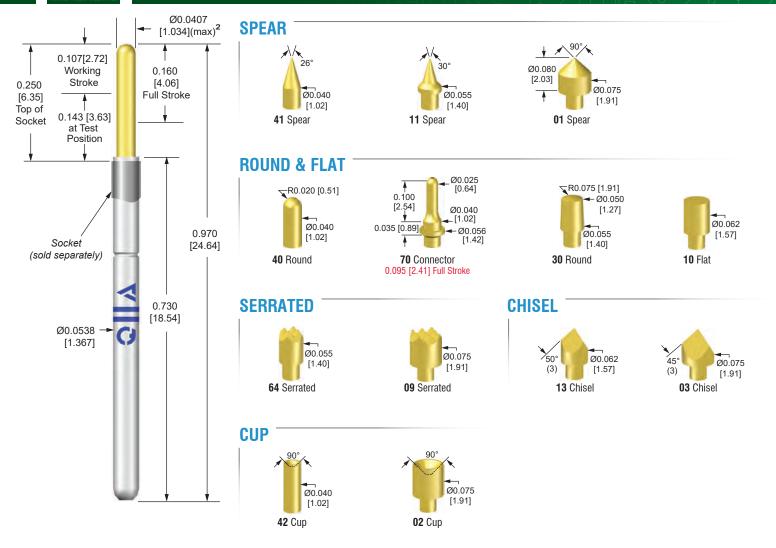
## **SOCKET P/N**

**100-SD 050** example: 100-SDN050S

	Letter	Material/Finish	
릞	G	Nickel silver/OD gold plated	
_	N	Nickel silver/no finish	
		Description	
	M	Male round tube ①	
	N	No termination	
	S	Solder cup ①	
	R*	Round pin	0.410 [10.41]
tion	R1*	Round pin	0.547 [13.89]
<b>Termination</b>	R3*	Round pin	0.216 [5.49]
Terr	R5*	Round pin	0.947 [24.05]
	$W^{\star}$	Square wire wrap pin	0.429 [10.90]
	W1*	Square wire wrap pin ①	0.694 [17.63]
	W2*	Square wire wrap pin ①	1.044 [26.52]
	W3*	Square wire wrap	0.164 [4.16]
	W5*	Square wire wrap pin ①	0.500 [12.70]

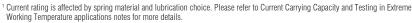
NOTES: 1 Not available in G Tube Material \* Pin material: Phosphor bronze/gold plated over nickel

# **100-16 Series** 0.100 [2.54] Centers | 0.160 [4.06] Full Stroke



## PROBE P/N 100-PL 16 example: 100-PLP1603L-B

Tube	Letter	Material/Finish	1		Average Resistance	Current Rating AMPS <sup>1</sup> 120°C (204°C) <sup>3</sup>	
	Р	Nickel silver/II	) precious metal cla	d	< 20 m0hms	14.0 (21.0) <sup>3</sup>	
-	G	Nickel silver/C	D gold plated		< 25 m0hms	12.0 (16.5) <sup>3</sup>	
	N	Nickel silver/n	o finish		< 45 m0hms	10.0 (15.5) <sup>3</sup>	
yle	Digits	Material/Finish	1				
Tip Style	See Tips	Heat treated BeCu/gold plated over nickel.					
		Spring Force				Cycle Life @ 0.107 [2.72] Stroke	
	L	Low	0.7 [20g/0.19N]	1.5 [43g/0.42N]	SS	1,000,000	
Spring	S	Standard	1.7 [48g/0.47N]	3.5 [99g/0.97N]	SS	1,000,000	
S	Н	High	2.2 [62g/0.61N]	5.5 [156g/1.53N]	MW	1,000,000	
	Χ	Extra	3.0 [85g/0.83N]	8.0 [227g/2.22N]	MW	1,000,000	
	U	Ultra	4.5 [128g/1.25N]	10.0 [283g/2.78N]	MW	250,000	
		Description					
_	В	Curved tube (pylon replacement)					
Option	N	No probe lubrication. Removing lubrication greatly reduces cycle life and should only be used in applications outside of the working temperature range, see Testing in Extreme Working Temperatures application note for more details. <sup>3</sup>					
	(Blank)	No option requ	iired				



<sup>&</sup>lt;sup>2</sup> Maximum plunger OD should be used to calculate minimum guide plate clearance holes.

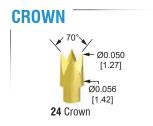
#### SPRING FORCE STROKE (mm) 0.00 2 03 3.05 4.06 0.107 [2.72] Stroke 12 340 10 283 227 FORCE (oz) 170 8 113 57 0.080 0.000 0.040 0.120 0.160 STROKE (in)

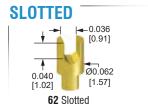
#### **TOOLS & ACCESSORIES**

<sup>&</sup>lt;sup>3</sup> Working Temperature Range: -55°C to 120°C with lubrication. SS springs can be used up to 204°C without lubrication.



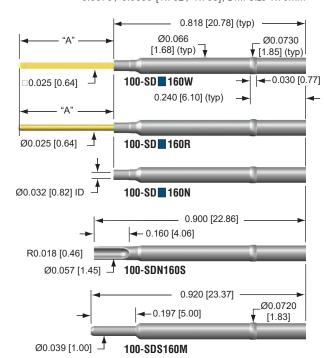








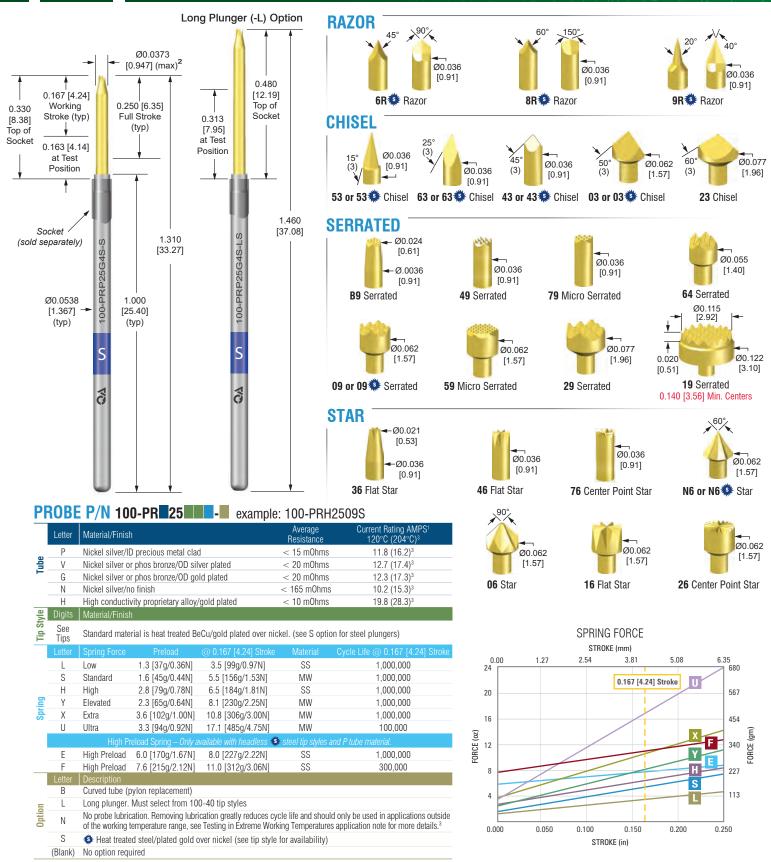
Suggested mounting holes and drill sizes in AT7000, G10/FR4 or similar materials should be gauged at: 0.0670 / 0.0690 [1.702 / 1.753]; Drill Size 1.75mm



## **SOCKET P/N 100-SD 160** example: 100-SDG160R

	Letter	Material/Finish	NOTES:				
Tube	G	Nickel silver/OD gold plated ③	Not available in     G tube material     Not available in     S tube material				
F	N	Nickel silver/no finish					
	S	Stainless steel/no finish ③					
	Letter	Description	A in (mm)	(3) Available only in			
	M	Male round tube 4		M termination			
	N	No termination ②		Available only in S tube material			
	S	Solder cup ①②		(5) Not available in			
n n	R*	Round pin ②	0.410 [10.41]	M or S termination			
natic	R1*	Round pin ②	0.547 [13.89]	* Pin material: Phosphor bronze/			
Termination	R3*	Round pin ②	0.216 [5.49]	gold plated over nickel			
Ĕ	R5*	Round pin ②	0.947 [24.05]	Over Hicker			
	$W^{\star}$	Square wire wrap pin ②	0.429 [10.90]				
	W1*	Square wire wrap pin ①②	0.694 [17.63]				
	W2*	Square wire wrap pin ①②	1.044 [26.52]				
	W5*	Square wire wrap pin ①②	0.500 [12.70]				

# 100-25 Series 0.100 [2.54] Centers 0.250 [6.35] Full Stroke

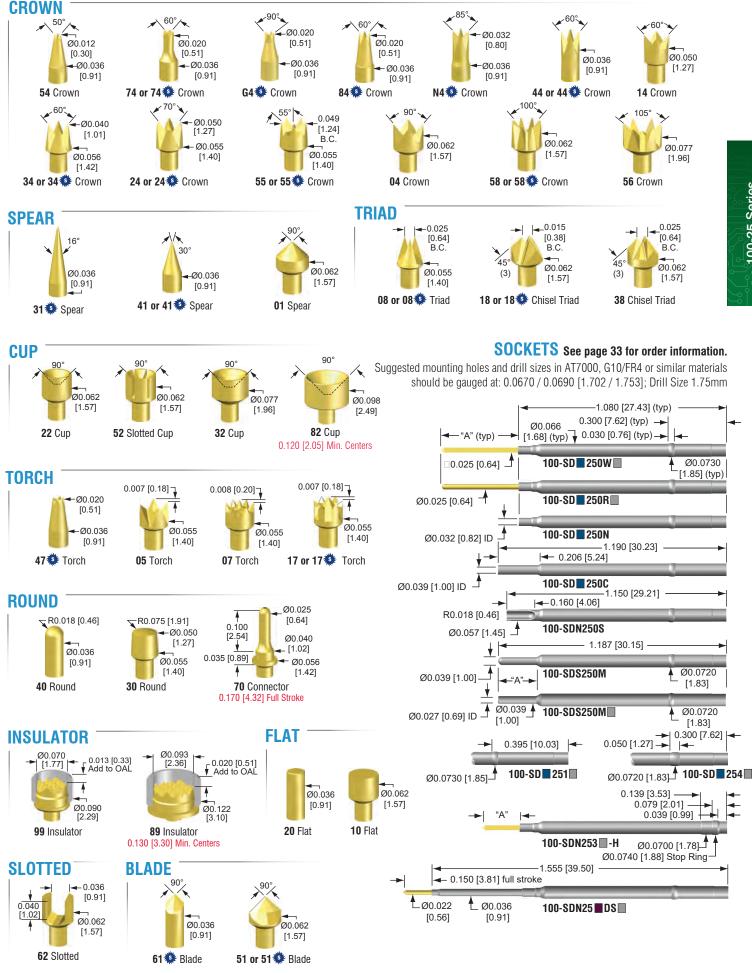


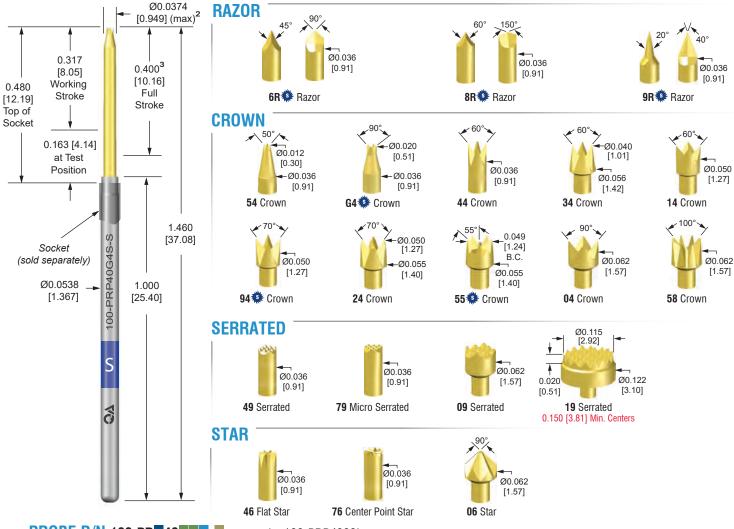
<sup>&</sup>lt;sup>1</sup> Current rating is affected by spring material and lubrication choice. Please refer to Current Carrying Capacity and Testing in Extreme Working Temperature applications notes for more details.

#### **TOOLS & ACCESSORIES**

<sup>&</sup>lt;sup>2</sup> Maximum plunger OD should be used to calculate minimum guide plate clearance holes.

<sup>&</sup>lt;sup>3</sup> Working Temperature Range: -55°C to 120°C with lubrication. SS springs can be used up to 204°C without lubrication.





## **PROBE P/N 100-PR 40 example:** 100-PRP4003L

Tube	Letter	Material/Finish			Average Resistance	Current Rating AMPS <sup>1</sup> 120°C (204°C) <sup>4</sup>			
	Р	Nickel silver/l	D precious metal o	clad	< 20 m0hms	10.2 (14.3)4			
	V	Nickel silver o	or phos bronze/OD	silver plated	< 20 m0hms	12.7 (17.5)4			
	G	Nickel silver o	or phos bronze/OD	gold plated	< 20 m0hms	12.2 (17.5)4			
	N	Nickel silver/r	no finish		< 375 m0hms	8.8 (13.2)4			
	Н	High conduct	ivity proprietary all	oy/gold plated	< 15 m0hms	15.9 (22.0)4			
yle	Digits	Material/Finis	h						
Tip Style	See Tips	Heat treated E	BeCu/gold plated o	ver nickel. (see S option t	or steel plungers	)			
		Spring Force		@ 0.317 [8.05] Stroke		Cycle Life @ 0.317 [8.05] Stroke			
6	L	Low	0.8 [23g/0.22N]	3.0 [85g/0.83N]	MW	1,000,000			
Spring	S	Standard	1.5 [43g/0.42N]	5.7 [162g/1.58N]	SS	500,000			
S	$H^3$	High	2.0 [57g/0.56N]	7.0 [198g/1.95N]	SS	300,000			
	$U^3$	Ultra	2.5 [71g/0.70N]	8.1 [230g/2.25N]	MW	10,000			
	Letter	Description							
	В	Curved tube (pylon replacement)							
Option	N	No probe lubrication. Removing lubrication greatly reduces cycle life and should only be used in applications outside of the working temperature range, see Testing in Extreme Working Temperatures application note for more details. <sup>4</sup>							
	S	Heat treat	ed steel/plated gol	d over nickel (see tip styl	e for availability)				
	(Blank)	No option req	uired						
		and the standard of the standard and behavior the place of the Occasion Occasion Occasion and Testing in Education							

STROKE (mm) 0.00 2.54 5.08 7.62 10.16 227 170 FORCE (oz) 113 57 0.317 [8.05] Stroke 0.000 0.100 0.200 0.300 0.400 STROKE (in)

SPRING FORCE

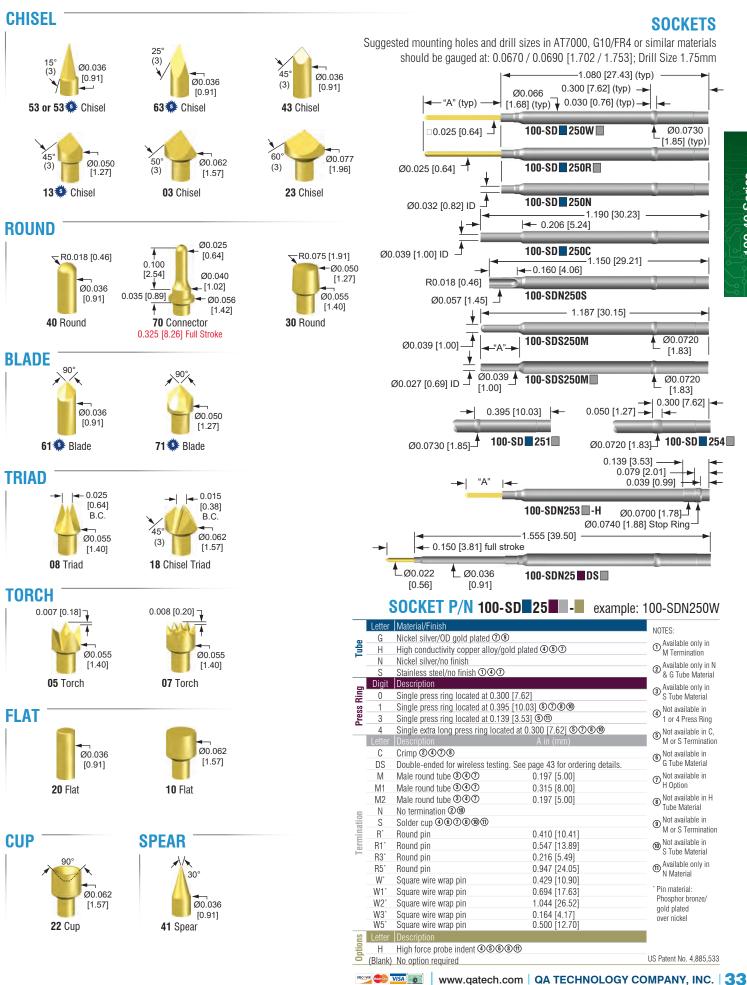
#### **TOOLS & ACCESSORIES**

<sup>&</sup>lt;sup>1</sup> Current rating is affected by spring material and lubrication choice. Please refer to Current Carrying Capacity and Testing in Extreme Working Temperature applications notes for more details.

<sup>&</sup>lt;sup>2</sup> Maximum plunger OD should be used to calculate minimum guide plate clearance holes.

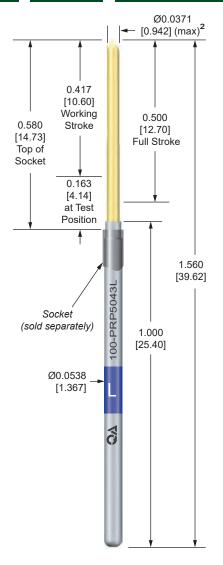
<sup>3 0.350 [8.89]</sup> max stroke for H & U spring.

<sup>&</sup>lt;sup>4</sup> Working Temperature Range: -55°C to 120°C with lubrication. SS springs can be used up to 204°C without lubrication.











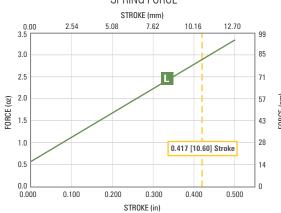
79 Micro Serrated

## PROBE P/N 100-PRP50 L example: 100-PRP5079L

				'		
Tube	Letter	Material/Finis	sh		Average Resistance	Current Rating AMPS <sup>1</sup> 120°C (204°C) <sup>3</sup>
_	Р	Nickel silver/l	ID precious metal cla	ad	< 30 m0hms	10.0 (13.7) <sup>3</sup>
Tip Style	Digits	Material/Finis				
	See Tips	Heat treated E	BeCu/plated over nic	kel		
Spring	Letter	Spring Force	Preload	@ 0.417 [10.60] Stroke	Material	Cycle Life @ 0.417 [10.60] Stroke
Š	L	Low	0.56 [16g/0.16N]	2.9 [82g/0.81N]	SS	80,000

<sup>&</sup>lt;sup>1</sup> Current rating is affected by spring material and lubrication choice. Please refer to Current Carrying Capacity and Testing in Extreme Working Temperature applications notes for more details

## SPRING FORCE



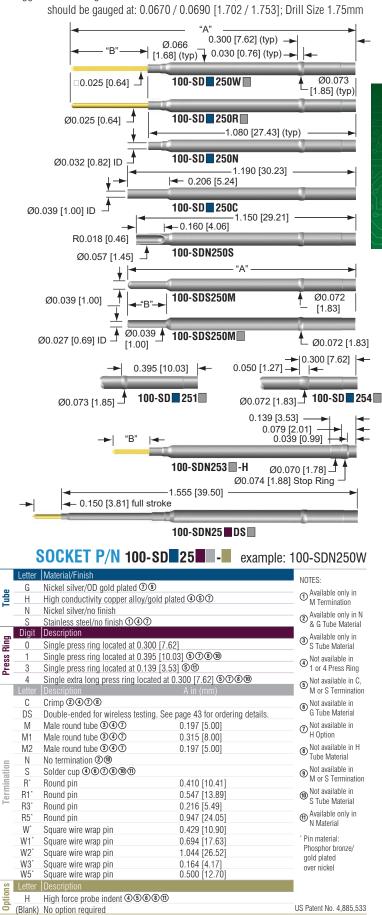
#### **TOOLS & ACCESSORIES**

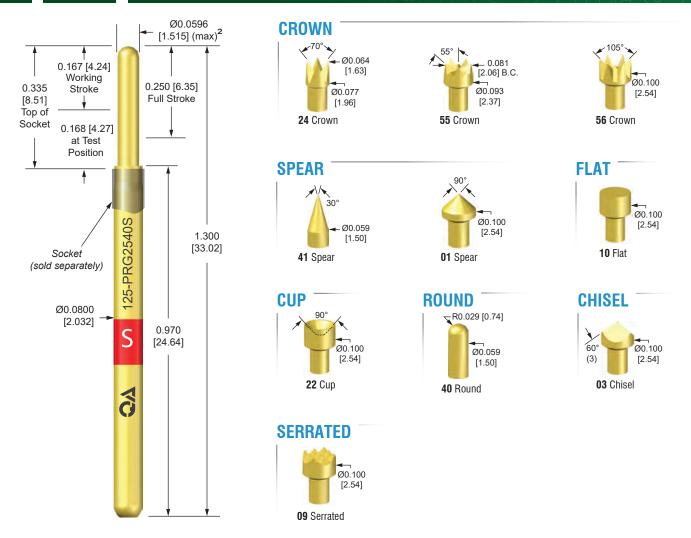
<sup>&</sup>lt;sup>2</sup> Maximum plunger OD should be used to calculate minimum guide plate clearance holes.

<sup>&</sup>lt;sup>3</sup> Working Temperature Range: -55°C to 120°C with lubrication. SS springs can be used up to 204°C without lubrication.

#### **SOCKETS**

Suggested mounting holes and drill sizes in AT7000, G10/FR4 or similar materials should be gauged at: 0.0670 / 0.0690 [1,702 / 1,753]; Drill Size 1,75mm

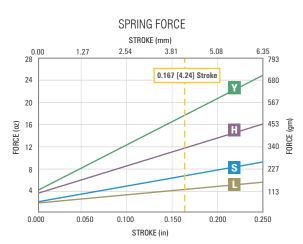




# **PROBE P/N 125-PRE25** example: 125-PRH2509S

	Letter	Material/Finish	ı		Average Resistance	Current Rating AMPS <sup>1</sup> 120°C (204°C) <sup>3</sup>		
e	G	Nickel silver O	D gold plated		< 15 m0hms	16.9 (23.0) <sup>3</sup>		
Tube	Н	High conductiv	vity proprietary alloy/	gold plated	< 10 m0hms	30.0 (41.0)3		
	N	Nickel silver/n	o finish		< 25 m0hms	13.7 (18.8) <sup>3</sup>		
	S	High conductiv	vity proprietary alloy/	silver plated	< 10 m0hms	32.8 (48.0) <sup>3</sup>		
yle	Digits	Material/Finish	1					
Tip Style	See Tips	Heat treated BeCu/gold plated over nickel						
		Spring Force				Cycle Life @ 0.167 [4.24] Stroke		
6	L	Low	1.9 [54g/0.53N]	4.5 [128g/1.25N]	SS	1,000,000		
Spring	S	Standard	2.2 [62g/0.61N]	7.0 [198g/1.95N]	SS	1,000,000		
S	Н	High	3.7 [105g/1.03N]	12.0 [340g/3.34N]	SS	1,000,000		
	Υ	Elevated	4.4 [125g/1.21N]	18.0 [510g/5.00N]	SS	100,000		
		Description						
_	В	Curved tube (pylon replacement)						
Option	N	No probe lubrication. Removing lubrication greatly reduces cycle life and should only be used in applications outside of the working temperature range, see Testing in Extreme Working Temperatures application note for more details. <sup>3</sup>						
	(Blank)	No option requ	uired					

<sup>&</sup>lt;sup>1</sup> Current rating is affected by spring material and lubrication choice. Please refer to Current Carrying Capacity and Testing in Extreme Working Temperature applications notes for more details.



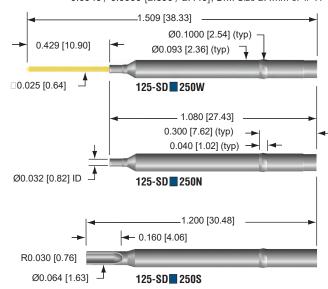
#### **TOOLS & ACCESSORIES**

<sup>&</sup>lt;sup>2</sup> Maximum plunger OD should be used to calculate minimum guide plate clearance holes.

<sup>&</sup>lt;sup>3</sup> Working Temperature Range: -45°C to 120°C with lubrication. SS springs can be used up to 204°C without lubrication.

#### **SOCKETS**

Suggested mounting holes and drill sizes in AT7000, G10/FR4 or similar materials should be gauged at:  $0.0940\,/\,0.0960$  [2.390 / 2.440]; Drill Size 2.4mm or #41



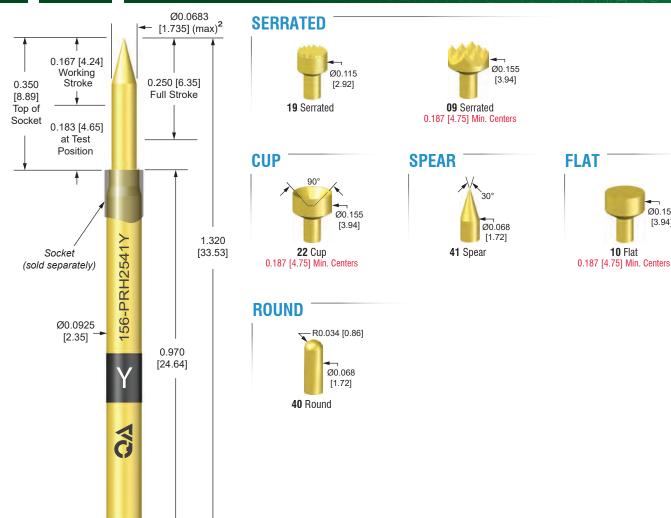
## **SOCKET P/N**

**125-SD 250** example: 125-SDN250W

	Letter	Material/Finish		
Tube	N	Nickel silver/no finish		
Z	G	Nickel silver/OD gold plated ②		
	Н	High conductivity copper alloy/gold plated ③		
no.		Description		
Termination	N	No termination		
Ē	S	Solder cup <b>⊙</b>		
n H	W	Square wire wrap pin, Phospor bronze/gold plated over nickel		
NOTES: ① Not available in G tube material US Patent No. 4,885,533				

NOTES: 1 Not available in G tube material

Not available in S termination
 Only available in S termination



# **PROBE P/N 156-PR 25** example: 156-PRH2509S

_	Letter	Material/Finisl	1		Average Resistance	Current Rating AMPS <sup>1</sup> 120°C (204°C) <sup>3</sup>		
Tube	N	Nickel silver/n	o finish		< 15 m0hms	16 (22) <sup>3</sup>		
Н	Н	High conducti	vity proprietary alloy/	gold plated	< 10 m0hms	31 (43) <sup>3</sup>		
	S	High conducti	vity proprietary alloy/	silver plated	< 10 m0hms	34 (47)3		
yle	Digits	Material/Finish						
Tip Style	See Tips	Heat treated B	eCu/gold plated over	nickel				
		Spring Force	Preload		Material	Cycle Life @ 0.167 [4.24] Stroke		
Spring	S	Standard	2.2 [62g/0.61N]	6.0 [170g/1.67N]	SS	1,000,000		
Spi	Н	High	3.6 [102g/1.00N]	10.0 [283g/2.78N]	SS	1,000,000		
	Υ	Elevated	5.4 [153g/1.50N]	16.0 [454g/4.45N]	SS	1,000,000		
		Description						
Option	N	No probe lubrication. Removing lubrication greatly reduces cycle life and should only be used in applications outside of the working temperature range, see Testing in Extreme Working Temperatures application note for more details. <sup>3</sup>						
	(Blank)	No option requ	uired					

<sup>1</sup> Current rating is affected by spring material and lubrication choice. Please refer to Current Carrying Capacity and Testing in Extreme Working Temperature applications notes for more details.

#### SPRING FORCE STROKE (mm) 6.35 793 5.08 0.00 1.27 28 0.167 [4.24] Stroke 680 24 20 567 453 (zo) 16 FORCE ( 340 PBCE ( 12 227 113 0.250 STROKE (in)

Ø0.155

[3.94]

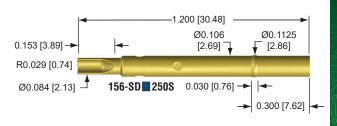
#### **TOOLS & ACCESSORIES**

<sup>&</sup>lt;sup>2</sup> Maximum plunger OD should be used to calculate minimum guide plate clearance holes.

<sup>&</sup>lt;sup>3</sup> Working Temperature Range: -45°C to 120°C with lubrication. SS springs can be used up to 204°C without lubrication.

## **SOCKETS**

Suggested mounting holes and drill sizes in AT7000, G10/FR4 or similar materials should be gauged at: 0.108 / 0.110 [2.74 / 2.79]; Drill Size 7/64" or 2.80mm

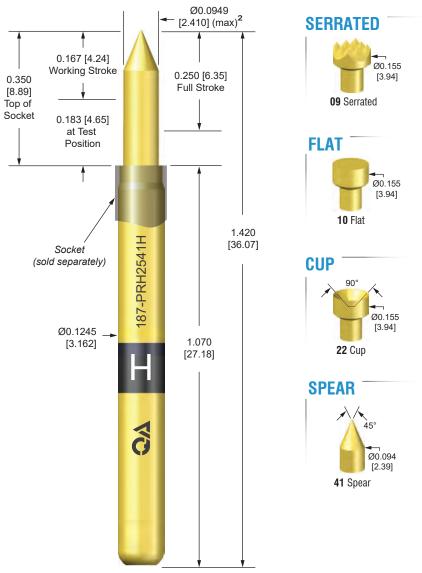


## **SOCKET P/N 156-SD 250S** example: 156-SDH250S

	Letter	Material/Finish
Lube	N	Nickel silver/no finish
	Н	High conductivity copper alloy/gold plated
Ë		
Term	S	Solder cup

US Patent No. 4,885,533





# PROBE P/N 187-PR 25 HH- example: 187-PRH2509H

	Letter	Material/Finis	h		Average Resistance	Current Rating AMPS <sup>1</sup> 120°C (204°C) <sup>3</sup>		
Tube	N	Nickel silver/no finish			< 20 m0hms	24 (32)3		
-	Н	High conducti	vity proprietary alloy,	/gold plated	< 10 m0hms	39 (55) <sup>3</sup>		
	S	High conducti	vity proprietary alloy,	/silver plated	< 5 mOhms	48 (59) <sup>3</sup>		
yle	Digits	Material/Finis	h					
Tip Style	See Tips	Heat treated BeCu/gold plated over nickel						
Spring		Spring Force				Cycle Life @ 0.167 [4.24] Stroke		
중	Н	High	7.0 [198g/1.95N]	18.0 [510g/5.00N]	SS	1,000,000		
		Description						
Option	N	No probe lubrication. Removing lubrication greatly reduces cycle life and should only be used in applications outside of the working temperature range, see Testing in Extreme Working Temperatures application note for more details. <sup>3</sup>						
	(Blank)	No option req	uired					

<sup>&</sup>lt;sup>1</sup> Current rating is affected by spring material and lubrication choice. Please refer to Current Carrying Capacity and Testing in Extreme Working Temperature applications notes for more details.

#### SPRING FORCE STROKE (mm) 6.35 793 1.27 5.08 0.00 28 0.167 [4.24] Stroke 680 24 20 567 FORCE (oz) 12 454 340 PBCE ( 227 113 0.250 STROKE (in)

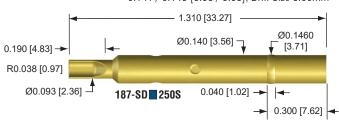
#### **TOOLS & ACCESSORIES**

<sup>&</sup>lt;sup>2</sup> Maximum plunger OD should be used to calculate minimum guide plate clearance holes.

<sup>&</sup>lt;sup>3</sup> Working Temperature Range: -45°C to 120°C with lubrication. SS springs can be used up to 204°C without lubrication.

## **SOCKETS**

Suggested mounting holes and drill sizes in AT7000, G10/FR4 or similar materials should be gauged at: 0.141 / 0.143 [3.58 / 3.63]; Drill Size 3.60mm



# **SOCKET P/N 187-SD 250S** example: 187-SDH250S

_	Letter	Material/Finish
Lube	N	Nickel silver/no finish
	Н	High conductivity copper alloy/gold plated
Ë		
Term.	S	Solder cup

US Patent No. 4,885,533



# **Wireless Sockets**

Wireless sockets are comprised of a standard socket with a special interface probe permanently attached to the tail of the socket. Wireless sockets allow construction of fixtures with far shorter signal path lengths than conventional wire wrapped designs. The shorter path length allows better control of the signal from the tester circuits to the Unit Under Test (UUT).

Note: Top test probe is not included with the wireless sockets. (See applicable product series for ordering information).

INTERFACE PROBE TIP STYLES

3 Chisel

45°(3) (typ)

#### 075-40 100-40 050-T40 039-40 Probe` Probe Probe Probe 050-16 Probe 0.474 0.480 0.480 [12.04] [12.19] 100-25 [12.19] 050-T25 039-25 075-25 (ref) 0.180 0.324 Probe 0.315 (ref) Probe Probe Probe 0.330 (ref) [4.57] [8.23] [8.00] [8.38] (ref) (ref) (ref) (ref) See 050-16 for press See 100-25 See 050-T25 See 075-25 ring config. for press for press, for press See 039-25 ring config. ring config. ring config. for press > ring config. Ø0.036 Ø0.0375 Ø0.052 Ø0.066 [0.91][0.95] [1.32] [1.68] Socket → 1.568 1.545 1.586 1.640 [39.83] [39.24] [40.29] [41.66] Ø0.030 [0.77]Ø0.0255 Ø0.036 [0.65][0.91] (typ) Interface Probe -

0.480

[12.19]

(ref)

0.330

[8.38]

(ref)

1.555

[39.50]

0.150 [3.81]

full stroke

100-SDN25\_DS

Mounting Hole Dia.

0.067/0.069

[1.702/1.753]

P/N: 039-SDC255DS3

∠ R0.011 [0.28] (typ) **0** Round

_		
Tube	Letter	Material/Finish
E.	С	Heat treated BeCu/gold plated over nickel
Style	Digits	Material/Finish
Tip St	3	Chisel. Heat treated BeCu/gold plated over nickel

# **P/N: 050-SBB16 DS** example: 050-SBB160DS3

Tube	Letter	Material/Finish
4	В	Heat treated BeCu/nickel clad ID/OD
	Digits	Press Ring
ing	0	Single press ring located at 0.310 [7.87]
Press Ring	1	Single press ring located at 0.400 [10.16]
Pre	2	Single press ring located at 0.434 [11.02]
	3	Single press ring located at 0.524 [13.31]
)e	Digits	Material/Finish
p St	0	Spherical. Heat treated BeCu/gold plated over nickel
Ē	3	Chisel. Heat treated BeCu/gold plated over nickel
Tip Style		

### **P/N: 050-STB255DS** example: 050-STB255DS3

-		•
Tube	Letter	Material/Finish
₽	В	Heat treated BeCu/nickel plated
Style	Digits	Material/Finish
	0	Spherical. Heat treated BeCu/gold plated over nickel
르	3	Chisel. Heat treated BeCu/gold plated over nickel

## INTERFACE PROBE SPECIFICATIONS

Tube Material: Nickel silver/ID precious metal clad

Working Stroke: Up to 0.100 [2.54]

050-SBB16\_DS

Mounting Hole Dia.

0.0368/0.0378

[0.935/0.960]

Working Temperature Range: Up to 204°C

**Spring Force:** 

0.125 [3.17]

full stroke

039-SDC255DS3

Mounting Hole Dia.

0.0307/0.0317

[0.780/0.805]

Ø0.0147

[0.373] (max)<sup>1</sup>

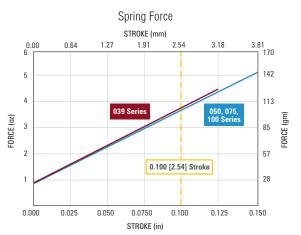
	Preload	@ 0.100 [2.54] Stroke	Material	Cycle Life @ 0.100 [2.54] Stroke
*039-25	0.8 [23g/0.21N]	3.9 [111g/1.07N]	SS	10,000
All Others	0.8 [23a/0.22N]	3.8 [108a/1.04N]	SS	100.000

050-STB255DS3

Mounting Hole Dia.

0.038/0.039

[0.965/0.991]



Ø0.0228 [0.579]

(typ) (max)1

075-SDN25\_DS\_

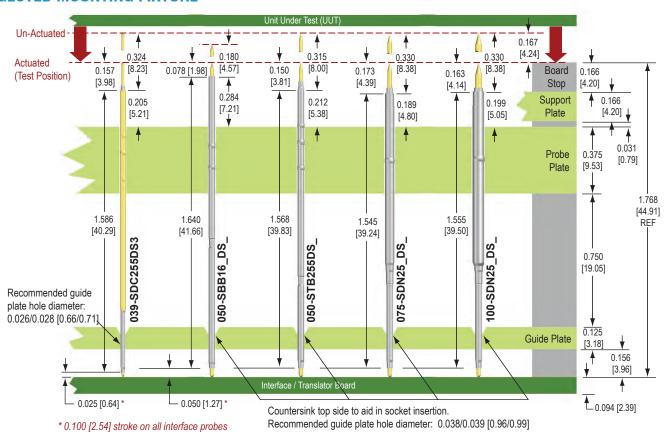
Mounting Hole Dia.

0.053/0.055

[1.346/1.397]



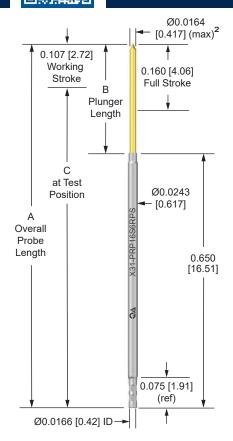
#### SUGGESTED MOUNTING FIXTURE



### **TOOLS & ACCESSORIES**

P/I	N: 07	<b>5-SDN25 DS</b> example: 075-SDN250DS3				
Tube	Letter	Material/Finish				
7	N	Nickel silver/no finish				
6	Digits	Press Ring				
Ring	0	Single press ring located at 0.300 [7.62]				
Press	1	Single press ring located at 0.395 [10.03]				
Δ.	4	Single extra long press ring located at 0.300 [7.62]				
/le	Digits	Material/Finish				
Tip Style	0	Spherical. Heat treated BeCu/gold plated over nickel				
Ē	3	Chisel. Heat treated BeCu/gold plated over nickel				

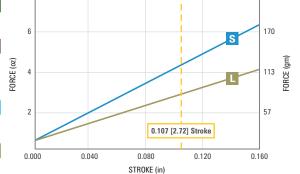
P/I	N: 100	<b>I-SUN25 US</b> example: 100-SDN250DS3			
Tube	Letter	Material/Finish			
F	N	Nickel silver/no finish			
Ring	Digits	Press Ring			
Ę	0	Single press ring located at 0.300 [7.62]			
Press	1	Single press ring located at 0.395 [10.03]			
Д.	4	Single extra long press ring located at 0.300 [7.62]			
/le	Digits	Material/Finish			
Tip Style	0	Spherical. Heat treated BeCu/gold plated over nickel			
F	3	Chisel. Heat treated BeCu/gold plated over nickel			





# PROBE P/N X31-PRP16 example: X31-PRP16S6RPL

Tube	Letter	Material/Finish			Average Resistance	Current Rating AMPS <sup>1</sup> 120°C (204°C) <sup>3</sup>							
F	Р	Nickel silver/IE	precious metal clad		< 64m0hms	3.4 (4.7)3							
Ţ.	Letter	Material/Finish											
Tip Material	S	Heat treate	d steel/gold plated o	ver nickel									
yle	Digits	Description	Description										
Tip Style	See Tips	Tip style geom	etry based on target	type									
gth	Letter	Tip Style Availa	ability Overall	Probe Length (A)	Plunger Length (B)	@ Test Position (C)							
Plunger Length	Р	43, 6R, 9R	2.0	930 [23.62]	0.280 [7.11]	0.823 [20.90]							
9	Letter	Spring Force	Preload	@ 0.107 [2.72] Stro	oke Material	Cycle Life @ 0.107 [2.72] Stroke							
Spring	L	Low	0.7 [20g/0.19N]	3.0 [85g/0.83N]	SS	300,000							
S	S	Standard	0.7 [20g/0.19N]	4.5 [128g/1.25N]	SS	25,000							
		Description											
Option	N					only be used in applications outside pplication note for more details. <sup>3</sup>							
	(Blank)	No option requ	ired										



SPRING FORCE STROKE (mm)

3.05

4.06

#### **TOOLS & ACCESSORIES**

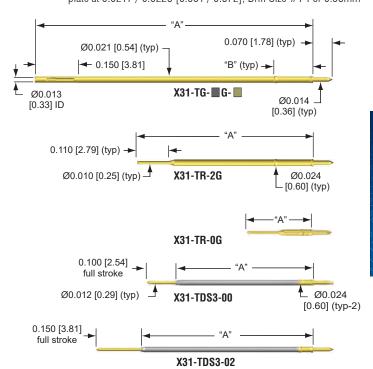
<sup>&</sup>lt;sup>1</sup> Current rating is affected by spring material and lubrication choice. Please refer to Current Carrying Capacity and Testing in Extreme Working Temperature applications notes for more details.

 $<sup>^{\</sup>rm 2}$  Maximum plunger OD should be used to calculate minimum guide plate clearance holes.

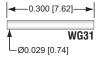
<sup>&</sup>lt;sup>3</sup> Working Temperature Range: -45°C to 120°C with lubrication. SS springs can be used up to 204°C without lubrication.

#### **TERMINATION PIN**

Suggested mounting holes and drill sizes in AT7000, G10/FR4 or similar materials should be gauged in probe plate at 0.0250 / 0.0260 [0.635 / 0.660]; Drill Size #71 or 0.65mm and back plate at 0.0217 / 0.0225 [0.551 / 0.572]; Drill Size #74 or 0.58mm



#### **WIRE GRIP SLEEVE** For use with G termination pins.



#### P/N: WG31

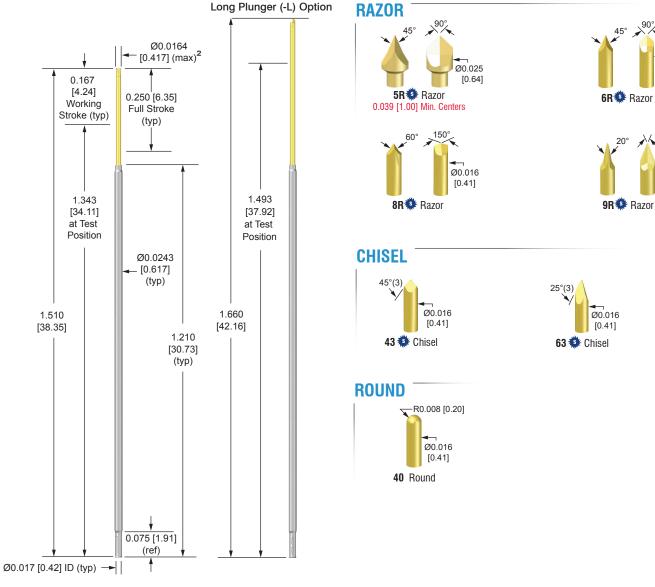
To accept 30AWG Kynar solid insulated wire, stripped at 0.120 [3.05] (not included) Nylon sleeve, clear

#### **TERMINATION PIN P/N**

**X31-T** example: X31-TG-2G DS3 Double-Ended for wireless testing. Order by part number above. Wire Grip: Heat treated BeCu/gold plated, accepts wire grip sleeve. Round Post. Heat treated Becu/gold plated over nickel. Description 0.040 [1.02] Only available in TR 0.230 [5.84] Only available in TR 0.615 [15.62] 0.137 [3.48] Body Only available in TG 0.628 [15.95] 0.077 [1.96] Only available in TG 0.915 [23.24] 0.137 [3.48] Only available in DS3 0.475 [12.07] 0.048 [1.22] 02 Only available in DS3 0.583 [14.81] 0.048 [1.22] X31-TG-2G with WG31 wire grip sleeve (Blank) No option required

US Patent No. 6,570,399 & 4,885,533



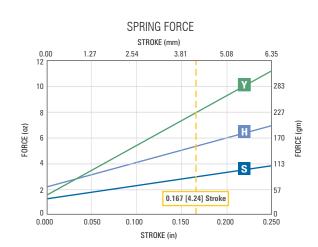


# PROBE P/N X31-PRP25 example: X31-PRP256RH-S

Tube	Letter	Material/Finis	sh		Average Resistance	Current Rating AMPS <sup>1</sup> 120°C (204°C) <sup>3</sup>
_	Р	Nickel silver/	ID precious metal o	clad	$< 65  \mathrm{mOhms}$	2.6 (3.6)3
yle	Digits	Material/Finis	sh			
Tip Style	See Tips	Standard mat	erial is heat treated	BeCu/gold plated over	nickel. (see S o	ption for steel plungers)
		Spring Force	Preload	@ 0.167 [4.24] Stroke	Material	Cycle Life @ 0.167 [4.24] Stroke
Spring	S	Standard	1.5 [43g/0.42N]	3.6 [102g/1.00N]	MW	1,000,000
Sp	Н	High	2.2 [62g/0.62N]	5.4 [153g/1.50N]	SS	50,000
	Υ	Elevated	1.5 [43g/0.42N]	8.0 [227g/2.22N]	SS	25,000
		Description				
	L	Long plunger	. Must select from	X31-40 tip styles		
Option	N		e working temperatı			should only be used in applications ng Temperatures application note
	S	Heat treat	ted steel/plated gol	d over nickel (see tip st	yle for availabilit	y)
	(Blank)	No option req	quired			

<sup>&</sup>lt;sup>1</sup> Current rating is affected by spring material and lubrication choice. Please refer to Current Carrying Capacity and Testing in Extreme Working Temperature applications notes for more details.

<sup>&</sup>lt;sup>3</sup> Working Temperature Range: -45°C to 120°C with lubrication. SS springs can be used up to 204°C without lubrication.



Ø0.016

[0.41]

Ø0.016 [0.41]

#### **TOOLS & ACCESSORIES**

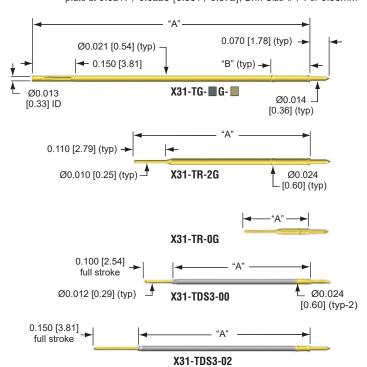
 $<sup>^{\</sup>rm 2}$  Maximum plunger OD should be used to calculate minimum guide plate clearance holes.



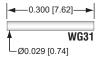


#### **TERMINATION PIN**

Suggested mounting holes and drill sizes in AT7000, G10/FR4 or similar materials should be gauged in probe plate at 0.0250 / 0.0260 [0.635 / 0.660]; Drill Size #71 or 0.65mm and back plate at 0.0217 / 0.0225 [0.551 / 0.572]; Drill Size #74 or 0.58mm



#### **WIRE GRIP SLEEVE** For use with G termination pins.



#### P/N: WG31

To accept 30AWG Kynar solid insulated wire, stripped at 0.120 [3.05] (not included) Nylon sleeve, clear

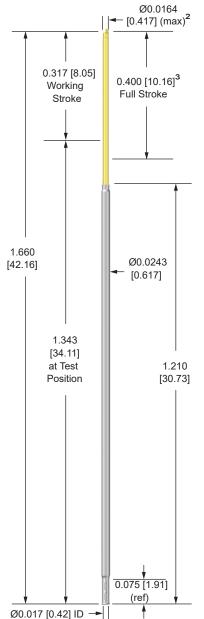
#### **TERMINATION PIN P/N**

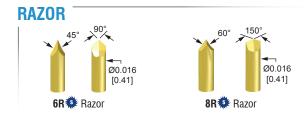
**X31-T** example: X31-TG-3G DS3 Double-Ended for wireless testing. Order by part number above. Wire Grip: Heat treated BeCu/gold plated, accepts wire grip sleeve. Round Post. Heat treated Becu/gold plated over nickel. 0.040 [1.02] Only available in TR 0.230 [5.84] Only available in TR 0.615 [15.62] 0.137 [3.48] Body Only available in TG 0.628 [15.95] 0.077 [1.96] Only available in TG 0.915 [23.24] 0.137 [3.48] Only available in DS3 0.475 [12.07] 0.048 [1.22] 02 Only available in DS3 0.583 [14.81] 0.048 [1.22] X31-TG-3G with WG31 wire grip sleeve

US Patent No. 6,570,399 & 4,885,533

(Blank) No option required









# PROBE P/N X31-PRP40 example: X31-PRP406RS-S

Tube	Letter	Material/Finish	1		Average Resistance	Current Rating AMPS¹ 120°C (204°C)⁴						
_	Р	Nickel silver/IE	precious metal cla	ad	< 100m0hms	2.5 (3.6)4						
Style	Digits	Description										
Tip St	See Tips	Heat treated st	eel/plated gold ove									
9		Spring Force	Preload	@ 0.317 [8.05] Stroke	Material	Cycle Life @ 0.317 [8.05] Stroke						
Spring	S	Standard	0.7 [20g/0.19N]	4.0 [113g/1.11N]	SS	50,000						
S	$H^3$	High	1.8 [51g/0.50N]	6.0 [170g/1.67N]	SS	50,000						
		Description										
Option _	N	No probe lubri outside of the more details. <sup>4</sup>	cation. Removing lu working temperatur	ubrication greatly reduces e range, see Testing in Ex	cycle life and sho treme Working Te	ould only be used in applications imperatures application note for						
	S	Heat treate	d steel/plated gold	over nickel (see tip style	for availability)							
	(Blank)	No option requ	iired									

<sup>&</sup>lt;sup>1</sup> Current rating is affected by spring material and lubrication choice. Please refer to Current Carrying Capacity and Testing in Extreme Working Temperature applications notes for more details.

#### SPRING FORCE STROKE (mm) 10.16 0.00 2.54 5.08 7.62 170 -ORCE (gm) FORCE (oz) 113 0.317 [8.05] —10 0.400 0.200 0.300

#### **TOOLS & ACCESSORIES**

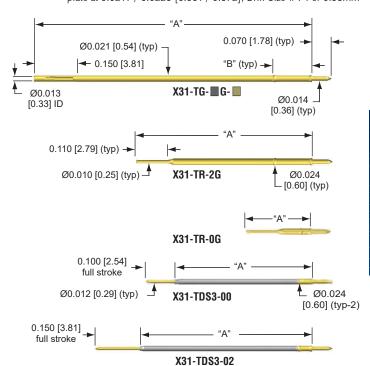
<sup>&</sup>lt;sup>2</sup> Maximum plunger OD should be used to calculate minimum guide plate clearance holes.

<sup>3 0.350 [8.89]</sup> max stroke for H spring.

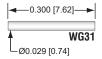
<sup>&</sup>lt;sup>4</sup> Working Temperature Range: -45°C to 120°C with lubrication. SS springs can be used up to 204°C without lubrication.

#### **TERMINATION PIN**

Suggested mounting holes and drill sizes in AT7000, G10/FR4 or similar materials should be gauged in probe plate at 0.0250 / 0.0260 [0.635 / 0.660]; Drill Size #71 or 0.65mm and back plate at 0.0217 / 0.0225 [0.551 / 0.572]; Drill Size #74 or 0.58mm



#### **WIRE GRIP SLEEVE** For use with G termination pins.



#### P/N: WG31

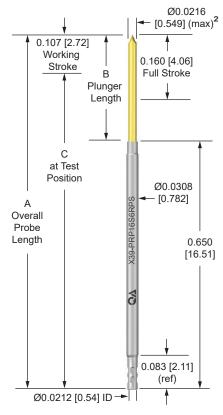
To accept 30AWG Kynar solid insulated wire, stripped at 0.120 [3.05] (not included) Nylon sleeve, clear

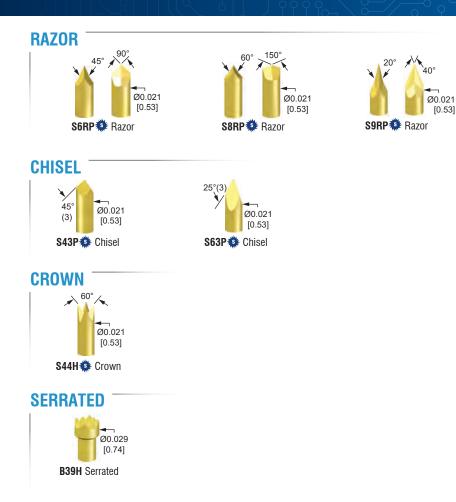
#### **TERMINATION PIN P/N**

**X31-T** example: X31-TG-3G DS3 Double-Ended for wireless testing. Order by part number above. Wire Grip: Heat treated BeCu/gold plated, accepts wire grip sleeve. Round Post. Heat treated Becu/gold plated over nickel. 0.040 [1.02] Only available in TR 0.230 [5.84] Only available in TR 0.615 [15.62] 0.137 [3.48] Body Only available in TG 0.628 [15.95] 0.077 [1.96] Only available in TG 0.915 [23.24] 0.137 [3.48] Only available in DS3 0.475 [12.07] 0.048 [1.22] 02 Only available in DS3 0.583 [14.81] 0.048 [1.22] X31-TG-3G with WG31 wire grip sleeve (Blank) No option required

US Patent No. 6,570,399 & 4,885,533







# PROBE P/N X39-PRP16 example: X39-PRP16S43PS

Tube	Letter	Material/Finish			Average Resistance	Current Rating AMPS <sup>1</sup> 120°C (204°C) <sup>3</sup>					
=	Р	Nickel silver/ID	precious metal clad	l	< 42 m0hms	4.5 (6.2)3					
rial	Letter	Material/Finish									
Tip Material	В	Heat treated BeCu/gold plated over nickel									
_	S	* Heat treated steel/gold plated over nickel									
yle	Digits	Description									
Tip Style	See Tips	Tip style geom	etry based on target	type							
gth	Letter	Tip Style Availa	ability Overall	Probe Length (A)	Plunger Length (	B) @ Test Position (C)					
Plunger Length	Н	39, 44	0.	870 [22.10]	0.220 [5.59]	0.763 [19.38]					
Plung	Р	43, 63, 6R, 8R	, 9R 0.	930 [23.62]	0.280 [7.11]	0.823 [20.90]					
	Letter	Spring Force	Preload	@ 0.107 [2.72] Strok	e Material	Cycle Life @ 0.107 [2.72] Stroke					
Spring	L	Low	0.8 [23g/0.22N]	3.0 [85g/0.83N]	SS	300,000					
중	S	Standard	0.8 [23g/0.22N]	4.5 [128g/1.25N]	SS	300,000					
	Н	High	1.0 [28g/0.28N]	6.0 [170g/1.67N]	SS	50,000					
		Description									
Option	N	applications or		orication greatly reduce temperature range, see		ould only be used in ne Working Temperatures					
	(Blank)	No option requ	ired								



SPRING FORCE STROKE (mm)

3.05

4.06

#### **TOOLS & ACCESSORIES**

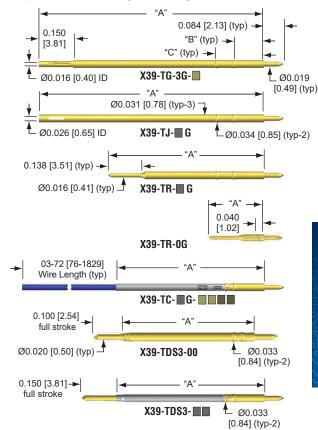
Extreme

¹ Current rating is affected by spring material and lubrication choice. Please refer to Current Carrying Capacity and Testing in Extreme Working Temperature applications notes for more details.

<sup>&</sup>lt;sup>2</sup> Maximum plunger OD should be used to calculate minimum guide plate clearance holes.

<sup>&</sup>lt;sup>3</sup> Working Temperature Range: -45°C to 120°C with lubrication. SS springs can be used up to 204°C without lubrication.

Suggested mounting holes and drill sizes in AT7000, G10/FR4 or similar materials should be gauged in probe plate at 0.0315 / 0.0325 [0.800 / 0.826]; Drill Size #66 or 0.84mm and back plate at 0.0315 / 0.0325 [0.800 / 0.826]; Drill Size #66 or 0.84mm



## TERMINATION PIN P/N

**X39-T - G-** example: X39-TJ-2G

		^	00 1		1		олаптрі	U. /	100 1	0 20	
ion	С	Crimped. Ter Tube materia				ed Be	Cu/gold pla	ted c	ver nick	æl.	
Termination	DS3	Double-ende	d for wireles	s tes	ting. See pa	ge 69	9 for orderin	g de	tails.		
erm	G	Wire Grip. He	at treated Bet	Cu/go	ld plated ove	er nic	kel, accepts	wire	grip slee	ve.	
	J	Wire Jack. H	eat treated B	eCu/	gold plated	over	nickel, acce	pts v	ire jack		
	R	Round post. Heat treated BeCu/gold plated over nickel.									
	Digits	Description		ŀ	A in (mm)		B in (mm)		C in (	mm)	
	0	Only availabl	e in TC	0.5	82 [14.78]		0.113 [2.87	]	0.065	[1.65]	
		Only availabl	e in TR	0.	261 [6.63]		0.040 [1.02	2]	0.000	[0.00]	
	1	Only availabl	e in TC	0.6	642 [16.31]		0.173 [4.39	)]	0.125	[3.18]	
	2	Only availabl	e in TJ	0.6	628 [15.95]		0.077 [1.96	i]	0.036	[0.91]	
Body		Only availabl	e in TR	0.675 [17.15]			0.210 [5.33]		0.125	[3.18]	
	3	Only availabl	e in TG	in TG 0.9			0.210 [5.33	0 [5.33]		[3.18]	
		Only availabl	e in TJ				0.210 [5.33	8] 0.125 [3.18		[3.18]	
	4	Only availabl	e in TJ	e in TJ 1.100 [27.94]			0.210 [5.33	3]	0.125	[3.18]	
	5	Only availabl	e in TJ	1.225 [31.12] 0.2			0.210 [5.33	3]	0.125	[3.18]	
_	8	Only availabl	e in TJ	1.6	600 [40.64]		0.210 [5.33	3]	0.125	[3.18]	
	Digits	Available for TG Termination Only									
	2	X39-TG-3G v	X39-TG-3G with WG39 wire grip sleeve								
	Digits	Wire Size Available for TC Termination Only									
	3	Wire Size Available for TC Termination Only  30 AWG Kynar insulated solid wire, pre-attached. Specify color and length  28 AWG Kynar insulated solid wire, pre-attached. Specify color and length  28 AWG Kynar insulated solid wire, pre-attached. Specify color and length  29 Available for TC Termination Only  Black  2 Red  4 Yellow  6 Blue  8 Grey  Brown  3 Orange  5 Green  7 Violet  9 White  angth Available for TC Termination  Decify Length in inches: 03 – 72 [76-1829]  ank) No option required									
SI	8	28 AWG Kyn	ar insulated s	solid	wire, pre-atta	achec	l. Specify co	lor a	nd lengt	h	
Options	Wire C	olors Available	for TC Tern	ninati	on Only						
0	0	Black 2	Red	4	Yellow	6	Blue	8	Gr	еу	
	1	Brown 3	Orange	5	Green	7	Violet	9	Wh	iite	
	Wire Le	ength Availabl	e for TC Tern	ninati	on						
	S	pecify Length i	n inches: 03	8 – 72	[76-1829]						
	(Bla	ank) No optior	required								

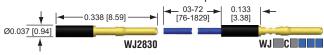
#### WIRE GRIP SLEEVE For use with G termination pins.



### P/N: WG39

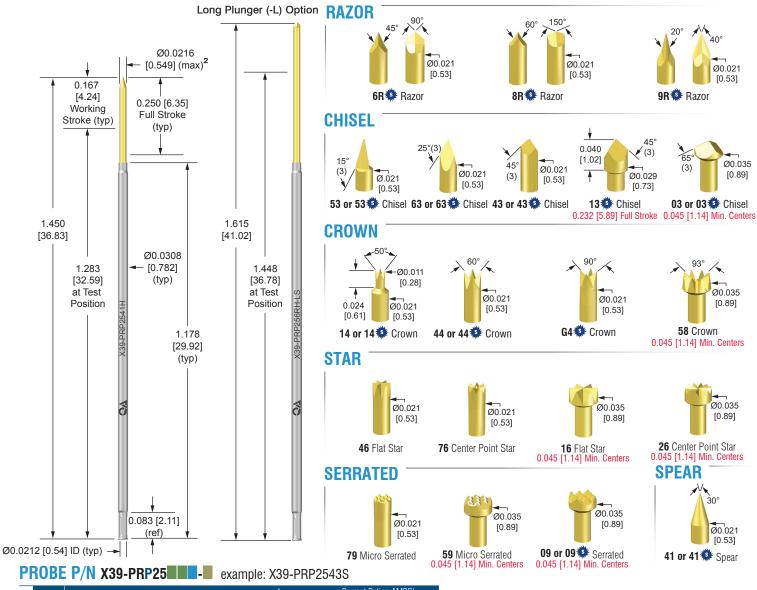
To accept 30AWG Kynar solid insulated wire, stripped at 0.120 [3.05], (not included) Nylon sleeve, black

### **WIRE JACK** For use with J termination pins.



#### **P/N: WJ** example: WJ28C8230

	Digit	Descripti	on								
Size	2830	Wire Jack	c only	(customer to	o crim	np wire) bras	s/gold	l plated with	nylon	insulator.	
S	28C8	28 AWG	Kynar	insulated so	lid wi	re, pre-attac	hed, s	pecify color	and le	ength.	
	30C3	30 AWG	Kynar	insulated so	lid wi	re, pre-attac	hed, s	pecify color	and le	ength.	
	Colors Available for 28C & 30C Termination										
	0	Black	2	Red		Yellow	6	Blue	8	Gray	
Wire	1	Brown	3	Orange	5	Green	7	Violet	9	White	
>	Wire l	ength Avai	lable	for 28C & 30	OC Te	rmination					
	Specify Length in inches: 03 – 72 [76-1829]										
00	E Letter Description										
Opti	Letter Description S Stripped Length 0.000/0.669 [0.00/16.99]; Customer to specify in inches										



#### Current Rating AMPS Material/Finish Nickel silver/ID precious metal clad < 25 m0hms 3.4 (4.7) Digits See Tips 음 Standard material is heat treated BeCu/plated gold over nickel. (see S option for steel plungers) L 1.2 [34g/0.33N] 3.0 [85q/0.83N] MW 1,000,000 S 1.1 [31g/0.31N] 4.3 [122g/1.20N] 1,000,000 Standard MW Н High 2.4 [68q/0.67N] 5.6 [159q/1.56N] MW 1,000,000 Elevated 3.2 [91g/0.89N] 8.0 [227g/2.22N] SS 25,000 Ε High Preload 4.2 [119g/1.17N] 8.0 [227g/2.22N] SS 10,000 Long plunger. Must select from X39-40 tip styles No probe lubrication. Removing lubrication greatly reduces cycle life and should only be used in applications outside of the working temperature range, see Testing in Extreme Working Temperatures application note for S Heat treated steel/plated gold over nickel (see tip style for availability) No option required (Blank)

SPRING FORCE

STROKE (mm)

5.08

6.35

#### **TOOLS & ACCESSORIES**

0.00

<sup>10</sup> 283 227 FORCE (oz) FORCE (gm 170 113 57 0.167 [4.24] Stroke 0.000 0.050 0.100 0.150 0.200 0.250 STROKE (in)

Current rating is affected by spring material and lubrication choice. Please refer to Current Carrying Capacity and Testing in Extreme Working Temperature applications notes for more details.

<sup>&</sup>lt;sup>2</sup> Maximum plunger OD should be used to calculate minimum guide plate clearance holes.

<sup>&</sup>lt;sup>3</sup> Working Temperature Range: -45°C to 120°C with lubrication. SS springs can be used up to 204°C without lubrication.



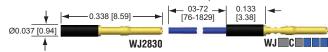
### WIRE GRIP SLEEVE For use with G termination pins.



P/N: WG39

To accept 30AWG Kynar solid insulated wire, stripped at 0.120 [3.05], (not included) Nylon sleeve, black

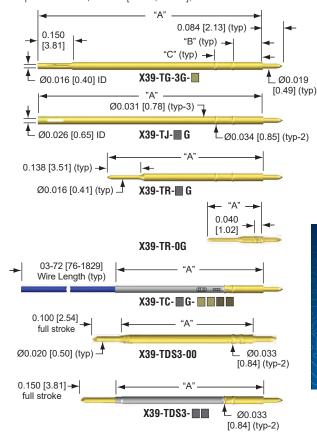
#### **WIRE JACK** For use with J termination pins.



### **P/N: W.I** example: W.I28C8230

' / '	4. VV	J			CV	ampic.	1102	000230	,			
	Digit	Descripti										
Size	2830	Wire Jack	only	(customer t	o crim	np wire) bras	s/gold	plated with	nylon	insulator.		
S	28C8	28C8 28 AWG Kynar insulated solid wire, pre-attached, specify color and length.										
	30C3											
	Colors	Available	for 28	C & 30C Te	rmina	tion						
	0	Black	2	Red		Yellow	6	Blue	8	Gray		
Wire	1	Brown	3	Orange	5	Green	7	Violet	9	White		
_	Wire L	ength Avai	lable t	for 28C & 30	OC Te	rmination						
	Specify Length in inches: 03 – 72 [76-1829]											
ion	Letter	Descripti	on									
Option	S Stripped Length 0.000/0.669 [0.00/16.99]; Customer to specify in inches											

Suggested mounting holes and drill sizes in AT7000, G10/FR4 or similar materials should be gauged in probe plate at 0.0315 / 0.0325 [0.800 / 0.826]; Drill Size #66 or 0.84mm and back plate at 0.0315 / 0.0325 [0.800 / 0.826]; Drill Size #66 or 0.84mm



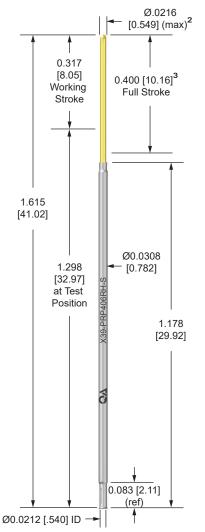
#### TERMINATION PIN P/N

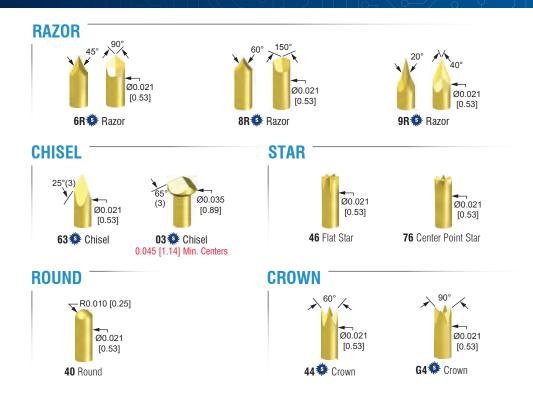
		X	39-T	- <b>I</b> G	-		exampl	e: X	39-TJ-30
	Letter	Material/Finis	sh						
ion	С	Crimped. Ter Tube materia				ed Be	Cu/gold pla	ted ov	ver nickel.
inat	DS3	Double-ende	d for wirele	ss testi	ing. See pa	ge 69	9 for orderin	g deta	ails.
Termination	G	Wire Grip. He	at treated Be	Cu/gol	d plated ove	er nic	kel, accepts	wire g	rip sleeve.
<u> </u>	J	Wire Jack. He	eat treated E	BeCu/g	old plated	over	nickel, acce	pts wi	ire jack.
	R	Round post.	Heat treated	BeCu,	gold plate	d ove	r nickel.		
	Digits	Description		А	in (mm)		B in (mm)		C in (mm)
		Only availabl	e in TC	0.5	82 [14.78]		0.113 [2.87	]	0.065 [1.65]
	0	Only available	e in TR	0.2	61 [6.63]		0.040 [1.02	]	0.000 [0.00]
	1	Only availabl	e in TC	0.6	42 [16.31]		0.173 [4.39	]	0.125 [3.18]
	0	Only availabl	e in TJ	0.6	28 [15.95]		0.077 [1.96	]	0.036 [0.91]
Body	2	Only available	e in TR	0.6	75 [17.15]		0.210 [5.33	]	0.125 [3.18]
	0	Only availabl	e in TG	0.9	75 [24.77]		0.210 [5.33	]	0.125 [3.18]
	3	Only availabl	e in TJ	0.9	75 [24.77]		0.210 [5.33	]	0.125 [3.18]
	4	Only availabl	e in TJ	1.10	00 [27.94]		0.210 [5.33	]	0.125 [3.18]
	5	Only availabl	e in TJ	1.2	25 [31.12]		0.210 [5.33	]	0.125 [3.18]
	8	Only availabl	e in TJ	1.6	00 [40.64]		0.210 [5.33	]	0.125 [3.18]
		Available for		tion Oı					
	2	X39-TG-3G v	vith WG39 w	ire grip	sleeve				
	Digits	Wire Size Ava	ailable for T	C Tern	nination On	ly			
	3	30 AWG Kyna	ar insulated	solid w	rire, pre-atta	achec	I. Specify co	lor an	d length
S	8	28 AWG Kyna	ar insulated	solid w	rire, pre-att	achec	I. Specify co	lor an	d length
Options	Wire C	olors Available	for TC Terr	ninatio	n Only				
Ö	0	Black 2	Red	4	Yellow	6	Blue	8	Grey
	1	Brown 3	Orange	5	Green	7	Violet	9	White
	Wire Le	ength Available		minatio	n				
	Sı	pecify Length i	n inches: 03	3 – 72	[76-1829]				
		anlıl Marantian			,				

(Blank) No option required

ISI



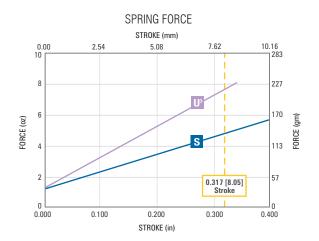




# PROBE P/N X39-PRP40 example: X39-PRP408RS-S

Tube	Letter	Material/Finis	h		Average Resistance	Current Rating AMPS <sup>1</sup> 120°C (204°C) <sup>4</sup>					
-	Р	Nickel silver/l	D precious metal o	lad	< 55 m0hms	3.3 (4.5)4					
yle	Digits	Material/Finis	h								
Tip Style	See Tips	Standard material is heat treated BeCu/plated gold over nickel (see S option for steel plungers)									
SE	Letter	Spring Force	Preload	@ 0.317 [8.05] Stroke	Material	Cycle Life @ 0.317 [8.05] Stroke					
Springs	S	Standard	1.2 [34g/0.33N]	4.8 [136g/1.32N]	SS	100,000					
S	U <sup>3</sup>	Ultra	1.3 [37g/0.36N]	7.5 [213g/2.09N]	SS	10,000					
		Description									
Option .	N	applications of				should only be used in reme Working Temperatures					
0	S	Neat treat	ed steel/plated gol	d over nickel (see tip style	e for availability	)					
	(Blank)	No option req	uired								

<sup>&</sup>lt;sup>1</sup> Current rating is affected by spring material and lubrication choice. Please refer to Current Carrying Capacity and Testing in Extreme Working Temperature applications notes for more details.



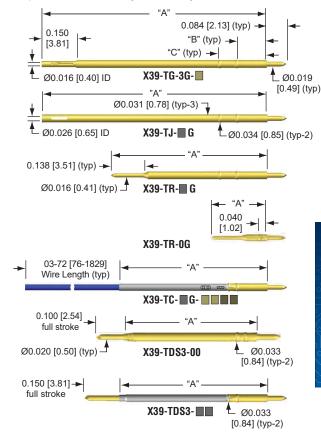
#### **TOOLS & ACCESSORIES**

<sup>&</sup>lt;sup>2</sup> Maximum plunger OD should be used to calculate minimum guide plate clearance holes.

<sup>3 0.350 [8.89]</sup> max stroke for U spring.

<sup>&</sup>lt;sup>4</sup> Working Temperature Range: -45°C to 120°C with lubrication. SS springs can be used up to 204°C without lubrication.

Suggested mounting holes and drill sizes in AT7000, G10/FR4 or similar materials should be gauged in probe plate at 0.0315 / 0.0325 [0.800 / 0.826]; Drill Size #66 or 0.84mm and back plate at 0.0315 / 0.0325 [0.800 / 0.826]; Drill Size #66 or 0.84mm



### **TERMINATION PIN P/N**

**X39-T - G-** example: X39-TJ-3G

ermination		
ion	С	Crimped. Termination material: Heat treated BeCu/gold plated over nickel. Tube material: ID precious metal clad.
inat	DS3	Double-ended for wireless testing. See page 69 for ordering details.
erm	G	Wire Grip. Heat treated BeCu/gold plated over nickel, accepts wire grip sleeve.
<u> </u>	J	Wire Jack. Heat treated BeCu/gold plated over nickel, accepts wire jack.

	F	Round post. Heat tre	eated BeCu/gold plate	ed over nickel.	
	Digits	Description	A in (mm)	B in (mm)	C in (mm)
	0	Only available in TC	0.582 [14.78]	0.113 [2.87]	0.065 [1.65]
	U	Only available in TR	0.261 [6.63]	0.040 [1.02]	0.000 [0.00]
	1	Only available in TC	0.642 [16.31]	0.173 [4.39]	0.125 [3.18]
	2	Only available in TJ	0.628 [15.95]	0.077 [1.96]	0.036 [0.91]
Body		Only available in TR	0.675 [17.15]	0.210 [5.33]	0.125 [3.18]
_	3	Only available in TG	0.975 [24.77]	0.210 [5.33]	0.125 [3.18]
	3	Only available in TJ	0.975 [24.77]	0.210 [5.33]	0.125 [3.18]
	4	Only available in TJ	1.100 [27.94]	0.210 [5.33]	0.125 [3.18]
	5	Only available in TJ	1.225 [31.12]	0.210 [5.33]	0.125 [3.18]
	8	Only available in TJ	1.600 [40.64]	0.210 [5.33]	0.125 [3.18]
		Austlahla far TO Tarasia	ation Only		

		Available	101	i di Tellillillati	י ווטוו							
	2	X39-TG-	3G w	ith WG39 wi	re gr	ip sleeve						
		Wire Size	Wire Size Available for TC Termination Only									
	3	30 AWG	Kyna	r insulated s	olid	wire, pre-atta	chec	l. Specify c	olor ar	nd length	4 885 533	
SI	8	8 28 AWG Kynar insulated solid wire, pre-attached. Specify color and length										
Options	Wire C	Colors Avail	lable	for TC Term	inati	on Only					8 668	
0	0	Black	2	Red		Yellow	6	Blue	8	Grey	6.570.399	
	1	Brown		Orange	5	Green	7	Violet	9	White		
	Wire L	ength Avai.	lable	for TC Term	inati	on					Patent No.	
	Specify Length in inches: 03 – 72 [76-1829]											
	(B	lank) No o <sub>l</sub>	ption	required							S	

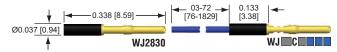
## WIRE GRIP SLEEVE For use with G termination pins.



#### P/N: WG39

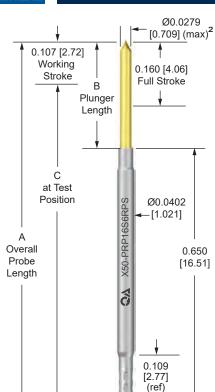
Description/Materia To accept 30AWG Kynar solid insulated wire, stripped at 0.120 [3.05], (not included) Nylon sleeve, black

## WIRE JACK For use with J termination pins.

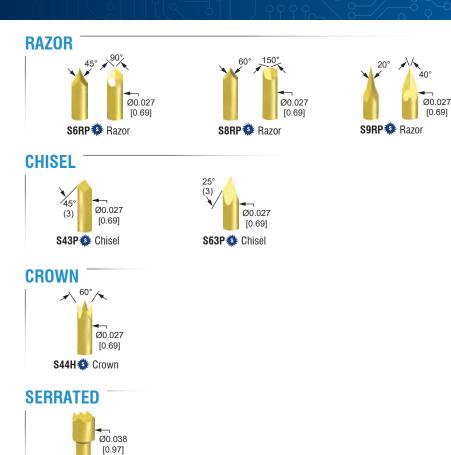


#### **P/N: WJ** example: WJ28C8230

	Digit	Descripti	on											
Size	2830	Wire Jacl	Wire Jack only (customer to crimp wire) brass/gold plated with nylon insulator.											
S	28C8	28 AWG Kynar insulated solid wire, pre-attached, specify color and length.												
	30C3	30 AWG Kynar insulated solid wire, pre-attached, specify color and length.												
	Colors Available for 28C & 30C Termination													
	0	Black	2	Red		Yellow	6	Blue	8	Gray				
Wire	1	Brown		Orange	5	Green	7	Violet	9	White				
_	Wire I	Length Avai	lable	for 28C & 30	OC Te	rmination								
Specify Length in inches: 03 – 72 [76-1829]														
lon	Letter Description													
Option	S Stripped Length 0.000/0.669 [0.00/16.99]; Customer to specify in inches								nches					



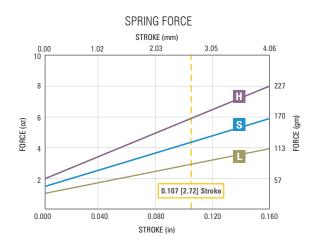
Ø0.027 [0.67] ID --



## PROBE P/N X50-PRP16 example: X50-PRP16S43PS

					•	
Tube	Letter	Material/Fir	nish		Average Resistance	Current Rating AMPS <sup>1</sup> 120°C (204°C) <sup>3</sup>
-	Р	Nickel silve	r/ID precious metal of	clad	< 41 m0hms	5.7 (7.8) <sup>3</sup>
Tip Material	Letter	Material/Fir	nish			
Mate	В	Heat treated	d BeCu/gold plated o	ver nickel		
₽	S	Heat tre	eated steel/gold plate	d over nickel		
yle	Digits	Description	l e			
Tip Style	See Tips	Tip style ge	ometry based on tarç	get type		
gth	Letter	Tip Style Av	ailability Ove	rall Probe Length (A)	Plunger Length (B	@ Test Position (C)
Plunger Length	Н	39, 44		0.870 [22.10]	0.220 [5.59]	0.763 [19.38]
Plung	Р	43, 63, 6R, 8R, 9R		0.930 [23.62]	0.280 [7.11]	0.823 [20.90]
	Letter	Spring Ford	e Preload	@ 0.107 [2.72] Stroke	Material Cy	rcle Life @ 0.107 [2.72] Stroke
Spring	L	Low	1.1 [31g/0.31N]	3.0 [85g/0.83N]	SS	300,000
쿬	S	Standard	1.5 [43g/0.42N]	4.5 [128g/1.25N]	SS	300,000
	Н	High	2.0 [57g/0.56N]	6.0 [170g/1.67N]	SS	100,000
		Description				
Option	N	applications		lubrication greatly reducting temperature range, s		
	(Blank)	No option r	equired			
_						

<sup>&</sup>lt;sup>1</sup> Current rating is affected by spring material and lubrication choice. Please refer to Current Carrying Capacity and Testing in Extreme Working Temperature applications notes for more details.



#### **TOOLS & ACCESSORIES**

See pages 75-79 for order information.

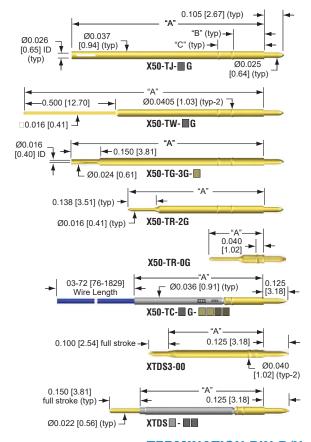
**B39H** Serrated

<sup>&</sup>lt;sup>2</sup> Maximum plunger OD should be used to calculate minimum guide plate clearance holes.

 $<sup>^3</sup>$  Working Temperature Range: -45°C to 120°C with lubrication. SS springs can be used up to 204°C without lubrication.

#### TERMINATION PIN

Suggested mounting holes and drill sizes in AT7000, G10/FR4 or similar materials should be gauged in probe plate at 0.0415 / 0.0430 [1.054 / 1.092]; Drill Size #57 or 1.1mm and back plate at 0.0380 / 0.0390 [0.965 / 0.990]; Drill Size 1.0mm



### **TERMINATION PIN P/N X50-T** - **G**- example: X50-TW-2G

Crimped. Termination material: Heat treated BeCu/gold plated over nickel.

С Tube material: ID precious metal clad. DS3 Double-Ended for wireless testing. See page 69 for ordering details. J Wire Jack. Heat treated Becu/gold plated over nickel, accepts wire jacks.

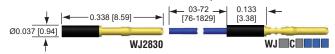
Round Post. Heat treated BeCu/gold plated over nickel

	W	Wire Wrap. Heat treated Be	Cu/gold plated over	nickel.	
	Digits	Description	A in (mm)	B in (mm)	C in (mm)
	0	Only available in TC	0.623 [15.82]	0.149 [3.78]	0.100 [2.54]
		Only available in TR	0.265 [6.73]	0.040 [1.02]	0.000 [0.00]
	1	Only available in TC	0.683 [17.35]	0.209 [5.31]	0.160 [4.06]
		Only available in TJ	0.628 [15.95]	0.078 [1.98]	0.035 [0.89]
_	2	Only available in TR	0.715 [18.16]	0.245 [6.22]	0.160 [4.06]
Body	3	Only available in TW	0.878 [22.30]	0.078 [1.98]	0.035 [0.89]
_	3	Only available in TJ or TG	1.015 [25.78]	0.245 [6.22]	0.160 [4.06]
	5	Only available in TJ or TW	1.265 [32.13]	0.245 [6.22]	0.160 [4.06]
	7	Only available in TW	1.765 [44.83]	0.245 [6.22]	0.160 [4.06]
	00	Only available in DS	0.475 [12.07]	0.035 [0.89]	0.078 [1.98]
	80	Only available in DS	0.623 [15.82]	0.100 [2.54]	0.149 [3.78]
	14	Only available in DS	0.683 [17.35]	0.159 [4.04]	0.209 [5.31]
	Digits	Wire Size Available for TC	Termination Only		
	3	30 AWG Kynar insulated so	lid wire, pre-attache	d. Specify color ar	nd length
	8	28 AWG Kynar insulated so	lid wire nre-attache	d. Specify color ar	nd length

WIRE GRIP SLEEVE For use with G termination pins.



## WIRE JACK For use with J termination pins.



#### P/N: WJ example: WJ28C8230

- , -						p						
	Digit Description											
Size	2830 Wire Jack only (customer to crimp wire) brass/gold plated with nylon insulator.											
S	28C8	28C8 28 AWG Kynar insulated solid wire, pre-attached, specify color and length.										
30C3 30 AWG Kynar insulated solid wire, pre-attached, specify color at									and le	ngth.		
Colors Available for 28C & 30C Termination												
-	0	Black	2	Red	4	Yellow	6	Blue	8	Gray		
Wire	1	Brown	3	Orange	5	Green	7	Violet	9	White		
	Wire I	_ength Ava	ilable f	or 28C & 3	OC Tei	rmination						
Specify Length in inches: 03 – 72 [76-1829]												
Letter   Description   S   Stripped Length 0.000/0.669 [0.00/16.99]; Customer to specify in inc												
									fy in ir	iches		

Yellow

Green

Blue

Violet

Red

Orange

Specify Length in inches: 03 - 72 [76-1829]

Wire Length Available for TC Termination

US Patent No. 6,570,399 & 4,885,533

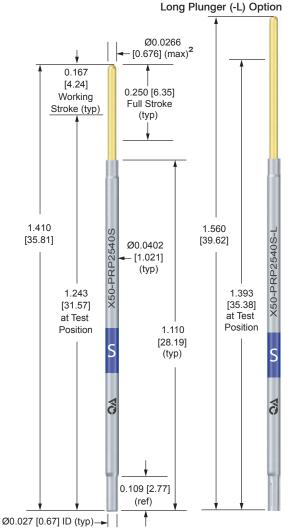
Grey

White

Black

(Blank) No option required













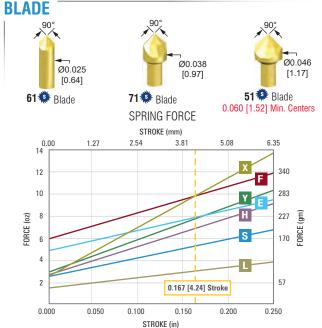
	0.000 [1.02] 11111.	Johnson 0.000 [1.02] Milli. 00110	310 0.000 [1.02] Mill. Contolo
	TRIAD		
	0.025 [0.64] B.C. 0.045 [1.14]	(3) 0.012 (0.30] B.C. (3) 0.046 [1.17]	0.023 [0.58] B.C. 0.046 (3)
ı	<b>08 or 08</b> Triad 0.060 [1.52] Min. Centers	18 or 18 Chisel Triad	38 Chisel Triad 0.060 [1.52] Min. Centers

orampion received	<b>PROBE</b>	P/N	X50-PRP25	-	example: X50-PRP2584X-S
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Tube	Letter	Material/Finisl	า		Average Resistance	Current Rating AMPS <sup>1</sup> 120°C (204°C) <sup>3</sup>
-	Р	Nickel silver/II	D precious metal cla	ıd	< 35 m0hms	5.6 (7.8) <sup>3</sup>
yle	Digits	Material/Finisl				
Tip Style	See Tips	Standard mate	erial is heat treated E	seCu/plated gold over ni	ckel. (see S option	on for steel plungers)
	Letter	Spring Force	Preload	@ 0.167 [4.24] Stroke	Material	Cycle Life @ 0.167 [4.24] Stroke
	L	Low	1.5 [43g/0.42N]	3.1 [88g/0.86N]	MW	1,000,000
	S	Standard	2.7 [77g/0.75N]	5.5 [156g/1.53N]	MW	1,000,000
6	Н	High	2.7 [77g/0.75N]	7.0 [198g/1.95N]	SS	1,000,000
Spring	Υ	Elevated	3.1 [88g/0.86N]	8.0 [227g/2.22N]	MW	250,000
S	Χ	Extra	2.7 [77g/0.75N]	10.1 [286g/2.81N]	MW	100,000
		High Preload	Spring – <i>Only availai</i>	ble with headless 🥵 ste	eel tip styles.	
	Е	High Preload	5.0 [142g/1.39N]	8.0 [227g/2.22N]	SS	300,000
	F	High Preload	6.0 [170g/1.67N]	10.0 [283g/2.78N]	SS	300,000
	Letter	Description				
	L	Long plunger.	Must select from X	50-40 tip styles		
Option	N	applications o				should only be used in me Working Temperatures
	S	Neat treate	ed steel/plated gold	over nickel (see tip style	e for availability)	
	(Blank)	No option requ	uired			

Current rating is affected by spring material and lubrication choice. Please refer to Current Carrying Capacity and Testing in Extreme Working Temperature applications notes for more details.

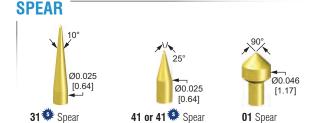
<sup>&</sup>lt;sup>3</sup> Working Temperature Range: -55°C to 120°C with lubrication. SS springs can be used up to 204°C without lubrication.



<sup>&</sup>lt;sup>2</sup> Maximum plunger OD should be used to calculate minimum guide plate clearance holes.

#### **CROWN** Ø0.020 Ø0.012 Ø0.018 [0.46][0.51] [0.30]-Ø0.025 Ø0.025 Ø0.025 [0.64] [0.64] [0.64] 84 Crown G4 Crown 54 Crown -Ø0.030 Ø0.020 [0.75][0.51] Ø0.025 -Ø0.025 Ø0.046 [0.64] [0.64][1.17] **44 or 44** Crown 74 Crown **34 or 34** Crown 0.060 [1.52] Min. Centers Ø0.032 0.037 [0.80] [0.94] B.C. Ø0.040 Ø0.042 [1.02] [1.07] N4 Crown **55 or 55** Crown 0.060 [1.52] Min. Centers 100° Ø0.040 [1.01] Ø0.046 Ø0.046 [1.17] [1.17] 24 or 24 Crown **58** Crown 0.060 [1.52] Min. Centers 0.060 [1.52] Min. Centers **TORCH** \_\_\_\_0.007 [0.18] -0.010 [0.25] Ø0.021 [0.53]Ø0 046 Ø0.046 Ø0.025 [1.17] [1.17] [0.64]47 Torch 05 Torch **07** Torch





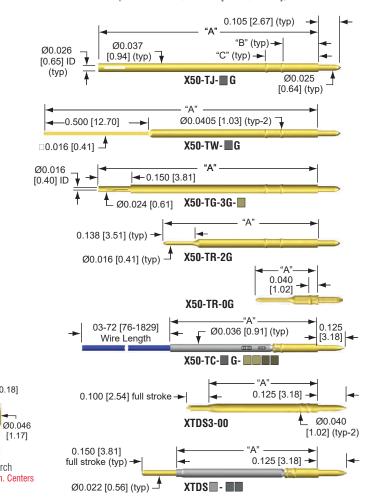


### **TOOLS & ACCESSORIES**

See pages 75-79 for order information.

### TERMINATION PIN See page 61 for order information.

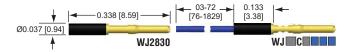
Suggested mounting holes and drill sizes in AT7000, G10/FR4 or similar materials should be gauged in probe plate at 0.0415 / 0.0430 [1.054 / 1.092]; Drill Size #57 or 1.1mm and back plate at 0.0380 / 0.0390 [0.965 / 0.990]; Drill Size 1.0mm



#### WIRE GRIP SLEEVE For use with G termination pins.



## WIRE JACK For use with J termination pins.

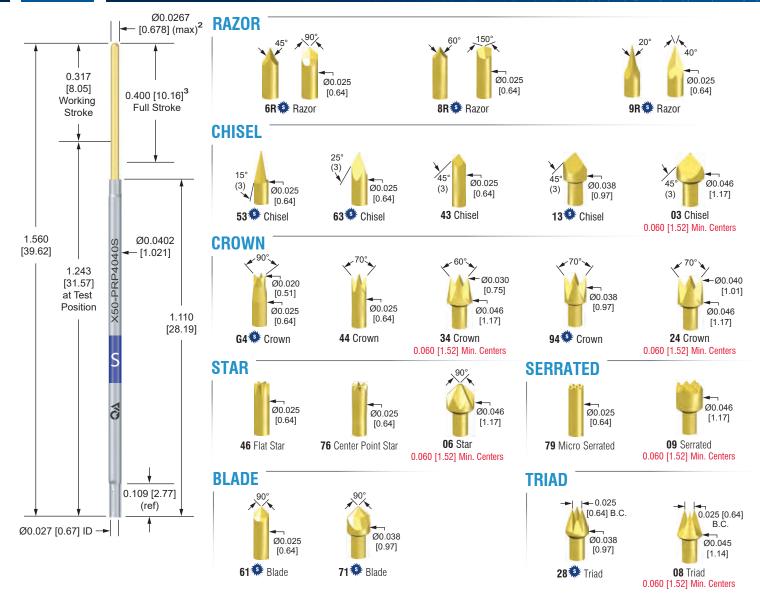




	30C3 30 AWG Kynar insulated solid wire, pre-attached, specify color and length.										
Colors Available for 28C & 30C Termination											
									Gray		
Wire	1	Brown	3	Orange	5	Green		Violet	9	White	
Wire Length Available for 28C & 30C Termination											
	Specify Length in inches: 03 – 72 [76-1829]										
E Letter Description											
Opt	Letter Description S Stripped Length 0.000/0.669 [0.00/16.99]; Customer to specify in inches									iches	

0.007 [0.18]

**17** Torch



# PROBE P/N X50-PRP40 example: X50-PRP4044S

Tube	Letter	Material/Finish	1		Average Resistance	Current Rating AMPS <sup>1</sup> 120°C (204°C) <sup>4</sup>							
_	Р	Nickel silver/II	) precious metal cla	d	< 35 m0hms	5.3 (7.8)4							
yle	Digits	Material/Finish	1										
Tip Style	See Tips	Heat treated BeCu/plated gold over nickel. (see S option for steel plungers)											
		Spring Force		@ 0.317 [8.05] Stroke		Cycle Life @ 0.317 [8.05] Stroke							
Spring	S	Standard	1.2 [34g/0.33N]	4.3 [122g/1.20N]	SS	500,000							
용	$H^3$	High	1.7 [48g/0.47N]	7.0 [198g/1.95N]	SS	300,000							
	U <sup>3</sup>	Ultra	1.3 [37g/0.36N]	9.3 [264g/2.59N]	MW	10,000							
		Description											
Option	N	No probe lubrication. Removing lubrication greatly reduces cycle life and should only be used in applications outside of the working temperature range, see Testing in Extreme Working Temperatures application note for more details. <sup>4</sup>											
0	S	# Heat treate	d steel/plated gold	over nickel (see tip style	for availability)								
	(Blank)	No option requ	iired										

<sup>&</sup>lt;sup>1</sup> Current rating is affected by spring material and lubrication choice. Please refer to Current Carrying Capacity and Testing in Extreme Working Temperature applications notes for more details.

#### SPRING FORCE STROKE (mm) 0.00 7 62 10 16 10 283 227 FORCE (gm) FORCE (oz) 170 113 0.317 [8.05] 57 0.200 0.100 0.300 0.000 0.400 STROKE (in)

#### **TOOLS & ACCESSORIES**

<sup>&</sup>lt;sup>2</sup> Maximum plunger OD should be used to calculate minimum guide plate clearance holes.

 $<sup>^{\</sup>rm 3}$  0.350 [8.89] max stroke for H & U spring.

<sup>&</sup>lt;sup>4</sup> Working Temperature Range: -55°C to 120°C with lubrication. SS springs can be used up to 204°C without lubrication.

Suggested mounting holes and drill sizes in AT7000, G10/FR4 or similar materials should be gauged in probe plate at 0.0415 / 0.0430 [1.054 / 1.092]; Drill Size #57 or 1.1mm and back plate at 0.0380 / 0.0390 [0.965 / 0.990]; Drill Size 1.0mm



# ROUND R0.013 [0.32] Ø0.025 [0.64] 40 Round



#### **WIRE GRIP SLEEVE**

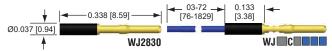
For use with G termination pins.



#### P/N: WG50

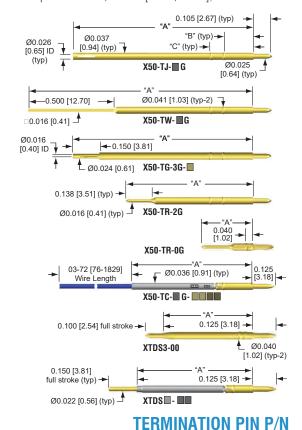
Description/Material
To accept 28AWG or 30AWG Kynar solid insulated wire, stripped at 0.120 [3.05], (not included) Nylon sleeve, white

## WIRE JACK For use with J termination pins.



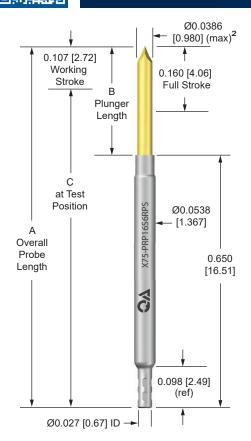
#### P/N: WJ example: WJ28C8230 2830 Wire Jack only (customer to crimp wire) brass/gold plated with nylon insulator. 28C8 28 AWG Kynar insulated solid wire, pre-attached, specify color and length. 30 AWG Kynar insulated solid wire, pre-attached, specify color and length. Yellow Gray Brown Violet White Orange Green 9 Wire Length Available for 28C & 30C Termination Specify Length in inches: 03 - 72 [76-1829]

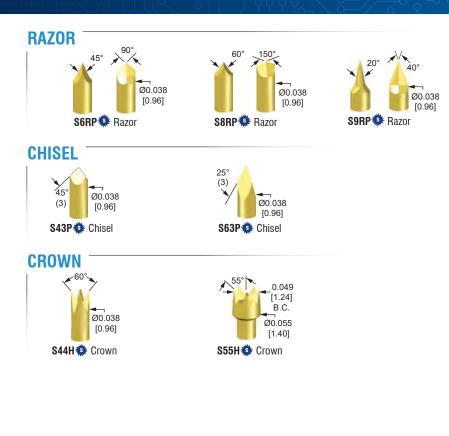
Stripped Length 0.000/0.669 [0.00/16.99]; Customer to specify in inches



**X50-T - G-** example: X50-TW-5G

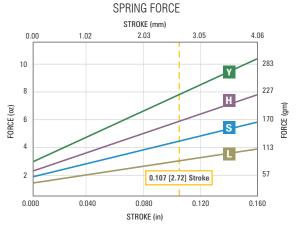
			nish									
_	С		ermination mat ial: ID precious			d Be	Cu/gold pla	ted o	over nickel.			
Termination	DS	Double-end	led for wireless	test	ing. See pa	ge 6	9 for orderin	g det	tails.			
E	G	Wire Grip. H	leat treated BeC	u/go	ld plated ove	r nic	kel, accepts	wire (	grip sleeve.			
E .	J	Wire Jack.	Heat treated Be	Cu/(	gold plated (	over	nickel, acce	pts w	vire jack.			
	R	Round post	. Heat treated E	BeCu	/gold plated	ove	r nickel.					
	W	Wire Wrap.	Heat treated Be	eCu/	gold plated	over	nickel.					
	Digits	Description		A	in (mm)		B in (mm)		C in (mm)			
	0	Only availal	ole in TC	0.6	23 [15.82]		0.149 [3.78	3]	0.100 [2.54]			
	U	Only availal	ole in TR	0.2	265 [6.73]		0.040 [1.02	2]	0.000 [0.00]			
	1	Only availal	ole in TC	0.6	83 [17.35]		0.209 [5.31	]	0.160 [4.06]			
		Only availal	ole in TJ	0.6	28 [15.95]		0.078 [1.98	3]	0.035 [0.89]			
_	2	Only availal	ole in TR	0.7	15 [18.16]		0.245 [6.22	2]	0.160 [4.06]			
Body		Only availal	ole in TW	0.8	78 [22.30]		0.078 [1.98	3]	0.035 [0.89]			
_	3	Only availal	ole in TJ or TG	1.0	15 [25.78]		0.245 [6.22	2]	0.160 [4.06]			
	5	Only availal	ole in TJ or TW	1.2	65 [32.13]		0.245 [6.22	2]	0.160 [4.06]			
	7	Only availal	ole in TW	1.7	65 [44.83]		0.245 [6.22	2]	0.160 [4.06]			
	00	Only availal	ole in DS	0.4	75 [12.07]		0.035 [0.89	9]	0.078 [1.98]			
	08	Only availal	ole in DS	0.6	.623 [15.82] 0.100 [2.54]			1]	0.149 [3.78]			
	14	Only availal	ole in DS	0.6	83 [17.35]		0.159 [4.04	1]	0.209 [5.31]			
	Digits	Available for TG Termination Only										
	3	X50-TG-3G	with WG50 wir	e gri	p sleeve							
	Digits	Wire Size A	vailable for TC	Terr	nination On	y				33		
	3	30 AWG Ky	nar insulated so	lid v	vire, pre-atta	che	d. Specify co	olor a	nd length	85,5		
S	8	28 AWG Ky	nar insulated so	lid v	vire, pre-atta	che	d. Specify co	olor a	nd length	4,8		
Options	Wire Co	olors Availab	le for TC Termi	natio	on Only					8 66		
Q	0	Black 2	Red	4	Yellow	6	Blue	8	Grey	70,3		
	1	Brown 3	Orange	5	Green	7	Violet	9	White	6,5		
	Wire Le	ength Availat	ole for TC Term	nati	on					US Patent No. 6,570,399 & 4,885,533		
	Sr	ecify Length	in inches: 03	- 72	[76-1829]					aten		
	—(Bla	ınk) No optio	on required		. ,					US P		





## PROBE P/N X75-PRP16 example: X75-PRP16S63PS

Tube	Letter	Material/Finish			Average Resistance	Current Rating AMPS <sup>1</sup> 120°C (204°C) <sup>3</sup>
_	Р	Nickel silver/ID	precious metal o	lad	< 26 m0hms	6.9 (9.5)3
rial	Letter	Material/Finish				
Tip Material	В	Heat treated Be	:Cu/gold plated o	ver nickel		
음	S	Heat treate	d steel/gold plate	d over nickel		
yle	Digits	Description				
Tip Style	See Tips	Tip style geom	etry based on targ	et type		
gth	Letter	Tip Style Availa	ability Over	all Probe Length (A)	Plunger Length (B)	@ Test Position (C)
Plunger Length	Н	09, 44, 55		0.870 [22.10]	0.220 [5.59]	0.763 [19.38]
Plung	Р	43, 51, 63, 6R	8R, 9R	0.930 [23.62]	0.280 [7.11]	0.823 [20.90]
	Letter	Spring Force	Preload	@ 0.107 [2.72] Strol	ke Material	Cycle Life @ 0.107 [2.72] Stroke
5	L	Low	1.3 [37g/0.36N	I] 3.0 [85g/0.83N]	SS	300,000
Spring	S	Standard	1.9 [54g/0.53N	l] 4.5 [128g/1.25N]	SS	300,000
S	Н	High	2.3 [65g/0.64N	l] 6.0 [170g/1.67N]	SS	300,000
	Υ	Elevated	3.0 [85g/0.83N	l] 8.0 [227g/2.22N]	SS	100,000
		Description				
Option	N					uld only be used in applications operatures application note for
	(Blank)	No option requ	ired			



# <sup>1</sup> Current rating is affected by spring material and lubrication choice. Please refer to Current Carrying Capacity and Testing in Extreme Working Temperature applications notes for more details.

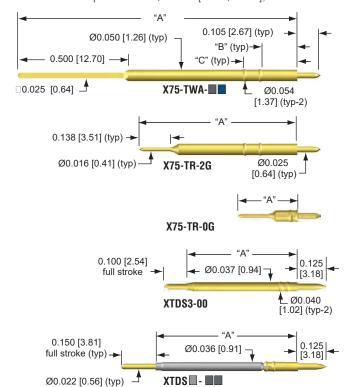
#### **TOOLS & ACCESSORIES**

<sup>&</sup>lt;sup>2</sup> Maximum plunger OD should be used to calculate minimum guide plate clearance holes.

<sup>&</sup>lt;sup>3</sup> Working Temperature Range: -45°C to 120°C with lubrication. SS springs can be used up to 204°C without lubrication.

#### TERMINATION PIN

Suggested mounting holes and drill sizes in AT7000, G10/FR4 or similar materials should be gauged in probe plate at 0.0545 / 0.0560 [1.384 / 1.422]; Drill Size #54 or 1.40mm and wired back plate at 0.0515 / 0.0525 [1.308 / 1.333]; Drill Size #55 or 1.35mm or wireless back plate at 0.0380 / 0.0390 [0.965 / 0.990]; Drill Size 1.0mm



# **SERRATED**

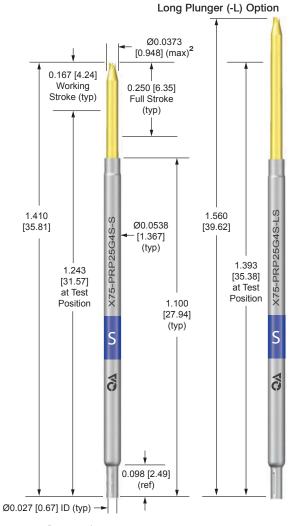


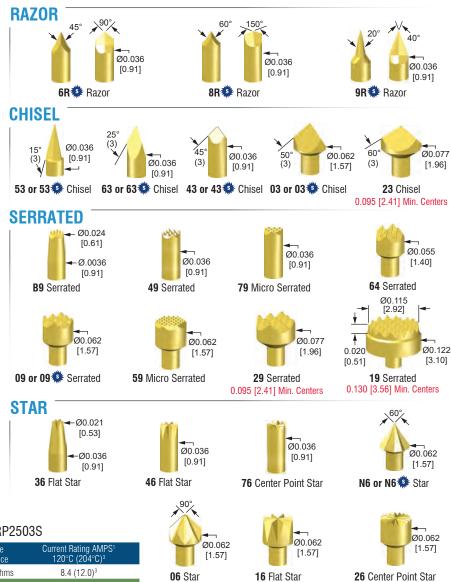
**BLADE** Ø0.062 [1.57] S51P Blade

## **TERMINATION PIN P/N**

X75-T - example: X75-TWA-2G

=								
Termination	DS3	Double-Ended for wireless testing. See page 69 for ordering details.						
Ē	R	Round Post. Heat treated BeCu or phos bronze/gold plated over nickel.						
Ĭ,	WA	Wire Wrap. Heat treated E	BeCu or copper allo	y/gold or silver pla	ted over nickel.			
	Digits	Description	A in (mm)	B in (mm)	C in (mm)			
	0	Only available in TR	0.271 [6.88]	0.039 [0.99]	0.000 [0.00]			
	2	Only available in TWA	0.878 [22.30]	0.079 [2.00]	0.034 [0.86]			
_		Only available in TR	0.715 [18.16]	0.245 [6.22]	0.160 [4.06]			
Body	5	Only available in TWA	1.265 [32.13]	0.245 [6.22]	0.160 [4.06]			
_	7	Only available in TW	1.765 [44.83]	0.245 [6.22]	0.160 [4.06]			
	00	Only available in DS	0.475 [12.07]	0.035 [0.89]	0.078 [1.98]			
	80	Only available in DS	0.623 [15.82]	0.100 [2.54]	0.149 [3.78]			
	14	Only available in DS	0.683 [17.34]	0.159 [4.04]	0.209 [5.31]			
9	Letter	Material						
Plating	G	Gold plated over nickel.						
_	S	Silver plated over nickel.	1					
		NOTES: ① Only Available TWA-5						





## PROBE P/N X75-PRP25 example: X75-PRP2503S

Tube	Letter	Material/Finish			Average Resistance	Current Rating AMPS <sup>1</sup> 120°C (204°C) <sup>3</sup>
_	Р	Nickel silver/ID	precious metal clad		< 25 m0hms	8.4 (12.0) <sup>3</sup>
yle	Digits	Material/Finish				
Tip Style	See Tips	Standard mater	rial is heat treated Be0	Cu/plated gold over nicke	el. (see S option t	for steel plungers)
		Spring Force		@ 0.167 [4.24] Stroke		Cycle Life @ 0.167 [4.24] Stroke
	L	Low	1.3 [37g/0.36N]	3.5 [99g/0.97N]	SS	1,000,000
	S	Standard	1.6 [45g/0.44N]	5.5 [156g/1.53N]	MW	1,000,000
	Н	High	2.8 [79g/0.78N]	6.5 [184g/1.81N]	SS	1,000,000
Spring	Υ	Elevated	2.3 [65g/0.64N]	8.1 [230g/2.25N]	MW	1,000,000
ջ	Χ	Extra	3.6 [102g/1.00N]	10.8 [306g/3.00N]	MW	1,000,000
	U	Ultra	3.3 [94g/0.92N]	17.1 [485g/4.75N]	MW	100,000
		High Preload S	pring – <i>Only available</i>	e with headless 🥵 steel t	ip styles	
	Е	High Preload	6.0 [170g/1.67N]	8.0 [227g/2.22N]	SS	1,000,000
	F	High Preload	7.6 [215g/2.12N]	11.0 [312g/3.06N]	SS	300,000
	Letter	Description				
	L	Long plunger.	Must select from 039	-40 tip styles		
Option	N					uld only be used in applications nperatures application note for
	S	# Heat treate	d steel/plated gold ov	ver nickel (see tip style fo	r availability)	
	(Blank)	No option requ	ired			

<sup>1</sup> Current rating is affected by spring material and lubrication choice. Please refer to Current Carrying Capacity and Testing in Extreme Working Temperature applications notes for more details.

# **TOOLS & ACCESSORIES**

0.050

24

20

16

12

0.000

FORCE (oz)

See pages 75-79 for order information.

SPRING FORCE STROKE (mm)

3.81

0.150

STROKE (in)

0.167 [4.24] Stroke

5.08

0.200

6.35 = 680

567

454

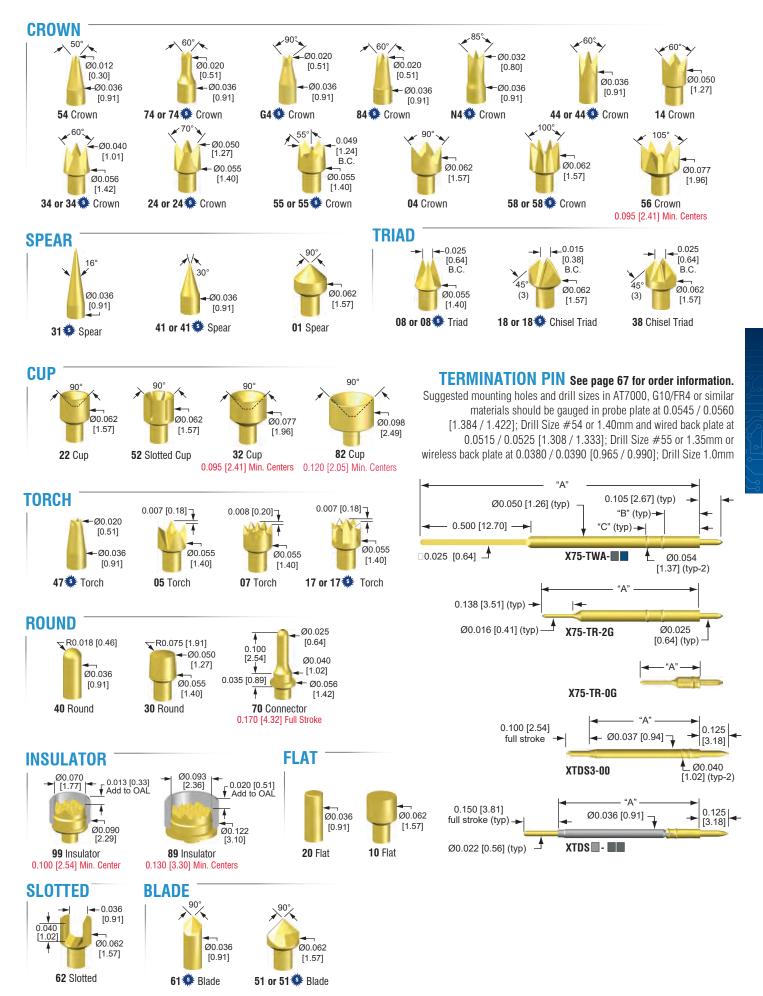
227 113

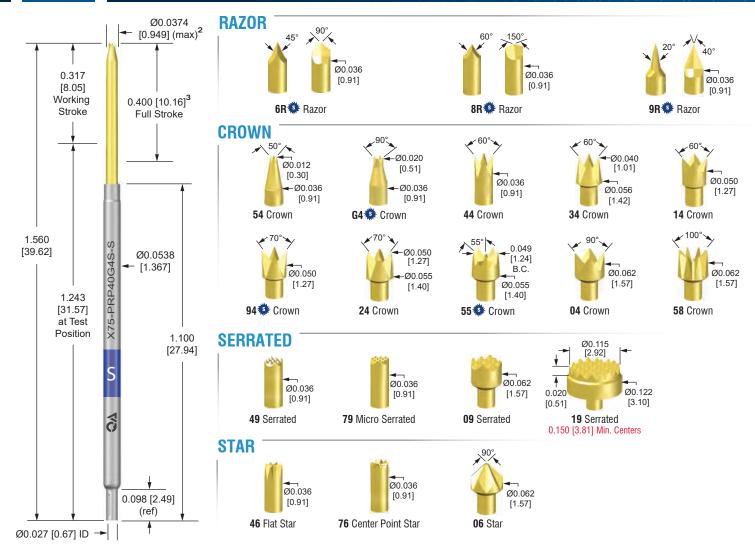
0.250

FORCE (gm 340

<sup>&</sup>lt;sup>2</sup> Maximum plunger OD should be used to calculate minimum guide plate clearance holes.

<sup>&</sup>lt;sup>3</sup> Working Temperature Range: -55°C to 120°C with lubrication. SS springs can be used up to 204°C without lubrication.

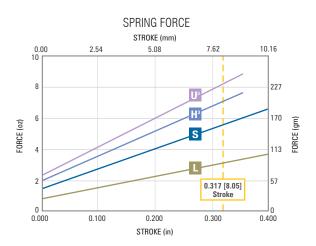




## PROBE P/N X75-PRP40 example: X75-PRP4003L

Tube	Letter	Material/Finish	ı		Average Resistance	Current Rating AMPS <sup>1</sup> 120°C (204°C) <sup>4</sup>		
-	Р	Nickel silver/I	) precious metal cla	d	< 20  mOhms	7.9 (11.3)4		
yle	Digits	Material/Finish	1					
Tip Style	See Tips	Heat treated B	eCu/plated gold ove	r nickel. (see S option fo	or steel plungers	)		
		Spring Force	Preload	@ 0.317 [8.05] Stroke	Material	Cycle Life @ 0.317 [8.05] Stroke		
5	L	Low	0.8 [23g/0.22N]	3.0 [85g/0.83N]	MW	1,000,000		
Spring	S	Standard	1.5 [43g/0.42N]	5.7 [162g/1.58N]	SS	500,000		
S	$H^3$	High	2.0 [57g/0.56N]	7.0 [198g/1.95N]	SS	300,000		
	$I_3$	Ultra	2.5 [71g/0.70N]	8.1 [230g/2.25N]	MW	10,000		
		Description						
Option .	N	No probe lubrication. Removing lubrication greatly reduces cycle life and should only be used in applications outside of the working temperature range, see Testing in Extreme Working Temperatures application note for more details. <sup>4</sup>						
0	S	Heat treate	d steel/plated gold	over nickel (see tip style	for availability)			
	(Blank)	No option requ	iired					

<sup>&</sup>lt;sup>1</sup> Current rating is affected by spring material and lubrication choice. Please refer to Current Carrying Capacity and Testing in Extreme Working Temperature applications notes for more details.



#### **TOOLS & ACCESSORIES**

<sup>&</sup>lt;sup>2</sup> Maximum plunger OD should be used to calculate minimum guide plate clearance holes.

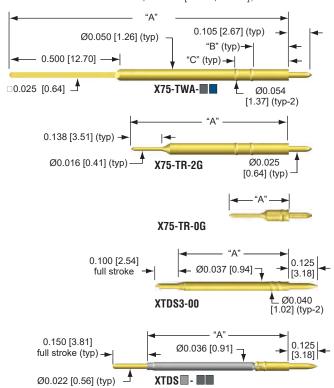
 $<sup>^{\</sup>rm 3}$  0.350 [8.89] max stroke for H & U spring.

<sup>&</sup>lt;sup>4</sup> Working Temperature Range: -55°C to 120°C with lubrication. SS springs can be used up to 204°C without lubrication.

#### **CHISEL** (3) Ø0.036 (3) 45° Ø0.036 [0.91] Ø0.036 (3) [0.91] [0.91] 53 or 53 Chisel 63 Chisel 43 Chisel Ø0.077 Ø0.050 [1.27] Ø0.062 [1.96] 13 Chisel 03 Chisel 23 Chisel 0.095 [2.41] Min. Centers **ROUND** Ø0.025 [0.64] R0.075 [1.91] **¬** R0.018 [0.46] 0.100 -Ø0.050 [2.54] Ø0.040 [1.27] <sub>--</sub> [1.02] Ø0.036 0.035 [0.89] Ø0.055 [0.91] **-** Ø0.056 [1.40] [1.42] 40 Round 30 Round 70 Connector 0.325 [8.26] Full Stroke **BLADE** 909 Ø0.036 Ø0.050 [0.91] [1.27] 61 Blade 71 Blade **TRIAD** 0.025 0.015 [0.64] [0.38] B.C. B.C. Ø0.062 Ø0.055 (3) [1.57] [1.40] 08 Triad 18 Chisel Triad **TORCH** 0.008 [0.20] 0.007 [0.18] Ø0.055 Ø0.055 [1.40] [1.40] 05 Torch 07 Torch **FLAT** Ø0.062 Ø0.036 [1.57] [0.91] 20 Flat **10** Flat **CUP SPEAR** Ø0.062 [1.57] Ø0.036 [0.91] **22** Cup 41 Spear

#### TERMINATION PIN

Suggested mounting holes and drill sizes in AT7000, G10/FR4 or similar materials should be gauged in probe plate at 0.0545 / 0.0560 [1.384 / 1.422]; Drill Size #54 or 1.40mm and wired back plate at 0.0515 / 0.0525 [1.308 / 1.333]; Drill Size #55 or 1.35mm or wireless back plate at 0.0380 / 0.0390 [0.965 / 0.990]; Drill Size 1.0mm



## **TERMINATION PIN P/N**

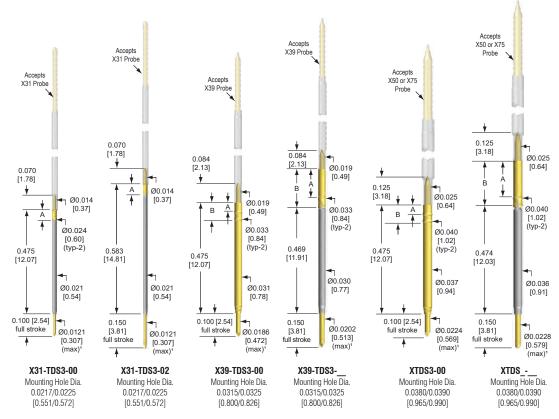
**X75-T** example: X75-TWA-5G

no	Letter	Material						
natii	DS	Double-Ended for wireless testing. See page 69 for ordering details.						
ermination	R	Round Post. Heat treated	BeCu/gold plated of	over nickel.				
Ę.	WA	Wire Wrap. Heat treated E	BeCu. See plating o	ptions.				
	Digits	Description	A in (mm)	B in (mm)	C in (mm)			
	0	Only available in TR	0.271 [6.88]	0.039 [0.99]	0.000 [0.00]			
	2	Only available in TWA	0.878 [22.30]	0.079 [2.00]	0.034 [0.86]			
		Only available in TR	0.715 [18.16]	0.245 [6.22]	0.160 [4.06]			
Body	5	Only available in TWA	1.265 [32.13]	0.245 [6.22]	0.160 [4.06]			
_	7	Only available in TW	1.765 [44.83]	0.245 [6.22]	0.160 [4.06]			
	00	Only available in DS	0.475 [12.07]	0.035 [0.89]	0.078 [1.98]			
	08	Only available in DS	0.623 [15.82]	0.100 [2.54]	0.149 [3.78]			
	14	Only available in DS	0.683 [17.34]	0.159 [4.04]	0.209 [5.31]			
g d	Letter	Material						
Plating	G	Gold plated over nickel.						
а.	S	Silver plated over nickel.	①					
		NOTES: ① Only Available TWA-5 US Patent No. 6.570.399 & 4.885.53						



# **Wireless Termination Pin**

Wireless termination pins allow construction of X Probe socketless fixtures with far shorter signal path lengths than conventional wire wrap designs. The shorter path length allows better control of the signal from the tester circuits to the Unit Under Test (UUT). Note: Top test probe is not included with the wireless termination. (See applicable product series for ordering information).



#### INTERFACE PROBE TIP STYLES





3 Chisel

#### INTERFACE PROBE SPECIFICATIONS

Working Stroke: Up to 0.100 [2.54]/0.075 [1.91] all - 00

Working Temperature Range: Up to 204°C

**Spring Force:** 

Series	Preload	@ 0.100 [2.54] Stroke	Material	Cycle Life @ 0.100 [2.54] Stroke
X31-00	1.0 [28g/0.28N]	3.8 [108g/1.04N]	SS	10,000*
X31-02	1.0 [28g/0.28N]	3.8 [108g/1.04N]	SS	10,000
X39-00	1.0 [28g/0.28N]	4.5 [128g/1.25N]	SS	25,000
X39-04/10	1.0 [28g/0.28N]	4.3 [122g/1.18N]	SS	25,000
XTD-00	1.0 [28g/0.28N]	4.5 [128g/1.25N]	SS	10,000
XTD-08/14	0.8 [23g/0.23N]	3.8 [108g/1.04N]	SS	100,000

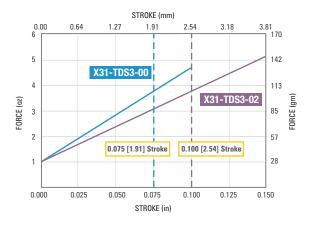
Working stroke @ 0.075 [1.91]

## **P/N: X31-TDS3-** example: X31-TDS3-02

,		•	
yle	Digit	Description	
Tip Style	3	Chisel. Heat treated BeCu/gold plated ov	ver nickel
Height	Digit	Tube Material	A in(mm)
Hei	00	Nickel silver/ID precious metal clad	0.048 [1.22]
Set	02	Nickel silver/ID precious metal clad	0.048 [1.22]

<sup>&</sup>lt;sup>1</sup> Maximum plunger OD should be used to calculate minimum guide plate clearance holes

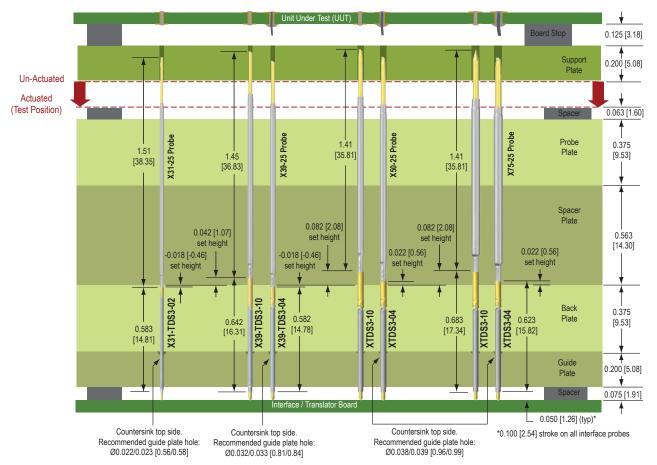
US Patent No. 6,570,399 & 4,885,533



#### **TOOLS & ACCESSORIES**



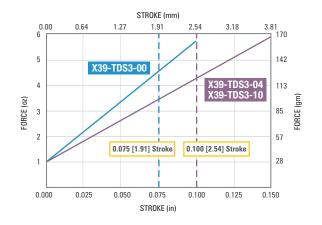
#### SUGGESTED MOUNTING FIXTURE



## **P/N: X39-TDS3-** example: X39-TDS3-04

Style	Digit	Description				
Tip St	3	Chisel. Heat treated BeCu/gold plated over nickel				
_	Digit	Tube Material	A in(mm)	B in(mm)		
Height	00	Heat treated BeCu/gold plated over nickel	0.036 [0.92]	0.077 [1.95]		
Set H	04	Nickel silver/ID precious metal clad	0.065 [1.65]	0.113 [2.87]		
	10	Nickel silver/ID precious metal clad	0.125 [3.18]	0.173 [4.39]		

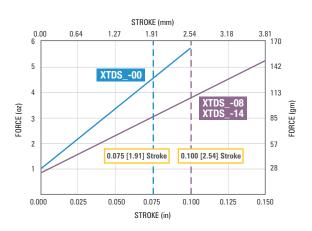
<sup>&</sup>lt;sup>1</sup> Maximum plunger OD should be used to calculate minimum guide plate clearance holes.



# P/N: XTDS - example: XTDS3-08

-, 111 211 2 2 2 2 3 1 1 1 1 1 1 1 1 1 1 1							
Digit	Description						
0	Spherical. Heat treated BeCu/gold plated over nickel						
3	Chisel. Heat treated BeCu/gold plated over nickel						
Digit	Tube Material	A in(mm)	B in(mm)				
00	Heat treated BeCu/gold plated over nickel	0.035 [0.89]	0.078 [1.98]				
80	Nickel silver/ID precious metal clad	0.100 [2.54]	0.149 [3.78]				
14	Nickel silver/ID precious metal clad	0.159 [4.04]	0.209 [5.31]				
	Digit 0 3 Digit 00 08	Digit Description  O Spherical. Heat treated BeCu/gold plated over a Chisel. Heat treated BeCu/gold plated over a Tube Material  O Heat treated BeCu/gold plated over nickel  Nickel silver/ID precious metal clad	Digit Description  O Spherical. Heat treated BeCu/gold plated over nickel  3 Chisel. Heat treated BeCu/gold plated over nickel  Digit Tube Material A in(mm)  00 Heat treated BeCu/gold plated over nickel  0.035 [0.89]  Nickel silver/ID precious metal clad 0.100 [2.54]				

<sup>&</sup>lt;sup>1</sup> Maximum plunger OD should be used to calculate minimum guide plate clearance holes.





# **Tester Interface Probes**

**KEYSIGHT/AGILENT** KEYSIGHT/AGILENT KEYSIGHT/AGILENT **KEYSIGHT/AGILENT** 100-SDN253 100-PRP2519L 100-PRP2562L 100-PRP4070L Ø0.025 [0.64] -Ø0.040 [1.02] Ø0.056 [1.42] 0.036 [0.91] 0.139 [3.53] (typ) Ø0.115 [2.92]-0.317 Ø0.062 [1.57] -0.060 [1.52] 0.040 [1.02] 0.079 [2.01] (typ) [8.05] Working Ø0.122 [3.10]-0.325 [8.26] 0.039 [0.99] (typ) Full Stroke 0.480 Ø0.074 [1.88] 0.167 [4.24] 0.167 [4.24] [12.19] (typ) Stop Ring Working Working 0.330 Top of 0.330 Stroke 0.250 [6.35] [8.38] [8.38] 0.250 [6.35] Full Stroke Top of Top of Ø0.070 Full Stroke Socket Socket 0.163 [4.14] 0.163 [4.14] 0.163 [4.14] [1.78] (typ) at Test Position at Test Position at Test 00-SDN253R5-H Position 100-SDN253W3-H 1.080 [27.43] (typ) Socket Socket 1.460 [37.08] (sold separately) Socket (sold separately) (sold separately) 1.310 [33.27] 1.310 Ø0.0538 Ø0.0538 Ø0 0538 0.164 [1.367] [1.367] 1.000 [1.367] □0.025 [25,40] [4.17] 1.000 Ø0.025 [25.40] [0.63][25.40] [0.63] 0 00 ó 0.947 [24.05]

Interface Probes are used in testers for electromechanical contact between the fixture and tester. QA Technology has listed the part numbers that correspond with the applicable testers. These part numbers are QA's recommended direct replacements.

KEYSIGHT/AGILENT	QA PROBE/SOCKET PART NUMBER
All 3070 ICT Testers	100-PRP2519L/100-SDN253R5-H
Polarity Check	100-PRP2562L/100-SDN253W3-H
Test Jet	100-PRP4070L/100-SDN253W3-H

#### P/N: 100-PRP2519L

Tube	Letter	Material/Finis	h		Average Resistance	Current Rating AMPS <sup>1</sup> 120°C (204°C)		
-	Р	Nickel silver/l	D precious metal c	< 15 m0hms	11.8 (16.2)			
Style	Digit	Material/Finish						
Tip St	19	Heat treated E	Heat treated BeCu/gold plated over nickel					
Spring	Letter	Spring Force	Preload	@ 0.167 [4.24] Stroke	Material	Cycle Life @ 0.167 [4.24] Stroke		
S	L	Low	1.3 [37g/0.36N]	3.5 [99g/0.97N]	SS	1,000,000		

### P/N: 100-PRP2562L

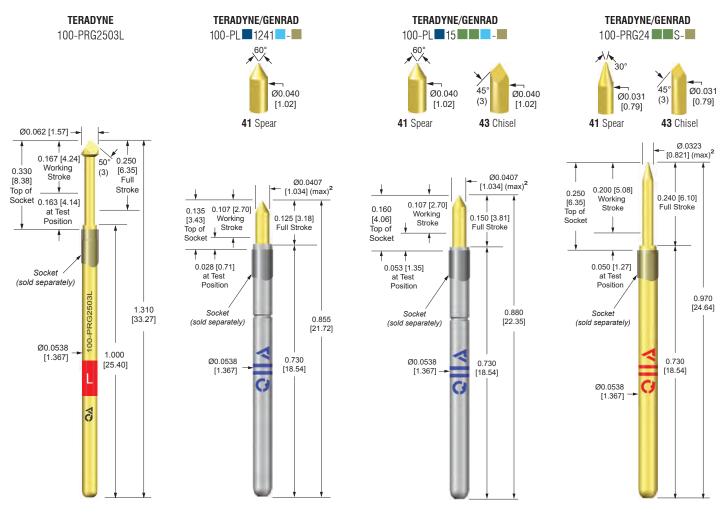
Tube	Letter	Material/Finis	h		Average Resistance	Current Rating AMPS <sup>1</sup> 120°C (204°C)
-	Р	Nickel silver/l	D precious metal o	< 15 m0hms	11.8 (16.2)	
Style	Digit	Material/Finis				
Tip St	62	Heat treated E	BeCu/gold plated or	ver nickel		
Spring		Spring Force		@ 0.167 [4.24] Stroke		Cycle Life @ 0.167 [4.24]Stroke
S	L	Low	1.3 [37g/0.36N]	3.5 [99g/0.97N]	SS	1,000,000

#### P/N: 100-PRP4070L

Tube	Letter	Material/Finis	h		Average Resistance	Current Rating AMPS <sup>1</sup> 120°C (204°C)
-	Р	Nickel silver/ID precious metal clad			< 20 m0hms	10.2 (14.3)
le /	Digit	Material/Finis				
Tip Style	70	Heat treated E	BeCu/gold plated over	er nickel		
Spring		Spring Force		@ 0.317 [8.05] Stroke		Cycle Life @ 0.317 [8.05] Stroke
S	L	Low	0.8 [23g/0.22N]	3.0 [85g/0.83N]	MW	1,000,000

#### P/N: 100-PRG2503L

Tube	Letter	Material/Finish			Average Resistance	Current Rating AMPS <sup>1</sup> 120°C (204°C)
_	G	Nickel silver/OD gold plated			< 15 m0hms	12.3 (17.3)
Tip Style	Digit	Material/Finish				
	03	Heat treated BeCu/gold plated over nickel				
Spring		Spring Force		@ 0.167 [4.24] Stroke		Cycle Life @ 0.167 [4.24]Stroke
S	L	Low	1.3 [37g/0.36N]	3.5 [99g/0.97N]	SS	1,000,000



TERADYNE/GENRAD	QA PART NUMBER
1800 Series 7878, 8852, 8855	100-PRG2503L See page 29 for sockets
2270, 2271, 2272, 2282 (any model), 2283, 2284, 2286, 2287 built before 7/95	100-PLP1241S and/or 100-PLP1241S-B See page 29 for sockets
TS121, TS124, TS128, TS81, TS84, TS86, TS87, 2280, 2281, 2281a, 2287a 228x ICA (any model), 2283, 2284, 2286, 2287 built after 7/95	100-PLP1541S and/or 100-PLP1541S-B See page 29 for sockets
2287L, 2287LX, TS87L, TS87LX, TS128L, TS124LX, TSLH, TSLX, TSH52, TSH51, TSMS, TSA, Tester model numbers ending in "L" (high density capacity	100-PRG2441S and/or 100-PLP1541S See page 29 for sockets

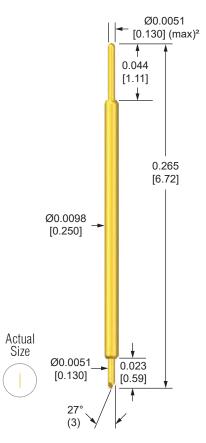
					P/N:	100-PL 1241 -	100-PL 15	100-PRG24 S-
	Letter	Material/Finish					Average Resistance	
Tube	Р	Nickel silver/ID	precious metal clad			< 20 m0hms	< 20 m0hms	NA
2	G	Nickel silver/OI	gold plated			< 25 m0hms	< 25 m0hms	< 15 m0hms
	N	Nickel silver/no	finish			< 45 m0hms	< 45 m0hms	NA
Style	Digits	Material/Finish						
p St	41	Heat treated Be	Cu/gold plated over n	ickel, spear		41	41	41
i⊒	43	Heat treated Be	Cu/gold plated over n	ickel, chisel		NA	43	43
	Letter	Spring Force	Preload	@ 0.107 [2.70] Stroke	Material	Cycle Life @ 0.107 [2.72] Stroke	Cycle Life @ 0.107 [2.72] Stroke	Cycle Life @ 0.200 [5.08] Stroke
	L	Low	0.7 [20g/0.19N]	1.5 [43g/0.42N]	SS	1,000,000	1,000,000	NA
	S	Standard	1.7 [48g/0.47N]	3.5 [99g/0.97N]	SS	1,000,000	1,000,000	NA
Spring	S	Standard	1.8 [51g/0.50N]	3.5 [99g/0.97N]	SS	NA	NA	1,000,000
ջ	Н	High	2.2 [62g/0.61N]	5.5 [156g/1.53N]	MW	1,000,000	1,000,000	NA
	Χ	Extra	3.0 [85g/0.83N]	8.0 [227g/2.22N]	MW	1,000,000	1,000,000	NA
	U	Ultra	4.5 [128g/1.25N]	10.0 [283g/2.78N]	MW	250,000	250,000	NA
	В	High Preload	2.0 [57g/0.56N]	2.6 [74g/0.72N]	SS	NA	NA	1,000,000
		Description						
Option	В	Curved tube (p	/lon replacement)					
op	N	No probe lubrio	ation. Removing lubri	cation greatly reduces cycle li	ife and should onl	y be used in applications outside of th	ne working temperature range	
	(Blank)	No option requi	red					

Working Temperature Range: -55°C to 120°C with lubrication. SS springs can be used up to 204°C without lubrication.

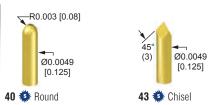
<sup>1</sup> Current rating is affected by spring material an lubrication choice. Please refer to Current Carrying Capacity and Testing in Extreme Working Temperature applications notes for more details.

<sup>&</sup>lt;sup>2</sup> Maximum plunger OD should be used to calculate minimum guide plate clearance holes.

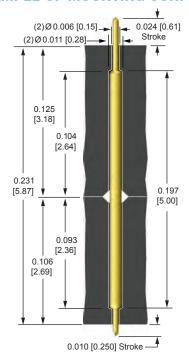




#### TIP STYLES FOR DUT SIDE ONLY



#### **EXAMPLE OF MOUNTING CONFIGURATION**

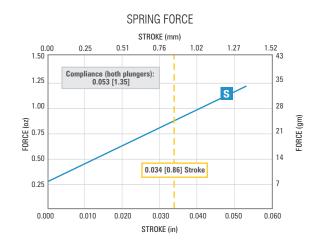


Actual stroke and plate thicknesses may vary based on application.

### PROBE P/N M035PRH14 S-S example: M035PRH1443S-S

Tube	Letter	Material/Finisl	h		Average Resistance	Current Rating AMPS <sup>1</sup> 120°C (204°C) <sup>3</sup>				
_	Н	Phosphor Broi	nze/precious metal ID	)/OD	< 200 m0hms	1.6 (2.2) <sup>3</sup>				
Style	Digits	Material/Finisl	า							
Tip St	See Tips	Heat treated st	teel/gold plated over	nickel						
ring		Spring Force	Preload	@ 0.86mm Stroke	Material	Cycle Life @ 0.86mm Stroke				
Sp	S	Standard	0.28 [7.8g/0.08N]	0.88 [25.0g/0.25N]	MW	100,000				
Option		Description								
opt	S	★ Heat treated steel/plated gold over nickel (see tip style for availability)								

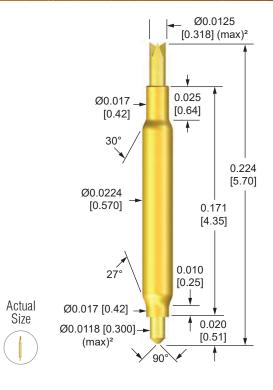
<sup>&</sup>lt;sup>1</sup> Current rating is affected by spring material and lubrication choice. Please refer to Current Carrying Capacity and Testing in Extreme Working Temperature applications notes for more details.



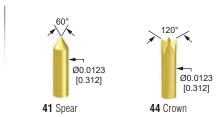
<sup>&</sup>lt;sup>2</sup> Maximum plunger OD should be used to calculate minimum guide plate clearance holes.

<sup>&</sup>lt;sup>3</sup> Working Temperature Range: up to 120°C with lubrication. SS springs can be used up to 204°C without lubrication.

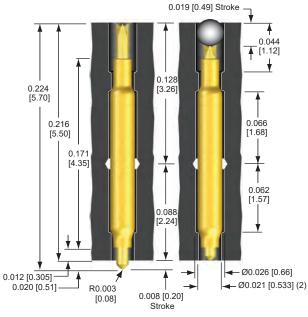




### TIP STYLE FOR DUT SIDE ONLY



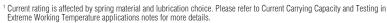
### **EXAMPLE OF MOUNTING CONFIGURATION**



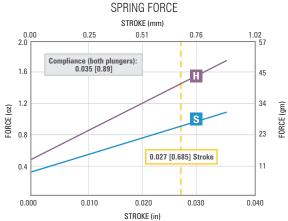
Actual stroke and plate thickness may vary based on application.

## PROBE P/N M08-PRG89 example: M08-PRG8941S

Tube	Letter	Material/Finis	h		Average Resistance	Current Rating AMPS <sup>1</sup> 120°C (204°C) <sup>3</sup>
_	G	Copper alloy/	gold plated		< 40 m0hms	4.4 (6.1) <sup>3</sup>
Style	Digits	Material/Finis				
Tip St	See Tips	Heat treated E	BeCu/gold plated over	nickel		
6	Letter	Spring Force	Preload	@ 0.027 [0.69] Stroke	Material	Cycle Life @ 0.027 [0.69] Stroke
Spring	S	Standard	0.32 [9.1g/0.09N]	0.95 [26.9g/0.26N]	SS	1,000,000
	Н	High	0.49 [13.9g/0.14N]	1.48 [42.0g/0.41N]	SS	1,000,000
_		9	5.15 [.5.0g/0.1111]		30	.,550,000



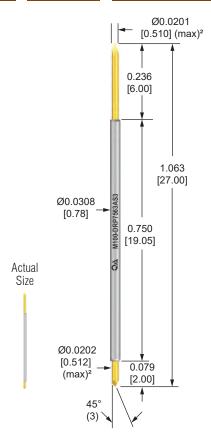
<sup>2</sup> Maximum plunger OD should be used to calculate minimum guide plate clearance holes.



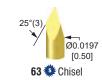
<sup>&</sup>lt;sup>3</sup> Working Temperature Range: up to 120°C with lubrication. SS springs can be used up to 204°C without lubrication.



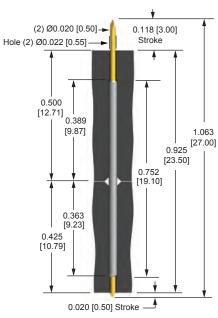




#### TIP STYLES FOR DUT SIDE ONLY



### **EXAMPLE OF MOUNTING CONFIGURATION**



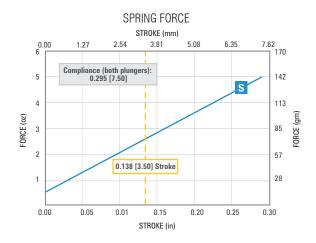
Actual stroke and plate thicknesses may vary based on application.

### PROBE P/N M100-DRP7563AS3

Tube	Letter	Material/Finish	ı	Average Resistance	Current Rating AMPS <sup>1</sup> 120°C (204°C) <sup>3</sup>	
_	Р	Nickel silver/II	D precious metal clad		< 65 m0hms	3.4 (4.7) <sup>3</sup>
Style	Digits	Material/Finish	1			
Tip St	See Tips	Heat treated st	eel/gold plated over nick	rel		
Spring	Letter	Spring Force	Preload	@ 0.86mm Stroke	Material	Cycle Life @ 0.86 mm Stroke
Spr	S	Standard	0.58 [16.38g/0.16N]	2.65 [75.0g/0.74N]	SS	100,000
ī.		Description				
E.	3	Heat treated B	eCu/plated gold over nic	kel		

<sup>&</sup>lt;sup>1</sup> Current rating is affected by spring material and lubrication choice. Please refer to Current Carrying Capacity and Testing in Extreme Working Temperature applications notes for more details.

<sup>&</sup>lt;sup>3</sup> Working Temperature Range: -45°C to 120°C with lubrication. SS springs can be used up to 204°C without lubrication.



<sup>&</sup>lt;sup>2</sup> Maximum plunger OD should be used to calculate minimum guide plate clearance holes.



Socketless

### **Pin Gauge Tools**

PG Pin Gauge Tools for simple Go/No-Go inspection of socket and termination pin mounting holes are available for each series.

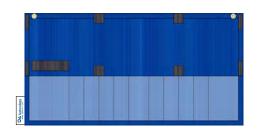


PRODUCT SERIES	PG TOOL PART NUMBER
025-16	PG25
039-16 039-25 039-40	PG39
050-05 050-16	PG050-05/16
050-25 050-40	PG050-25
075-25 075-40	PG75
100-05 100-16 100-25 100-40	PG100
125-25	PG125
156-25	PG156
187-25	PG187

PRODUCT SERIES	PG TOOL PART NUMBER BACK PLATE	PG TOOL PART NUMBER PROBE PLATE
X31-16 X31-25 X31-40	PG-X31-T	PG-X31-P
X39-16 X39-25 X39-40	PG-X39	PG-X39
X50-16 X50-25 X50-40	PG-X50-T	PG-X50-P
X75-16 X75-25 X75-40	PG-X75A-T	PG-X75A-P

### **Tool Organizer**

The TRL-1 is a compact canvas tool roll to organize a variety of maintenance tools to be accessible at your fingertips (tools are sold separately).



#### **Probe Maintenance Brush**

The **TBR-1** is made from a natural bristle to easily clean away fluxes and debris from your probe tips as part of your regular scheduled maintenance program.

#### **Installation Hammer**

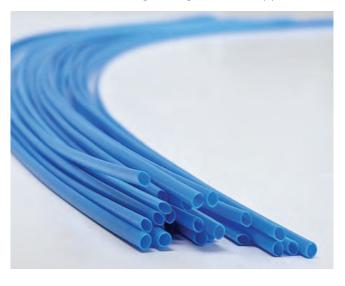


The **THM-1** hammer is to be used in conjunction with our installation and extraction tools.



### **Insulated Tubing (Heat Shrinkable)**

For insulating wire wrap and wire jack sockets and termination pins on 0.050 centers and smaller. Available in 24 [6.10] lengths with 0.046 [1.17] ID, this blue tubing is stiffer than other types, making installation easier. Customer to cut tubing in lengths to suit applications.



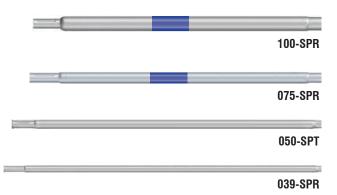
### **Fixture Training Kit**

Efficiently installing and removing probes, sockets or termination pins for regularly scheduled maintenance or in emergency situations is a skill that takes time and experience. Attempting to learn while using existing production fixtures could result in catastrophic errors and costs if the process is carried out incorrectly. QA's **FTK-1** Fixture Training Kit will help you tackle this challenge. Used in conjunction with our instructional videos, the fixture enables you to effectively train new and existing technicians, without disrupting the production schedule.



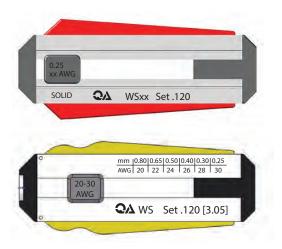
### **Socket Plugs**

QA Technology's Socket Plugs are a quick and easy solution to block a conventional socket where a test point is no longer needed. This eliminates the potential error of re-installing a probe which could result in a test error or board damage.



### **Wire Strippers**

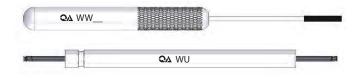
WS30 or WS28 Wire Strippers are used to strip 28 or 30 AWG. **WS** tool has a built-in adjustment dial to accommodate various wire sizes from 20-30 AWG. All are preset to strip a length of 0.120 [3.05] for use with wire plugs, jacks or grips.



### **Wire Wrap Tools**

Wire wrapping is the most common wiring method for the larger center spacing sockets and termination pins. For the PCB professional who needs tools for low volume production, maintenance and field repair, QA now offers high quality hand wire wrap tools that are available for 26, 28, or 30 AWG wire sizes.

These tools form modified wraps on standard 0.025 [0.635] square or round pins. Additionally, the P option can wrap pins up to 1.100 [27.94] long. Our unwrap tools are double-ended to facilitate easy removal of both clockwise and counterclockwise wire wraps and are compatible with both the standard and long pin versions.



	WIRE WRAP TOOL PART NUMBER						
WIRE SIZE	STANDARD LENGTH (0.750" [19.1mm] Hole depth)	LONG PIN OPTION (1.100" [27.9mm] Hole depth)					
26 AWG	WW26	WW26P					
28 AWG	WW28	WW28P					
30 AWG	WW30	WW30P					
Unwrap	W	ľU					

### **Installation Tools**

The ATR Adjustable Installation Tools allow insertion of conventional sockets at varying set heights in inches (millimeters).

Installation Tools, ITR (Flush or pre-set to your required set heights) are available for each product series.

# QA Technology Replacement PIN Replacement STOP

#### **CONVENTIONAL SOCKETS**





		SOCKET INSTALLATION TOOL PART NUMBERS									
PRODUCT SERIES	ADJUSTABLE TOOL	ADJUSTABLE REPLACEMENT PIN	ADJUSTABLE REPLACEMENT STOP	FLUSH TOOL	REPLACEMENT <b>TIP</b>	PRESET TOOL	REPLACEMENT TIP	SET HEIGHT (MIN TO MAX)			
039-16 039-25 039-40	ATR039 ATR039M	ATR0	39-TIP	ITR039-FL	ITR039-FL-TIP	ITR039 Set	ITR039-TIP Set	0.001 to 0.320 [0.03 to 8.13]			
050-05 050-16	ATR050	ATR050-PIN	ATR050-STOP	ITR050-FL	ITR050-FL-TIP	ITR050	ITR050-TIP	0.001 to 0.360 [0.03 to 9.14]			
050-25 050-40	ATR050M	ATR050M	ATRUSU-PIN	ATRUSU-STUP	IINUSU-FL	1111030-FL-111	Set	Set	0.001 to 0.270 [0.03 to 6.86]		
075-25 075-40	ATR075 ATR075M	ATR075-PIN	ATR075-ST0P	ITR075-FL	ITR075-FL-TIP	ITR075 Set	ITR075-TIP Set	0.001 to 0.345 [0.03 to 8.75]			
100-05				ITR100-FL	ITR100-FL-TIP						
100-16	ATR100	ATR100	ATR100-PIN	ATR100-STOP	ITR100-FL	ITR100-FL-TIP	ITR100	ITR100-TIP	0.001 to 0.190 [0.03 to 4.83]		
100-25 100-40	ATR100M	ATTTOO-T IN	A111100-0101	TITT TOO-IL	1111100-1 E-111	Set	Set	0.001 to 0.345 [0.03 to 8.76]			
125-25	ATR125 ATR125M	ATR125-PIN	ATR125-STOP	ITR125-FL	ITR125-FL-TIP	ITR125 Set	ITR125-TIP Set	0.001 to 0.240 [0.03 to 6.10]			
156-25				ITR156-FL	ITR156-FL-TIP	ITR156 Set	ITR156-TIP Set	0.001 to 0.250 [0.03 to 6.35]			
187-25				ITR187-FL	ITR187-FL-TIP	ITR187 Set	ITR187-TIP Set	0.001 to 0.240 [0.03 to 6.10]			

		TERMINATION INSTALLATION TOOL PART NUMBERS								
PRODUCT SERIES	FLUSH TOOL	REPLACEMENT <b>TIP</b>	PRESET TOOL	REPLACE- MENT <b>TIP</b>	SET HEIGHT (MIN TO MAX)	PRESET Negative TOOL	<b>PRESET</b> Negative REPLACEMENT <b>TIP</b>	SET HEIGHT (MIN TO MAX)		
X31-16 X31-25 X31-40	ITRX31-FL	ITRX31-FL-TIP	ITRX31 Set	ITRX31-TIP Set	-0.150 to 0.050 [-3.81 to 1.27]	ITRX31E Set	ITRX31E-TIP Set	-0.435 to -0.150 [-11.05 to -3.81]		
X39-16 X39-25 X39-40	ITRX39-FL	ITRX39-FL-TIP	ITRX39 Set	ITRX39-TIP Set	-0.150 to 0.100 [-3.81 to 2.54]	ITRX39E Set	ITRX39E-TIP Set	-0.435 to -0.150 [-11.05 to -3.81]		
X50-16 X50-25 X50-40	ITRX50-FL	ITRX50-FL-TIP	ITRX50 Set	ITRX50-TIP Set	-0.150 to 0.150 [-3.81 to 3.81]	ITRX50E Set	ITRX50E-TIP Set	-0.435 to -0.150 [-11.05 to -3.81]		
X75-16 X75-25 X75-40	ITRX75-FL	ITRX75-FL-TIP	ITRX75 Set	ITRX75-TIP Set	-0.150 to 0.150 [-3.81 to 3.81]	ITRX75E Set	ITRX75E-TIP Set	-0.435 to -0.150 [-11.05 to -3.81]		

#### **Extraction Tools**

Extraction Tools, **ETR** remove sockets or termination pins without damaging the mounting hole.

To properly extract a socket or termination pin from your fixture, we recommend that it first be mounted Flush. We offer an **ETR-KIT**, which includes an ITR-FL and ETR tool for each product series.

#### **CONVENTIONAL SOCKETS**



Termination Extraction Tools ETRX remove termination pins without damaging the mounting hole. ETRX\_E Tools are designed to remove and install termination pins from the back plate with the probe and optional spacer plate in place.

#### X PROBE SOCKETLESS



	EXTRACTION TOOL PART NUMBERS								
PRODUCT SERIES	KIT TOOL	EXTRACTION TOOL	REPLACEMENT TIP	<b>EXTENDED</b> EXTRACTION TOOL	<b>EXTENDED</b> REPLACEMENT TIP				
039-16 039-25 039-40	ETR039-KIT	ETR039	ETR039-TIP						
050-05 050-16	ETR50-05/16-KIT	ETR050-05/16	ETR050-05/16-TIP						
050-25 050-40	ETR050-25-KIT	ETR050-25	ETR050-25-TIP						
075-25 075-40	ETR075-KIT	ETR075	ETR075-TIP						
100-05 100-16 100-25 100-40	ETR100-KIT	ETR100	ETR100-TIP						
125-25	ETR125-KIT	ETR125	ETR125-TIP						
156-25	ETR156-KIT	ETR156	ETR156-TIP						
187-25	ETR187-KIT	ETR187	ETR187-TIP						
X31-16 X31-25 X31-40	ETRX31-KIT	ETRX31	ETRX31-TIP	ETRX31E	ETRX31E-TIP				
X39-16 X39-25 X39-40	ETRX39-KIT	ETRX39	ETRX39-TIP	ETRX39E	ETRX39E-TIP				
X50-16 X50-25 X50-40	ETRX50-KIT	ETRX50	ETRX50-TIP	ETRX50E	ETRX50E-TIP				
X75-16 X75-25 X75-40	ETRX75-KIT	ETRX75	ETRX75-TIP	ETRX75E	ETRX75E-TIP				

### Wire Plug **Installation Tool**

QA TECHNOLOGY WTR Replacement Tip

WTR28 or WTR30 Wire Plug Installation Tools are used to install Wire Plug, into the back of the socket. Order WTR28-TIP or WTR30-TIP for replacement tip.

### Wire Jack **Installation Tool**



JTR2830 Wire Jack Installation Tools are used to install Wire Jacks for the wire assembly into the back of the socket or termination pin. Order JTR2830-TIP for replacement tip.

### **Wire Grip Installation Tool**



GTR31, GTR39 and GTR50 Wire Grip Installation Tools are used to install Wire Grips for the wire assembly into the back of the socket or termination pin. Order GTR31-TIP, GTR39-TIP or GTR50-TIP for replacement tip.

### **Probe Installation Tool**



PT50/39 and PT100/75 Probe Installation Tools ease probe installation while preventing probe tip blunting.

### **Probe Extraction Tool**

PERX39/050, PERX50/075 or PERX75/100 Probe Extraction Tools allow easy removal of probes with headed point styles. Order



PERX39/050-TIP, PERX50/075-TIP, or **PERX75/100-TIP** for replacement tip.

### **Damaged Probe Tube Extraction Tool**



TERX31/039, TERX39/050, TERX50/075, and TERX75/100 tools are used to remove a damaged probe tube. Order TERX31/039-TIP, TERX39/050-TIP, TERX50/075-TIP or TERX75/100-TIP for replacement tip.

#### **Indicator Probes**

Used to measure probe stroke in a test fixture (plunger remains at deflected position).

#### 050-25 & 050-40 SERIES



#### 075-25 & 075-40 SERIES



#### 100-25 & 100-40 SERIES

IP100-2510	06	#15-750)	
IP100-2540	04	PEO.Mr.	
IP100-4010	04-	\$5.6H	
IP100-4040	DA .	1996	

#### X39 SERIES

IPX39-2540

#### X50 SERIES



#### X75 SERIES



### Wire Jack Crimping Tool

An air-actuated Crimper, CR2830 is available to permanently attach customer supplied wire to wire jacks.



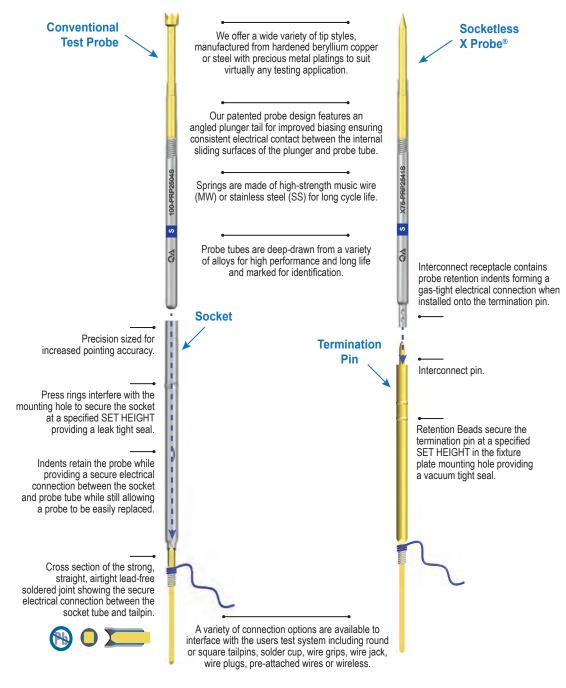
# **General Product Information**

# **Design and Construction for QA Test Probe Products**

QA Technology's test probe products are designed and primarily utilized for testing printed circuit boards, components, and for interfacing test fixtures to automatic test equipment (ATE) where compliant electrical interfaces/contacts are needed.

Our test products use a two-part system: a test probe and a socket or termination pin. This system provides

a reliable electrical contact when testing the various types of UUT configurations, where variable target types, board manufacturing processes, and testing environments are encountered. Our wide range of products provide the versatility needed to work in applications including bare board, functional and incircuit test, as well as solutions to the ever-changing industry process challenges.



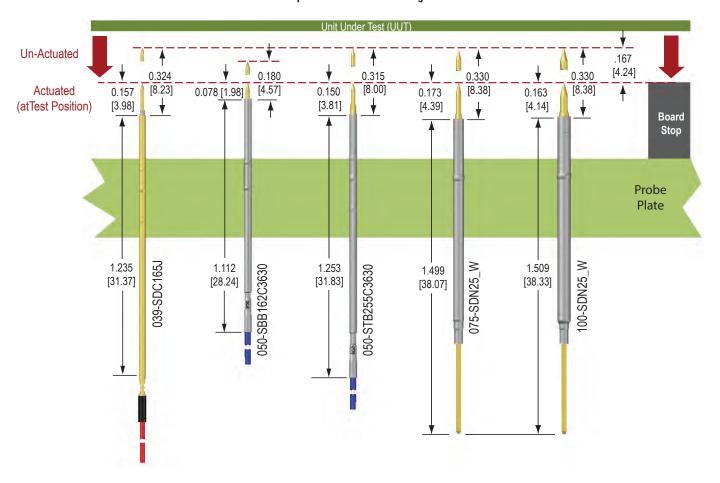
# Sample Fixture Layout (Conventional)

QA Technology offers a broad range of In-circuit (ICT), Functional (FCT) and Ball Grid Array (BGA) probes, sockets and accessories. With thousands of standard tube material, tip style and spring force configurations available for delivery within 24 hours, QA's test product lineup and delivery are second to none. QA also offers complete product support, from recommending a tip style or spring force to full

product application analysis with suggestions to help reduce false failure causes.

Conventional ICT, bare board and functional test probes and sockets, as well as double-ended probes are offered for center to center spacing from 0.014 [0.35] up to 0.187 [4.75]. Below you will find a general layout example of a test fixture utilizing different termination types on 39mil through 100mil center spacing. For more information regarding your application, please feel free to contact us.

#### **Example of Wired Fixture Configuration**



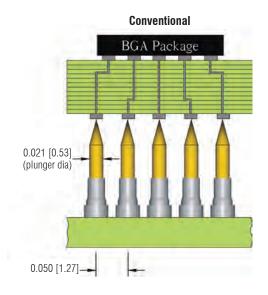
# Socketless X Probe® **Technology Overview**

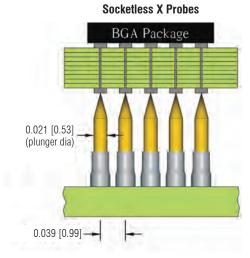


As the physical size of printed circuit boards continues to shrink faster than ever, smaller targets on closer centers have a direct correlation to

the rapidly growing demand of smaller probes used in test fixtures today.

X Probe® Socketless Technology overcomes the shortcomings of using conventional probes on fine pitched targets. The X Probe socketless design utilizes a larger more robust probe and allows it to be mounted on closer centers compared to a conventional probe and socket system.

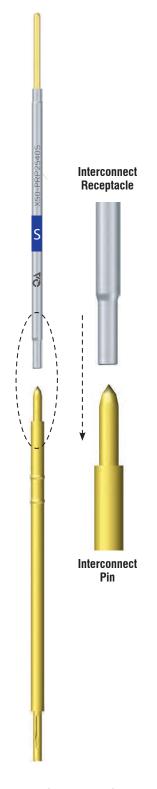




The X Probe Socketless Series comprises two parts: a test probe and a termination pin. The probe is designed around our patented rolled probe tube design with a modified interconnect receptacle on the bottom. This interconnect receptacle increases the tube length

while all other aspects of the probe are the same. The interconnect receptacle receives the precision interconnect pin located at the top of the termination pin.

The termination pin is unique in that it performs all the functions of a typical socket while staying within the diameter of the probe tube. The termination pin is the heart of the assembly. It retains the probe at the proper set height by utilizing two retention beads while providing a reliable electrical connection between the probe and the test fixture's wiring.

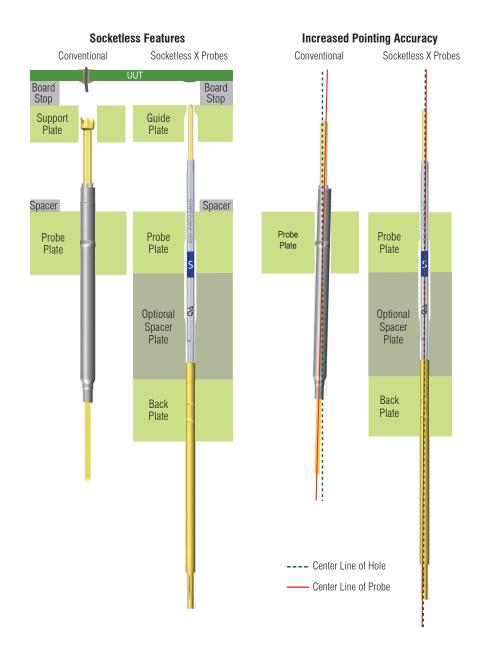


#### **Features**

- Based on "tried and true" fixture methods.
- Adjustable termination pin set heights for leads vs. pads/vias.
- Available in multiple working stroke designs for compact, standard and dual leveling test fixture designs.
- Easily incorporated into fixture designs for all test platforms: Keysight, GenRad, Teradyne and others.
- Compatible with all existing manufacturing and assembly techniques.
- Easy maintenance and increased test reliability.
- Availability and acceptance worldwide benefits board designers, OEMs, fixture houses, and test engineers.

#### **Benefits**

- Large termination pin allows faster drill times.
- Solid termination pin does not wear out and provides increased durability.
- Reduces board manufacturing costs.
- A greater number of spring force and tip style selections.
- Available with all conventional wiring methods - end user friendly.
- Increased pointing accuracy helps improve first pass yields.
- Simplifies board design.



# **Available Wire Methods** Pre-attached Wire Wire Jack Wire Grip Wire Wrap Round Tail Wireless'

# **Sample Fixture Layout (X Probe)**



X Probe Technology is compatible with Keysight/Agilent, GenRad, Teradyne, and others. Existing fixture kits are able to accommodate

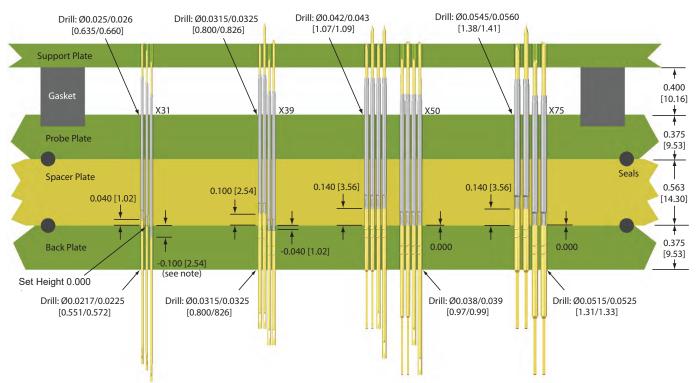
X Probes even when additional plates are required. In general, the height of the fixture is increased to maintain the depth of the wiring area to accommodate the personality pins and alignment plate. A taller dress frame is required to accommodate any additional height.

With design considerations, standard test probes can be mixed mounted with the X Probe Socketless Series. A standard socket would mount in the Probe Plate and clearance holes would have to be drilled in the optional Spacer and Back Plates.

A gasket or seal method would have to be designed to maintain the integrity of the vacuum. The best approach is to cut out areas in the plates where the sockets are to be mounted and design inserts with gaskets to accommodate them.

When incorporating mix mounting into your X Probe fixture kit design or comparable, you must plan ahead to account for the added overall height of the X Probe and termination pin.

#### **Example of Wired X Probe Fixture Configuration**



Note: When using a set height of below FLUSH for X31 Terminations, back plates will need to be counter drilled at Ø0.025/0.026 [0.635/0.660] to the proper depth to allow clearance for probe tubes

### **Probe Tube Materials**

Measurement sensitivity is a critical factor when considering probe performance. The more sensitive the measurement, the smaller the threshold between pass and fail, so it is important to match the correct probe to the application.



The tube material is an important feature when selecting the right test probe for your application. The following is a summary of the options, characteristics, and color code identification of QA probe tube materials:

### "N" Style Probe Tube

The "N" tube is a nickel silver tube without plating. This tube is suitable for bare board test applications or where probe resistance below one ohm is acceptable.



### "G" Style Probe Tube

The "G" tube is a nickel silver or phosphor bronze tube plated with gold. This tube is suitable for loaded board and in-circuit testing where an improvement in performance and longer life over the "N" tube is required.



### "V" Style Probe Tube

The "V" tube is a nickel silver or phosphor bronze tube plated with silver. This tube is suitable for loaded board and in-circuit testing in non-corrosive environments where an improvement in performance and longer life over the "N" tube is required.



### "P" Style Probe Tube

The "P" tube is a nickel silver tube with precious metals clad on the inside surface. This unique cladding process, through deep drawing, hardens the precious metal layer improving wear properties while providing a uniform surface along the entire ID of the tube. This tube is suitable for all loaded board and in-circuit testing where long life and low consistent electrical resistance is required.



### "H" Style Probe Tube

The "H" tube is a high conductivity proprietary tube plated with gold. This premium tube style is suitable for high current loaded board and in-circuit applications to provide an improvement in performance compared to the "G" and "P" tubes.



### "S" Style Probe Tube

The "S" tube is a high conductivity proprietary tube plated with silver. This tube style is suitable for high current, loaded board and in-circuit testing applications for use in non-corrosive environments to provide an improvement in performance compared to the "H" tube.



# **Spring Force Selection**

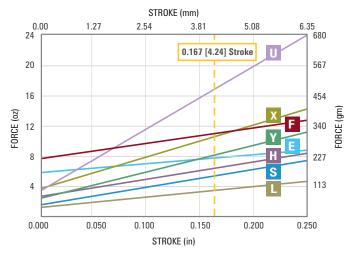
Selecting the proper spring forces for probes used to test printed circuit boards is not a casual consideration. The right spring force can make an important impact on contact reliability and will affect the cycle life of a probe. More importantly, determining the correct overall spring force is critical to ensuring the proper actuation of a test fixture and to preventing potential damage to the unit under test (UUT).

QA Technology's springs are designed to be used at working stroke, typically 2/3 of the rated full stroke. This maximizes the cycle life of the probe without the risk of over stressing the spring.

QA's high pre-load springs (E or F) offer a higher initial force through the full stroke to generate better probe tip penetration. The spring force is more consistent when the probe stroke is affected by variations due to board flex, fixture tolerances, and target heights.

Spring material is also an important factor when considering higher current applications. Stainless steel (SS) springs will typically carry higher amperage with increased temperature limits compared to music wire (MW) springs.

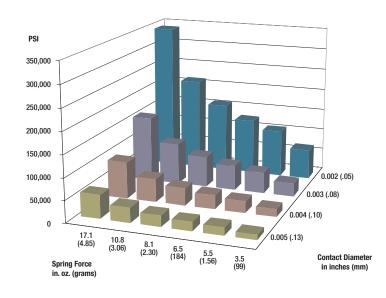
#### 100-25 SERIES SPRING FORCES



### Contact Force on a Test Target

It is important to consider the condition of the UUT surfaces when selecting the proper spring force. When a probe makes contact, it causes deformation of the test target materials. The contact force for each probe must be high enough to penetrate any oxides, contaminants, or flux residues that can accumulate on both the test targets and the probe tips.

Sharp probe tips have the benefit of a reduced surface area which significantly increases the contact pressure applied. This allows the designer to select lower spring forces in a fixture and still achieve good contact.



By contrast, a probe tip which is flat or rounded by design will make contact over a larger area, causing less contact pressure. This may interfere with the probe's ability to penetrate contamination layers. In these situations, a higher spring force may be necessary to achieve reliable electrical contact.

### **Calculating Spring Force for a Chosen Stroke**

Probes are not always used at their rated working stroke. A probe's spring force at any chosen stroke can be calculated with the formula:

$F = P + (S(Fw - P) \div Sw)$ WHERE:	100-25 SERIES STANDARD SPRING FORCE
F = Force at actual stroke (oz, gm, Newtons)	
S = Actual stroke (in or mm)	
P = Preload force (oz, gm, Newtons) see catalog/website	1.6 oz [45 gm/0.44N]
Fw = Force at known working stroke (oz, gm, Newtons) see catalog/website	5.5 oz [156 gm/1.53N]
<b>Sw</b> = Known working stroke (in or mm) see catalog/website	0.167 [4.24]

Example: Find the force at 0.200 [5.08] stroke for the standard force spring in the 100-25 series:

$$F = P + (S(Fw - P) \div Sw)]$$

$$F = 1.6 + (0.200(5.5 - 1.6) \div 0.167) = 6.3 \text{ oz } [179 \text{ gm/1.76N}]$$

#### **Vacuum Fixture Considerations**

The collective force of the probes must not exceed the vacuum fixture system's capability to move the tested product into contact with the probes. This formula can be used to calculate either the maximum number of probes of a given spring force, or the maximum spring force allowed for a given number of probes. An efficiency factor is added to account for fixture leaks, spring force tolerances, vacuum considerations (details below), etc. The spring force must never exceed the force applied by atmospheric pressure.

Example: 6" x 10" [15.2 cm x 25.4 cm] board and 5.5 oz [156 gm] probes.

By using the total area of the UUT in the formula, the approximate maximum number of probes in a fixture can be calculated (Example below)

Avoid densely concentrated areas of high force so as not to damage the product or cause fixture actuation problems.

Concentrations of probes around connectors or large pin packages may exceed one (1) atmosphere in a small area of the product as long as the total force is below the maximum limit. Uneven probe distribution can cause excessive flexing of the product and may affect the vacuum seal – particularly with thin boards.

### **Vacuum System Efficiency**

When calculating spring force limitations, the efficiency factor is used to define the vacuum system's ability to overcome the total probe spring force. The two factors that are typically referenced are air flow in cubic feet per minute (CFM) and amount of vacuum in inches of mercury. Cubic feet per minute is the measure of the vacuum system's ability to move a volume of air over time. The higher the CFM, the better the vacuum system's ability to draw the product down quickly and overcome initial seal leakage. A vacuum reservoir will compensate for low pump CFM, absorbing the initial rush as the vacuum system evacuates the fixture and seats the product. Inches of mercury is the measure of the system's ability to draw a complete vacuum. Thirty inches of mercury is one atmosphere (a full vacuum). Anything less than 30 inches can be considered a percentage of one (1) atmosphere and used in the probe limit calculation above as the efficiency factor. The example used in the limit calculation was 0.60 which represents 18 inches of mercury in a high elevation facility divided by 30 inches.

### **Summary**

Check spring force selection or changes with the fixture manufacturer since these choices are closely tied to the fixture design.

Contact pressure (a function of spring force and tip geometry) must be high enough to penetrate oxides and contaminants that accumulate on both the test targets and the probe tips.

Electrical performance depends largely on the combination of tip sharpness and geometry, as well as on the spring force of a probe. While increasing spring force applies more contact pressure to the test targets, be cautious because it also adds to the overall forces applied to the UUT.

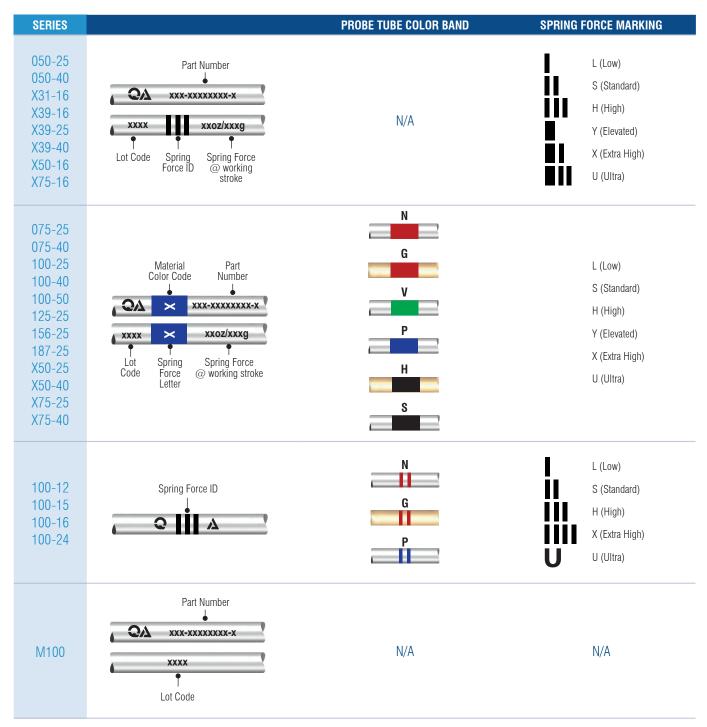
#### Example:

AREA OF BOARD	x	ATMOSPHERIC PRESSURE	х	FORCE UNIT CONVERSION	÷	AVE. FORCE PER PROBE	х	SYSTEM EFFICIENCY	=	MAX NO. OF PROBES
60 in <sup>2</sup> [387 cm <sup>2</sup> ]	X	14.7 psi [1.03 kg/cm²]	X	16 oz/lb [1000 gm/kg]	÷	5.5 oz [155 gm]	X	60%	=	1,500

AREA OF BOARD	х	ATMOSPHERIC PRESSURE	х	FORCE UNIT CONVERSION	÷	AVE. FORCE PER PROBE	х	SYSTEM EFFICIENCY	=	MAX NO. OF PROBES
1 in <sup>2</sup> [6.45cm <sup>2</sup> ]	x	14.7 psi [1.03 kg/cm²]	X	16 oz/lb [1000 gm/kg]	÷	5.5 oz [156 gm]	X	60%	=	25

### **Probe Identification**

QA Technology uses a series of markings to ease probe selection and to help test engineers, fixture fabricators, or maintenance technicians to identify the correct part when replacing a worn out or damaged probe. The chart below identifies the markings for each of our product series.\*



<sup>\*</sup>Unmarked series: 025-16, 039-16, 039-25, 039-40, 050-05, 050-16, 100-05, M035, M08, X31-25, X31-40 or any high-preload (E/F) spring probes

# **Wire Socket and Termination Pin Connection Options**

QA Technology offers a wide variety of wire termination types to fit your application. The following is a summary of the options and their applications.

Please Note: some of these socket or termination pin styles are available only in specific probe series (refer to the QA Technology catalog or website for details).

#### EXAMPLE SOCKET P/N: XXX-SXXXXX OR TERMINATION P/N: XXX-T --XX

P/N Designation	DESCRIPTION
C	Crimp Used to manually attach custom wiring. Not included.
Сххх	Crimp with Pre-attached Wire  Used primarily on close center or fine pitch probe sizes where wire wrap is not available. For a reliable connection, these sockets are available with a four-jaw, eight indent crimp for the wire attachment. Various wire gauges, lengths, and colors are available.
DSx	Double Ended Compared to conventional wire designs, these sockets, used in wireless fixtures, offer shorter signal path lengths for improved signal integrity from the tester circuits to the unit under test (UUT).
G	Wire Grip Used with our WG wire grip sleeves (sold separately) and customer supplied solid conductor wire, QA wire grips offer an easy wire connection method for socket or termination pin applications.
J	Wire Jack Used with our WJ wire jack (sold separately and available with or without solid conductor wire pre-attached), QA wire jacks offer an easy wire connection method for socket or termination pin applications.

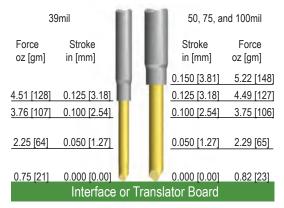
P/N Designation	DESCRIPTION
M	Male Round Tube  QA male round tubes are typically mounted onto edge cards, ribbon cable assemblies, or other type of connectors. They are made to accept a one millimeter (1.0mm) female plug. These sockets are made of stainless steel and are recommended for corrosive environments. They are not recommended for solder applications.
N	No Termination Typically used as an inexpensive option, these sockets can be soldered directly to a board, crimped or soldered into the open end.
P	Wire Plug Used with our WP wire plugs (sold separately) and customer supplied wire, QA wire plugs offer an easy wire connection method to a socket.
R	Round Pin  QA round pins are used primarily for female connectors, or they can be soldered directly into board vias.  Pins are available in a variety of lengths.
S	Solder Cup  QA solder cups are exceptionally reliable connections and are used primarily in low-density areas.  They can be wave or hand soldered and used in vias or with wire.
W	Square Wire Wrap Pin Square wrap pins are the most commonly used terminations in ATE fixturing for large-scale wiring. QA's products provide excellent electrical integrity through a gas-tight connection that prevents the effects of corrosion. They are one of the most cost-effective connection methods for skilled fixture makers because they facilitate rapid installation, reliable performance, and are inexpensive solutions. QA wire wrap pins are available in a variety of lengths.

# **Sockets and Termination Pins for Wireless Testing**

Wireless sockets or termination pins allow construction of fixtures with shorter signal path lengths compared to conventional wired designs. The shorter path length allows for improved signal integrity from the tester circuits to the unit under test (UUT). Fixtures built in this manner are referred to as "wireless" and they improve impedance characteristics, allow greater bandwidths for analog test signals and higher vector rates for digital testing.

A wireless socket or termination pin has a non-replaceable interface probe as its termination. This interface probe typically contacts a dedicated PCB/interface/ translator board on the fixture. The bottom probe is noncycling and it is designed to last the life of the socket. Replace the wireless assembly if the socket is damaged or worn.

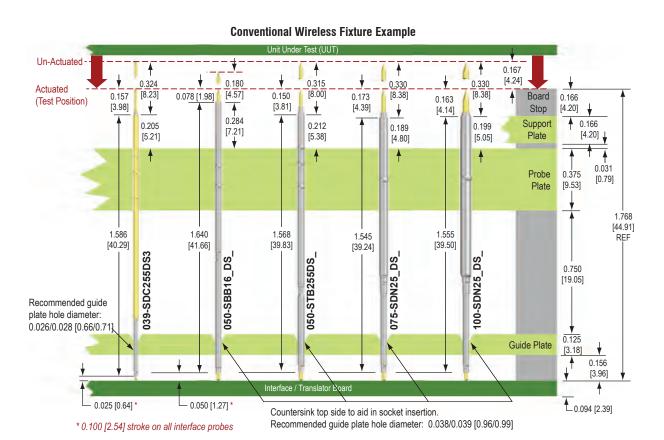
The top of the socket or termination pin accepts standard probes from the appropriately sized series and is



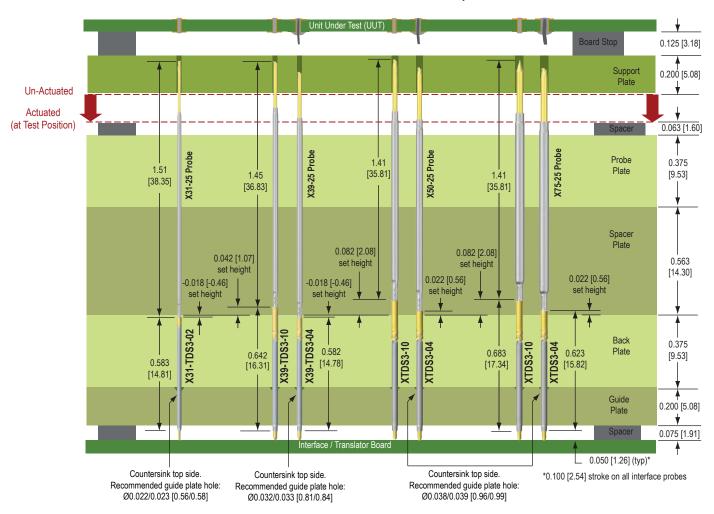
Plunger stroke and force for interface probes

replaceable, as routine maintenance requires. When mix mounting QA's 39mil wireless sockets with 50mil, 75mil, and 100mil wireless sockets, the fixture designer must consider that the full plunger stroke of the 39mil wireless socket is only 0.125 [3.18] stroke versus the 0.150 [3.81] stroke for the others.

Ultimately, the set height and board layout are dependent upon the specific fixture design and application. QA recommends a guide plate to help maintain alignment between the interface probe and the contacts on the dedicated PCB/interface/translator board. Here's a suggested layout as a reference.

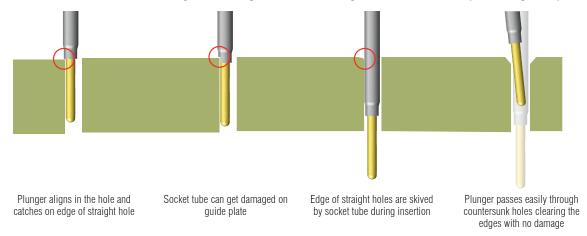


#### Socketless X Probe® Wireless Fixture Example



### **Advantage of Using Countersunk Holes**

The illustrations below show the advantages of using a countersunk guide hole on the top of the guide plate.



**Notes** 



# **Probe Selection by Application**

# **Testing in Extreme Working Temperatures**

QA Technology test probes are designed for optimal performance in a wide range of test environments. When testing in extreme high or low temperatures, the right probe materials are key to performing a successful test and maximizing cycle life. In a humid environment, moisture can increase the negative effects of fluxes and contaminants that collect on the probes from the unit under test.



Our probes' spring material and lubrication determine the working temperate limits of a given probe series. As with many moving parts that involve friction, probes are lubricated to prevent wear, extend cycle life, and maintain low electrical resistance.

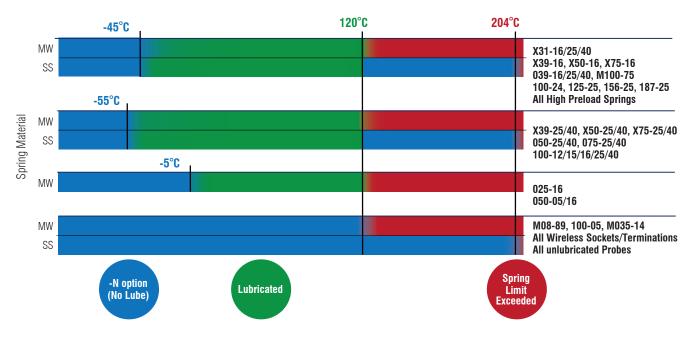
Below is a chart of the various product series we offer and their temperature limitations. More details can be found on each product series specification in our catalog or website.

At extreme high temperatures, lubrication properties could degrade and the strength of the spring material may be compromised. Although the springs are not likely to fracture in this situation, they may take a permanent set and the spring force at a given deflection will be reduced. Select probes with a stainless steel spring and non-lubricated (-N) option to withstand the higher temperature, up to 204°C, to maximize cycle life.

In extreme cold temperature environments, the lubricant's viscosity will increase as temperature decreases, causing sluggish movement of the plungers and intermittent contact. If probes are actuated below their rated temperature, the lubrication may not perform properly resulting in galling of the plunger and inside surface of the probe tube. This wear could cause the base metal to form oxides, greatly reducing the electrical performance.

If it is necessary to perform tests below the rated temperature limit, QA recommends using non-lubricated probes as there is no known lower temperature limit and they will actuate freely. Keep in mind that cycle life is reduced and resistance is higher with non-lubricated probes.

If it is necessary to use lubricated probes in extreme cold environments without doing harm to the plating or materials, actuate them at room temperature and then move them to the cold environment.



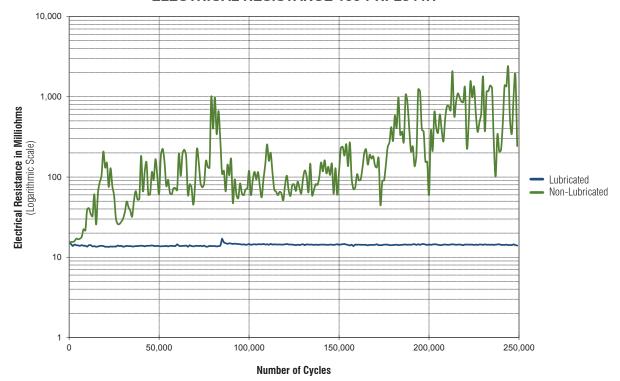
#### **Lubricated vs. Non-lubricated Probes**

While testing in extreme environments is achievable, there are significant performance differences between lubricated and non-unlubricated probes, such as cycle life and resistance.

In a side-by-side cycle test study with standard lubrication and identical probes without lubrication, resistance measurements were taken at every 2,000 cycles, and stroke measurements at every 5,000 cycles. Note that cycle counts on a tester in a controlled laboratory environment are considerably higher than in a production environment. Below is a summary of the results:



#### **ELECTRICAL RESISTANCE 100-PRP2544H**



100-PRP2544H	100-PRP2544H –N
LUBRICATED	NON-LUBRICATED
No measurements greater than 24 milliohms.	Electrical resistance greater than 50 milliohms was seen as early as 8,000 cycles.
	Wear particles were present on the plunger shanks around the socket bases. This caused electrical and stroke failures.
Spring force was consistent throughout the test with no increase in spring force after 1,000,000 cycles.	Significant increase in the force required to compress the non-lubricated probe.

# **Tip Style Selection**

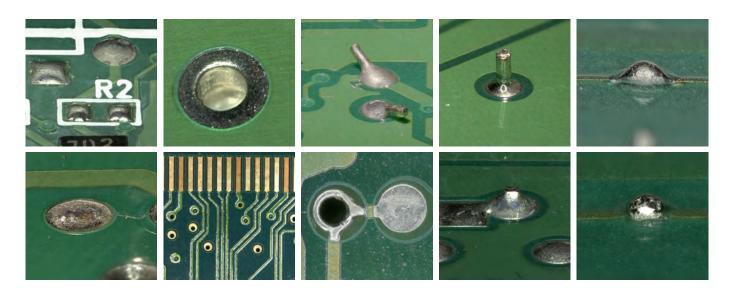
Printed Circuit Boards (PCB) are an essential part of the many electronic products we rely on every day. Both in-circuit and functional testing after manufacturing are critical steps to ensuring their dependability. QA Technology's test probes are an important part of this process, offering the best possible electrical contact with each board being tested.

While there are many probe factors that affect its ability to make reliable electrical contact, proper tip style selection is likely the most important one. Incorrect tip selection could cause false failures where no defects are found (NDF), lower your first pass yields (FPY), or in extreme cases, damage the unit under test (UUT). Selecting the right tip can reduce the overall cost of test by increasing the output of units being tested and extending the life of your test probes.

Test engineers often have very different experiences as to which is the best probe tip style to use for any given contact surface. QA offers a wide range of styles to support the various board test applications known in the industry. The following considerations will help you select the right tip style for many of today's common test targets.

### **Test Target Types**

It is important to consider the size, shape and other features of the test targets. There are various PCB targets such as pads, vias, leads, posts, and solder bumps, which range in probe-ability from easy to difficult.



#### **BOARD MANUFACTURING/PROCESSES**

PCBs that are designed with a clean process and are produced with surface finishes such as immersion tin, silver, gold, or ENIG are generally considered easy to probe. Reliable electrical contact can be achieved by using many of the common probe tip styles.





Immersion Aq (silver)





**Immersion Sn** 

Test targets that are solder pasted using a no-clean process, or have other common finish types such as hot air solder leveling (HASL), are typically considered medium difficulty to probe. For these finishes, be sure you are using a no-clean paste that incorporates a pin-testable flux. The selection of probe tips to choose from for these applications is slightly more limited.

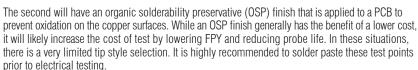


Hot Air Solder Leveling - HASL



Lead with wave solder/reflow

The most difficult to probe test targets typically fall into one of two categories. The first is one that is solder pasted using a flux that is NOT rated as pin-testable (PT). This type of flux leaves a residue that is more difficult to penetrate, making electrical contact less reliable. In this case, we recommend that you work with your process team to see if a probe-able flux can be used.





Lead Free Solder Paste/Flux



Organic Solderability Preservative OSP



Unpasted OSP Via

### **Tip Materials**

QA's tips are made from either beryllium copper (BeCu) or steel. Both are gold plated over nickel. The hardness of steel ranges between 58 and 60 on the Rockwell C scale, 38-42 for BeCu. As such, steel will have reduced wear and remain sharp longer.

While there is a difference in the average resistance of less than 10 mOhms between the two base materials, it will not affect the vast majority of test applications.

### **Tip Geometry**

QA offers many different tip styles, each with their unique geometry. The large number of headed or headless choices supports the wide variety of test applications.

Geometry and sharpness will determine the ability to penetrate contamination layers. A tip that is blunt or has dull edges will make contact over a larger area thus reducing its ability to penetrate contamination layers on the test targets.

A tip that has a sharp point or steep cutting edges applies a higher pressure against the solder causing it to yield. As the solder yields, any oxides or remaining flux residues are disrupted, allowing better electrical contact.



### **Recommended Tip Styles for Target Types**

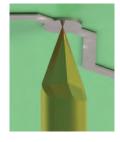
#### **TEST PADS, VIAS AND THROUGH-HOLES**

TEST PADS, VIAS and THROUGH-HOLES come in a wide range of sizes, surfaces, and shapes. They can be solder pasted, unpasted, concave, flat, or convex (dome).

Vias and through-holes in a PCB are typically used to pass a signal from one layer to another. When these are to be used as test points, it is necessary that they are not solder-masked so that they can be easily probed.













EASY

For gold plated pads use a SPHERICAL or FLAT tip to minimize marking.











For flat pads or solder domes, reduced **CROWN** tips may be considered to prevent sliding off the target.



For contacting flat pads and vias pasted with pin-testable solder, CHISEL, BLADE, or STAR tips can be good choices.







The CHISEL TRIAD tip is a good choice for contacting open holes/vias where flux is present. The SPEAR tip is used when the rim of the hole must remain free of marks.







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**RAZOR** tips are made with two sharp cutting edges to increase contact reliability on a wide variety of pasted pads and vias. Although QA does not recommend testing on unpasted vias, the 6R RAZOR may be the best choice.







A steeper angled tip such as SHARP CHISEL, SHARP NEEDLE, or TRIAD can provide the highest penetrating pressure for reliable testing on flat or domed test pads.







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#### **LEADS AND POSTS**

A lead is a terminal on a component. They could be different lengths, straight or bent. Smaller leads will require tip styles with closely spaced cutting edges to trap the leads. A post is larger in diameter and more rigid than leads.

Multi-point tips are designed to capture a target, such as a lead or a post. Some styles have steeper valleys between the tips, creating a self-cleaning feature where it allows contamination to escape.











For stability on a lead or post and to minimize side-loading, the **SERRATED** tip style is the best choice, but has a limited ability to penetrate contamination.







For extremely long leads, CUP or TORCH tip styles can be used, but are likely to require more maintenance.









When using a pin-testable flux, a self-cleaning CROWN or other multi-point tip with valleys will help prevent contamination from building up.













Tip styles with close points, such as CHISEL TRIAD, or TORCH, are best used on short leads.





A **SLOTTED CUP** tip is self-cleaning, while a traditional CUP can easily collect dust and contamination from the ÚUT. A traditional CUP is best used in a horizontal or downward-pointing orientation.





When a more difficult to test process is being used, consider using an aggressive self-cleaning **CROWN** tip design that features deeper cuts.



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Small diameter leads require a self-cleaning tip geometry such as a **CROWN** or **TORCH** tip to prevent the lead from slipping through the valleys.





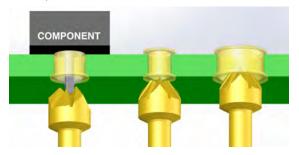
#### **SOLDER BEAD/BUMP/DOME**

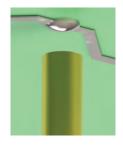
Technology provides test point accessibility, using a probe to contact a variety of solder beads or bumps that are placed on a trace where the solder mask has been removed. In addition, by placing an excessive amount of solder on vias or test pads, a round dome of solder may also need to be probed.

In addition, QA offers many specialty tip styles for other important, but less common applications.

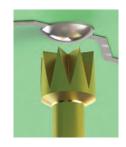
 Our CHISEL TRIAD "38" tip style is designed specifically to be a multi-purpose solution for boards that may or may not have leads present during testing. When a component is present, the 6 peaks aggressively capture the lead within the cutting

edges. When the component is absent, the point of contact varies based on the diameter of the throughhole. With smaller holes, the three sharp points will hit the face of the via ring. When contacting a larger through-hole, the three sharp cutting edges will contact the inside of the hole, giving optimal electrical points of contact.













For clean processes where a minimal witness mark is desired, our FLAT tip is the best choice.





When light flux residues are present, a MICRO SERRATED tip is suggested.



For no-clean flux targets, our moderately aggressive **FLAT STAR** tip has deep radial groves extending from the center, offering a self-cleaning benefit where contaminates or oxides tend to adhere to other tip styles.









The most aggressive tip for this target type is our **CENTER POINT STAR**. Their sharp radial cutting edges, along with a sharp center point, make these ideal when difficult no-clean flux processes are being used.

For larger solder domes on traces and pads, a SHARP CHISEL or **9R RAZOR** tip may be considered. It is critical to have extremely good pointing accuracy for reliability. QA recommends a guided plate fixture design.







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- Our INSULATOR "89" and "99" tip styles are used to test the presence or absence of a component on a PCB. An insulating sleeve around the probe keeps the probe electrically isolated from a flat contact surface, but allows the probe to make electrical contact with a lead or post.
- Our CONNECTOR "70" tip style is used to test a female pin connector where the rounded tip makes contact with the inner beams. A shoulder of the tip acts as a stop to prevent the tip from sliding completely through.
- QA offers the various tip styles for probes used in tester systems known throughout the industry. In our catalog and website, QA provides complete probe details that match tester manufacturers' series.

# "99" with "99" with "70" Connector Lead Present Lead Absent Probe (contact made) (open contact) 70 03

#### Other Considerations

- When new fixtures are built, we recommend verification of the selected tip styles once all board elements are identified. Initial processes and solder types can vary from the prototype PCB design to the production boards. In preparation for the launch of production UUT's, tip styles may need to be changed to a different geometry or a more aggressive style based on the cleanliness of the board.
- If the tip style recommendations do not generate good electrical contact, look closely at the witness mark that the probe tip should have made on the test target. Poor pointing accuracy, TIR of the probe assembly, as well as the diameter of the target can be attributed to missing the intended target. While certain tip styles may work well on flat or concave vias, when a dome is present, and pointing accuracy is not good, they may glance off the target and hit the solder mask.
- If your board process causes the solder mask to be below the test point, a multi-point tip may work even if you do not have good pointing accuracy. If your solder mask is higher than your target, one or more of these multipoint tips could prevent the others from making electrical contact. In this scenario, change to a single point probe to hit the target.
- In cases where you cannot improve the pointing accuracy on leads or posts, select a larger diameter tip style to maximize the ability to hit the test target reliably.

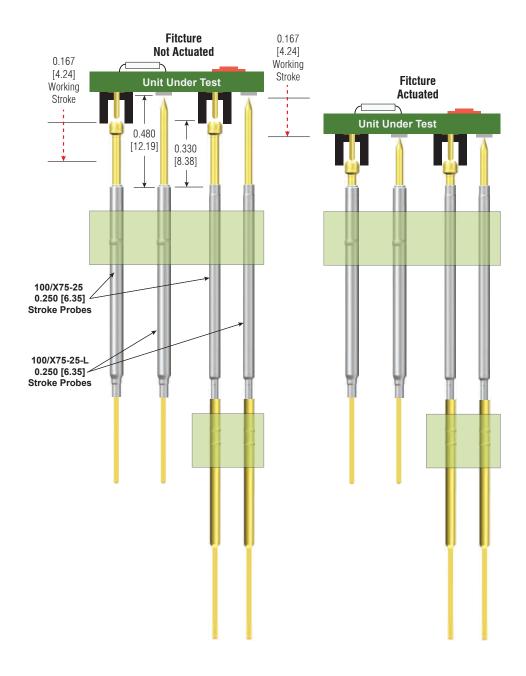
In summary, it is critical to select a tip style with the right number of points of contact, the correct angles, and sharpness. Improving the electrical contact to your test targets will help increase probe life and improve your FPY. Higher yields mean less time troubleshooting false failures, faster through-put, and ultimately, lower overall cost of test.



# **Long Plunger Option For Various Target Heights**

Testing loaded printed circuit boards can be complex when various target heights are present and when you do not want to adjust the socket or termination pin set height.

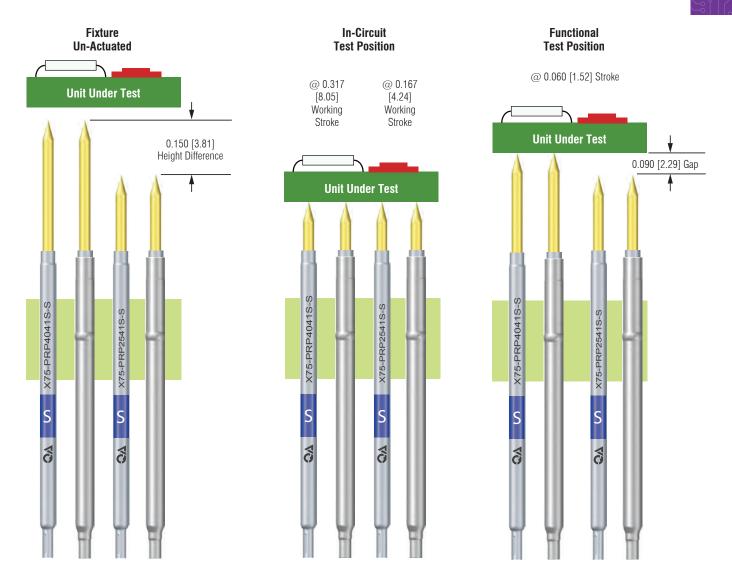
QA Technology's long plunger (-L) option in our 0.250 [6.35] stroke series offers a solution to help contact the shorter target, while maintaining the same spring force when the fixture is actuated at the recommended working stroke.



# **Long Stroke Probes for Dual-Level Testing**

To perform a functional component test (FCT) and an in-circuit test (ICT) in the same fixture, use a longer stroke probe for the functional part of your test. QA Technology's 0.400 [10.16] long stroke probes are designed for this purpose. For dual-level testing, they are easily mixed with their standard stroke 0.250 [6.35] counterparts, available in a variety of sizes. This allows for the same set height when mounting sockets or termination pins for the same series.

Long stroke probes are 0.150 [3.81] longer than their neighboring standard stroke probes when the fixture is in the unactuated position. During an in-circuit test, the long stroke probes will be actuated to 0.317 [8.05], and the standard stroke probes will be actuated to 0.167 [4.24], the recommended working stroke position. In the functional test position, the long stroke probes are actuated to approximately 0.060 [1.52], leaving 0.090 [2.29] clearance to the standard stroke probes.

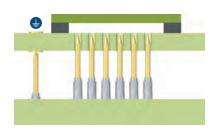


Note: When installing the 050-25 sockets or X39-25 termination pins for the dual level testing, the 0.250 [6.35] stroke sockets terminations must be mounted 0.015 [0.38] higher to achieve the 0.150 tip height difference when the fixture is not actuated.

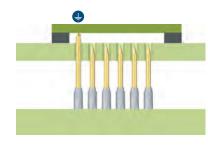
### **Extended Stroke Probe**

QA Technology's Extended Stroke Probe is designed for applications where a longer plunger and more stroke is needed. The 100-50 series probe is a 0.500" (12.7mm) full stroke probe that fits into a standard 100-25 series socket.

### **Suggested Uses:**



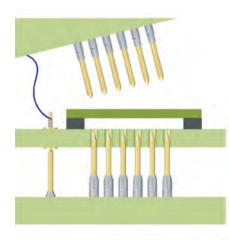
1. To continuously bleed off static charge from a support plate, use an extended stroke ESD ground probe in a probe plate to contact an ESD lug.



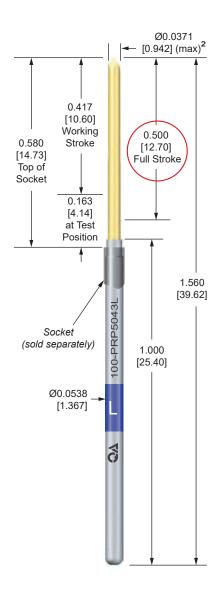
2. Use an extended stroke ESD ground probe to contact a ground point on the UUT to bleed off static before other probes contact a board.



3. Used with a shorter stroke probe, the extended reach probe contacts a conductive sensor on a gate or support plate to signal if a gate is open or closed.



4. Use an extended stroke probe when connecting to transfer points that are connected to topside probes or other signals for sensor plates used in an upper gate assembly. This allows electrical verification to be performed while the topside assembly is in the "open" position.



**Notes** 



# **Cycle Life for Test Probes**

Perhaps the most common question we hear from our customers is, "How long will my probes last?". The best answer we can give is that it depends on many factors. While applications vary widely, extreme testing conditions may exist. Some test probes may be cycled once on clean contacts and maintained in the compressed position, while others on a high volume production assembly line may experience much higher cycles.

The published mechanical life and resistance data for a probe is based on both the fatigue life of the spring and the internal sliding contact surfaces when cycled in a controlled laboratory test environment. However, in an actual production environment, a test probe will typically encounter many conditions that will affect probe life.

Here are several important factors that should be considered:

**Test Application** – Measurement sensitivity is a critical factor when considering probe performance. For example, probe life may be much longer on a less sensitive measurement. Tests requiring high current need probes manufactured from materials that can carry high amperage. For targets with closer than average centers, this forces the use of smaller probes which are more fragile, have lower current ratings, and may have a shorter cycle life than larger probes.

**Board Manufacturing Processes** – There are a variety of board manufacturing processes that play a significant role in the ultimate cost of a test. It has become commonplace to use a no-clean process, which can leave everything from gummy residues to brittle contaminants affecting a probe's contact reliability. Careful selection of tip styles and spring forces must be considered when contacting these difficult test targets.

**Test Environment** – Flux residues can range from very hard to wet and gummy depending on temperature and humidity levels. These flux residues can slowly build up on the tips of the test probes causing false failures resulting in no defects found (NDF). This effort to diagnose and retest boards with these false failures increases your company's total cost of test. Testing in extreme high or low temperatures can reduce probe cycle life significantly. In cold temperatures, a probe's lubrication may thicken, preventing the plunger from returning to full height. In extreme heat, the lubrication and/or the spring material may be compromised, causing premature probe failure.

**Board Manufacturing Materials** – The introduction of manufacturing processes which leave a difficult to probe coating or residues on the board can add complications for testing. Matching the best probe and tip style to the materials and finishes of the test targets is critical for a reliable test and for extending probe life.

For example, while organic solderability preservatives (OSP) can protect boards from oxidation, this protective layer can cause significant problems at test. Because reliable testing requires a good contact between the test probe and the test target, a combination of steel tip material, razor style tip design, and higher spring force will break through the coating, extending the probe's life.

Applying pin testable solder paste to test targets is recommended to provide the most reliable, highest yielding contact surface.

Fixture Design – Fixture design and construction will greatly affect a probe's performance. Probes that are out of alignment will quickly wear out.

- Producing fixture plates with accurate hole sizes, positions, and straightness will improve the installation, wiring, and accuracy of sockets and termination pins.
- When using a guide plate for small targets or close centers, proper alignment will minimize excess wear on the side of the plunger or damage to the probe tip.
- Socket/termination pin set height is also critical for probe performance and longevity. QA probes are designed to operate at a working stroke, typically at two third stroke. When set too low, the probe is under stroked, reducing the contact force and the ability to penetrate surface contaminants. When set too high, the probe is over stroked, which may result in spring failure and potential damage to the unit under test (UUT). Use QA indicator probes to measure the deflection amount and ensure probes are operating with the correct working stroke in your fixture.
- When designing a fixture, proper selection of spring force is important. Several factors such as total collective probe force, condition of the contact surface, contact density, board stops, and support pins all must be considered.
- Using the correct probe installation tool will avoid damage to the tip. A harder tool can cause the tips to deform or even break, directly impacting the probe's effectiveness.

**Probe Selection** – QA offers a wide range of tube, spring, and tip options to ensure the best possible probe choice for a specific application, environment, manufacturing process, and test target.

- The tube material and plating are important factors that influence the resistance and current rating of a probe.
- QA springs are made of music wire or stainless steel and are designed to maximize cycle life for a given force.
- Selecting the right tip style, size, and material for the target is critical for reliable contact.
- There are significant differences between lubricated and non-lubricated probes. QA probes are lubricated to maximize cycle life and performance. Unlubricated probes are available options if required.
- An effective method for maximizing probe life is to select QA's socketless X Probe® design, delivering the same performance as conventional ICT probes while offering additional benefits. Using larger, more robust probes on smaller centers will generate better pointing accuracy, less sideloading, an increased spring force, and tip style selection.

Care and Maintenance – Improved test yields and reduced downtime are the rewards for keeping fixtures and probes in top condition.

- Good maintenance begins with careful storage. Leave probes in their original packaging to protect them from damage.
- Clean probe tips, remove lint, fibers, and other contaminants by gently brushing the probe tips with QA's natural fiber brush and vacuum away the dislodged particles. Never use cleaning solvents. They will wash away the internal lubrication and potentially cause debris to wash inside the probe, causing reduced performance or shorter life.
- Diagnosing contact problems as they arise and replacing test probes one at a time is more expensive than replacing probes on regular intervals. A preventive maintenance program for fixtures can reduce downtime and lower the overall cost of test.

# **Identifying When to Replace a Probe**

Probe wear is inevitable. Knowing when to replace a probe at the right time makes testing more reliable while reducing the chance of false failures and lost rework expenses. Here are some common signs that a probe needs replacing:

## **High Electrical Resistance**

 Contamination buildup on the probe tips or the UUT can form an insulating layer and prevents reliable contact. This contamination comprises flux residue,

solder oxides, and particulates from the contact surface. Also, fibrous contamination from clothing, gloves, or the recently sheared PCB material.



- Damage to the probe tip plating allows formation of oxides on the plunger base material. This effect is compounded in fixtures that sit idle for extended periods in humid environments.
- Damaged probe tips no longer create pressure high enough to make reliable contact. Tips are commonly damaged by improper installation, bottoming during use, or lateral motion between the tip and the UUT.



#### **Internal Wear**

- Plating wear on internal contact surfaces is caused by extended cycling or sideloading the plunger (contacting angled component leads with crowns, contacting misaligned open vias with chisels, etc.).
- Dirty plungers could potentially move contamination onto the critical internal contact areas.



## **Spring Failure**

- Spring failure can occur when probes are used beyond their working stroke and rated cycle life. Indications of spring failure to look for are: plungers that no longer return to full height, reduced spring force, or broken spring coils that compromise the full stroke capability of a plunger which may cause damage to the UUT.
- Temperature relaxation happens when springs are exposed to temperatures greater than 120°C for music wire and 204°C for stainless steel for extended periods.

# **Current Carrying Capacity**

This test report presents the data and describes the procedures for testing the current carrying capacity for QA Technology's test probes and their respective mounting sockets or termination pins. The current carrying ability of a probe is ultimately determined with respect to probe temperature. (Refer to the Applications Note titled Working Temperature Ranges for additional information.) QA's testing was performed at a nominal ambient temperature of 20°C. The final current carrying capacity of a probe will depend upon many additional factors specific to the actual application.

The maximum temperature that a probe can handle is determined primarily by the spring material and the lubricant used. Ratings for probes with music wire springs are limited to 120°C, while stainless steel springs can handle up to 204°C. Ratings at both temperatures are outlined in their respective product pages. Note that only certain products use a stainless spring.

Although our current and temperature ratings are based on our product materials, many fixture materials will not tolerate temperatures up to 204°C (some plastics will not even withstand 120°C). Many solders may become weak or even melt well below this temperature. Precaution is advised if operating probes at very high temperatures.

## **Test Procedure**

QA Technology's current test system consists of a multichannel data acquisition system, programmable DC power supplies, a test fixture chamber shielded from room air currents and an industrial PC to provide test configuration, control and data recording. The test fixture chamber provides connection points for one or two test fixtures at a time, and it also has thermocouples installed for measuring the ambient air temperature during the test.

For our conventional probe series, FR4 test fixtures were built to mount eight probes at a time for testing. Standard 0.250 [6.35] stroke probes were stroked to 2/3 of their nominal full stroke. Long stroke 0.400 [10.16] probes were tested at 0.075 [1.91] stroke which is commonly used in dual-level fixturing. The probes were spaced 1.00 [2.54] apart to provide effective thermal isolation between individual probes. A circuit board was designed to allow all eight probes in one fixture to be connected in series. The surface of the circuit board was coated with solder to simulate typical contact conditions between the probe tip and a circuit board under test. The sockets were interconnected to complete the series current path. The wire gauge used

for interconnecting the sockets was selected according to the expected test current.

Fine gauge type T thermocouples (Copper/Copper-Nickel) were soldered to the sockets just below the bottom surface of the socket mounting plate. The fine gauge thermocouple wire minimized heat transfer from the socket and decreased the thermal response time. The thermocouples were then connected to the multi-channel data acquisition system.

In the case of QA's X Probes®, the test thermocouples were attached directly to the probe tube wall just above the tube's interconnect receptacle. The X Probe termination pins were connected in the same fashion as the sockets for conventional probes.

For testing wireless sockets and termination pins, the test fixtures were designed so that both the test probe and wireless interface probe are part of the current path. The interface board was spaced so that the plungers were compressed to the recommended stroke and a flat gold pad was used for the contact point. The gold contacts on the interface board were wired to complete the series current path and a thermocouple was soldered to the wireless interface probe tube to monitor the temperature of the interface probe assembly. In general, the current carrying capacity of the wireless sockets and termination pins were less than a standard wired socket and termination pin assembly due to the additional interface probe.

A programmable DC power supply was used to provide a constant test current through the probes and sockets or termination pin being tested. The current was programmatically incremented and the assemblies were allowed to reach a stable temperature before the readings were recorded. This process was repeated until the required temperature rise was achieved across a majority of the probes under test.

The wire gauge used for interconnecting the sockets or termination pins of the probes under test varied depending on the final current requirements for the test. Indeed, the choice of interconnect wire gauge played a significant role in determining the temperature of a particular probe during testing. A heavier gauge wire ran cooler for any given current, with the copper conductor acting as a heat sink for the probe under test.

Three sets of tests were conducted and analyzed statistically to produce a temperature vs. current curve based upon a 3-sigma rise above the average data values. The final current carrying rating for the probe was derived from this curve. Using this 3-sigma standard, 99.7% of all probes will meet the current rating.

The M035-14, M08-89, and M100-75 probes' setup utilized fixtures designed around the typical applications for these probes and consisted of two plates with the probes captured between a top and bottom plate. A small cross-channel was machined in the plates to allow room for the thermocouple wires. Two circuit boards sandwiched the top and bottom plates to route the series test current through all eight probes.

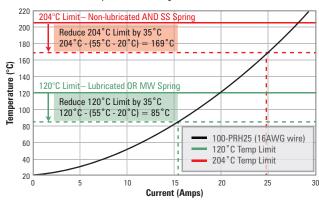
## **Application Notes**

**Probe Mounting Density** – Higher probe mounting densities decrease the probe's current carrying ability. This is due to the combined heat generated by the probes and the decrease of air circulation via natural convection. Because each application is unique, it is recommended that appropriate tests be conducted before probes are put into service in applications with high currents, high probe densities, or limited airflow.

**Probe Cooling** – These temperature measurements were made in the absence of any forced convection. Providing airflow (by means of a fan, for example) around the sockets or termination pins will reduce the temperature for a given current. Also, tests have shown that the airflow present due to leaks in a typical vacuum fixture will reduce temperature.

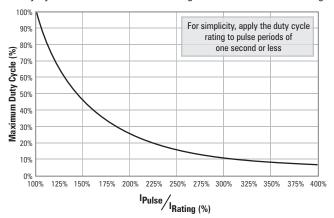
**Elevated Ambient Temperatures** – For conditions where the ambient temperature differs from the 20°C ambient of these tests, a simple graphical technique can be used to obtain a corrected current limit; shift the temperature limit line down by the same amount that the actual ambient temperature exceeds 20°C. For example, a 100-PRH25 series probe operating in an environment with an ambient temperature of 55°C will exceed 120°C at 15.4 amps and 204°C at 24.7 amps (instead of 19.8 amps and 28.3 amps respectively at 20°C ambient).

100-PRH25 Example Determining Current Limit at 55°C Ambient



**Duty Cycle for Pulsed Currents** – This data reflects performance at 100% duty cycle. Higher currents can be carried for pulses of short duration. For simplicity, apply higher currents for no longer than one second (longer pulses may be carried, but require that thermal inertia and rate of temperature gain be known). A probe's ultimate temperature is determined by the dissipated power [P=I2R], so duty cycle adjustments should be made according to the square of the current ratio. For example, a 100-PRH2509X in a 100-SDH250W is rated for 19.8 amps. If you want to run it at 35 amps, the duty cycle would need to be  $(19.8 \div 35)^2 = 0.566^2 = 0.32 = 32\%$ . So, to avoid overheating this probe at 35 amps, power must be applied for no more than 320 milliseconds (1 second x 32%). Similarly, the 187-25 Series of probes and sockets are designed for high current applications given the larger component diameters and greater internal contact surfaces areas when compared to the other series. A 187-PRS2509H probe in a 187-SDH250S socket carries a maximum continuous current of 59 amps. To carry 75 amps it would need to be run at a 62% duty cycle  $(59 \div 75)^2 = 0.619 = 62\%$ .

Duty Cycle for Pulsed Currents Exceeding the Continuous Current Rating



**Reference Point** – For comparison purposes, note that a 16 AWG, Ø 0.051 [1.30] solid copper wire close to the same diameter as a 100-25 series probe tube. Ø 0.054 [1.37] reaches 120°C at 31 amps.

CENTER SPACING	PROBE	SOCKET	WIRE SIZE	CURRENT CAPACITY @ 120°C (AMPS) <sup>1</sup>	CURRENT CAPACITY @ 204°C (AMPS) <sup>2</sup>
0.025 [0.63]	025-PRP1640S	025-SBH160C-3	30	2.7	3.7
0.039 [1.00]	039-PRP1644X-S	039-SDC165J	28	3.1	4.2
0.039 [1.00]	039-PRP2544H-S	039-SDC165J	28	3.1	4.3
0.039 [1.00]	039-PRP2544X-S	*039-SDC255DS3	28	3.8	5.3
0.039 [1.00]	039-PRP406RS-S	039-SDC165J	28	2.6	3.6
0.039 [1.00]	039-PRP406RS-S	*039-SDC255DS3	28	2.8	3.8
0.050 [1.27]	050-PLP0543S	050-SBB050C6530	26	3.7	5.2
0.050 [1.27]	050-PLP1609H	050-SBN160S	26	4.9	7.4
0.050 [1.27]	050-PLP1609H	*050-SBB162DS3	22	4.2	5.8
0.050 [1.27]	050-PTP2509Y	050-STB255C6530	26	4.5	6.2
0.050 [1.27]	050-PTP2509Y	*050-STB255DS3	22	4.5	6.5
0.050 [1.27]	050-PRP2509X	050-SRB255C6530	26	3.9	5.4
0.050 [1.27]	050-PTP4046U	050-STB255C6530	26	4.3	5.9
0.050 [1.27]	050-PTP4046U	*050-STB255DS3	22	4.4	6.4
0.050 [1.27]	050-PRP4046S	050-SRB255C6530	22	3.7	5.0
0.075 [1.91]	075-PRP2509X 075-PRG2509X	075-SDN250S	20	7.7 7.7	10.4 11.1
0.073 [1.91]	075-PRN2509X	07 3-3DN2303	20	6.1	8.5
0.075 [1.91]	075-PRP2509X	*075-SDN250DS3	20	5.4	7.6
0.075 [1.91]	075-PRP4009U 075-PRG4009U 075-PRN4009U	075-SDN250S	20	7.3 7.2 6.1	10.0 9.0 9.9
0.075 [1.91]	075-PRP4009U	*075-SDN250DS3	20	4.9	7.1
0.100 [2.54]	100-PLP0502H 100-PLN0502H	100-SDN050S	18	13.2 12.0	18.1 18.5
0.100 [2.54]	100-PLP1609U 100-PLG1609U 100-PLN1609U	100-SDN160S	16	14.0 12.0 10.0	21.0 16.5 15.5
0.100 [2.54]	100-PRP2509X 100-PRV2509X 100-PRG2509X 100-PRN2509X 100-PRH2509X	100-SDN250S 100-SDN250S 100-SDN250S 100-SDN250S 100-SDH250W	16	11.8 12.7 12.3 10.2 19.8	16.2 17.4 17.3 15.3 28.3
0.100 [2.54]	100-PRP2509X	*100-SDN250DS3	16	5.9	8.5
0.100 [2.54]	100-PRP4009U 100-PRV4009U 100-PRG4009U 100-PRN4009U 100-PRH4009U	100-SDN250S 100-SDN250S 100-SDN250S 100-SDN250S 100-SDH250W	16	10.2 12.7 12.2 8.8 15.9	14.3 17.5 17.5 13.2 22.0
0.100 [2.54]	100-PRP4009U	*100-SDN250DS3	16	6.2	9.0
0.100 [2.54]	100-PRP5043L	100-SDN250S	16	10.0	13.7

<sup>\*</sup> Wireles

<sup>&</sup>lt;sup>1</sup> 120°C temperature limit for MW springs <u>or</u> lubricated probes

<sup>&</sup>lt;sup>2</sup> 204°C temperature limit for SS springs **and** non-lubricated probes

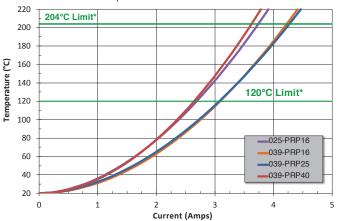
CENTER SPACING	PROBE	SOCKET	WIRE SIZE	CURRENT CAPACITY @ 120°C (AMPS) <sup>1</sup>	CURRENT CAPACITY @ 204°C (AMPS) <sup>2</sup>
0.125 [3.18]	125-PRG2509H 125-PRH2509H 125-PRN2509H 125-PRS2509H	125-SDN250S 125-SDH250S 125-SDN250S 125-SDH250S	12	16.9 30.0 13.7 32.8	23.0 41.0 18.8 48.0
0.156 [3.96]	156-PRH2509H 156-PRN2509H 156-PRS2509H	156-SDH250S	12	31 16 34	43 22 47
0.187 [4.75]	187-PRH2509H 187-PRN2509H 187-PRS2509H	187-SDH250S	10	39 24 48	55 32 59
0.031 [0.80]	X31-PRP16S44HS	X31-TR-2G	30	3.4	4.7
0.031 [0.80]	X31-PRP16S43PS	*X31-TDS3-00	30	3.7	5.1
0.031 [0.80]	X31-PRP2544H-S	X31-TG-3G	30	2.6	3.6
0.031 [0.80]	X31-PRP2544X-S	*X31-TDS3-02	30	3.2	4.4
0.031 [0.80]	X31-PRP406RS-S	X31-TG-3G	30	2.5	3.6
0.031 [0.80]	X31-PRP406RX-S	*X31-TDS3-02	30	2.9	4.0
0.039 [1.00]	X39-PRP16S44HS	X39-TR-2G	28	4.5	6.2
0.039 [1.00]	X39-PRP16B39HH	*X39-TDS3-00	28	5.5	7.6
0.039 [1.00]	X39-PRP2509Y	X39-TJ-3G	28	3.4	4.7
0.039 [1.00]	X39-PRP2509Y	*X39-TDS3-10	28	2.6	3.6
0.039 [1.00]	X39-PRP4044U	X39-TJ-3G	28	3.3	4.5
0.039 [1.00]	X39-PRP4044U	*X39-TDS3-10	28	4.2	5.9
0.050 [1.27]	X50-PRP16S44HS	X50-TR-2G	22	5.7	7.8
0.050 [1.27]	X50-PRP16B39HS	*XTDS3-00	22	7.1	9.7
0.050 [1.27]	X50-PRP2509X	X50-TJ-3G	28	5.6	7.8
0.050 [1.27]	X50-PRP2509X	*XTDS3-14	22	6.0	8.2
0.050 [1.27]	X50-PRP4009U	X50-TJ-3G	28	5.3	7.8
0.050 [1.27]	X50-PRP4009U	*XTDS3-14	22	5.9	8.2
0.075 [1.91]	X75-PRP16S44HS	X75-TR-2G	20	6.9	9.5
0.075 [1.91]	X75-PRP16B09HS	*XTDS3-00	20	7.3	10.0
0.075 [1.91]	X75-PRP2509X	X75-TWA-5G	20	8.4	12.0
0.075 [1.91]	X75-PRP2509X	*XTDS3-14	20	7.3	10.1
0.075 [1.91]	X75-PRP4009U	X75-TWA-5G	20	7.9	11.3
0.075 [1.91]	X75-PRP4009U	*XTDS3-14	20	7.3	10.2
0.35mm	M035PRH1440S-S	n/a	20	1.6	2.2
0.8mm	M08-PRG8944H	n/a	20	4.4	6.1
1.0mm	M100-DRP7563AS3	n/a	20	3.4	4.7

<sup>\*</sup> Wireless

 $<sup>^1</sup>$  120°C temperature limit for MW springs  $\underline{\textbf{or}}$  lubricated probes  $^2$  204°C temperature limit for SS springs  $\underline{\textbf{and}}$  non-lubricated probes

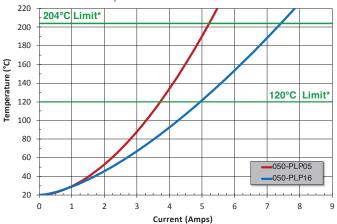
## 025-16 | 039-16 | 039-25 | 039-40 SERIES

Temperature vs. Current at 20°C Ambient



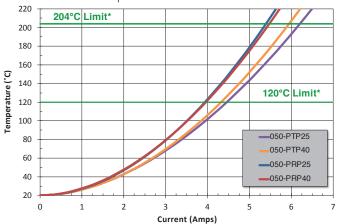
## 050-05 | 050-16 SERIES

Temperature vs. Current at 20°C Ambient



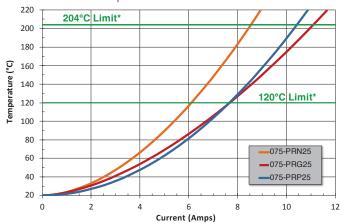
## 050-T25 | 050-T40 | 050-R25 | 050-T40 SERIES

Temperature vs. Current at 20°C Ambient



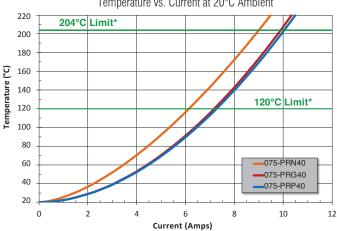
#### 075-25 SFRIFS

Temperature vs. Current at 20°C Ambient



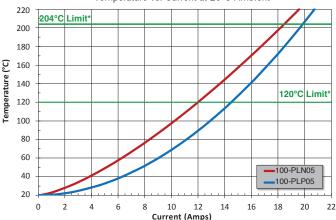
## 075-40 SERIES

Temperature vs. Current at 20°C Ambient



#### 100-05 SERIES

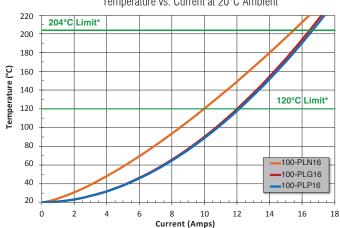
Temperature vs. Current at 20°C Ambient



\*Check product specification for temperature limitations

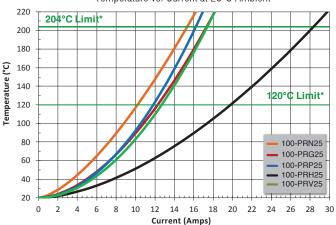
#### 100-16 SERIES

Temperature vs. Current at 20°C Ambient



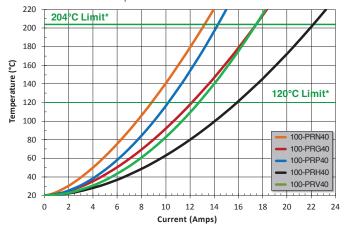
#### 100-25 SERIES

Temperature vs. Current at 20°C Ambient



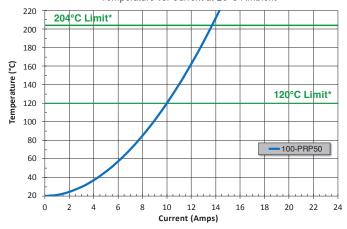
#### 100-40 SERIES

Temperature vs. Current at 20°C Ambient

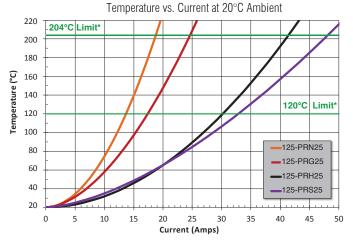


#### 100-50 SERIES

Temperature vs. Current at 20°C Ambient

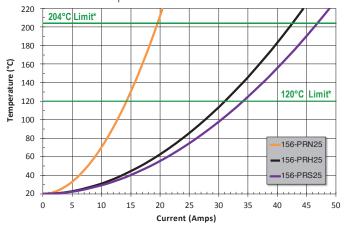


#### 125-25 SERIES



#### 156-25 SERIES

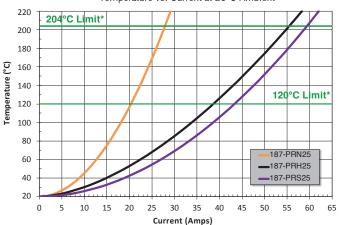
Temperature vs. Current at 20°C Ambient



<sup>\*</sup>Check product specification for temperature limitations

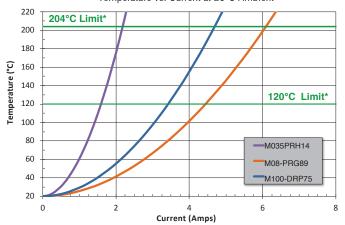
#### 187-25 SERIES

#### Temperature vs. Current at 20°C Ambient



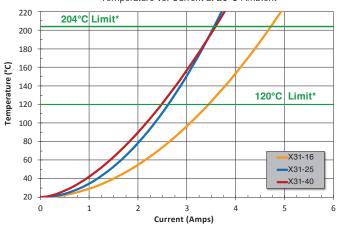
## **DOUBLE ENDED PROBES**

Temperature vs. Current at 20°C Ambient



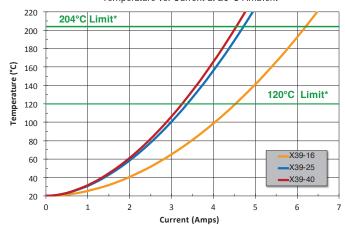
## X31-16 | X31-25 | X31-40 SERIES

Temperature vs. Current at 20°C Ambient



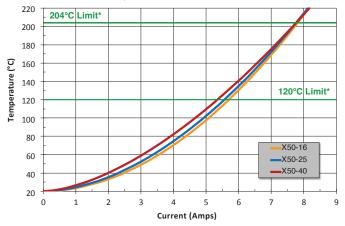
## X39-16 | X39-25 | X39-40 SERIES

Temperature vs. Current at 20°C Ambient



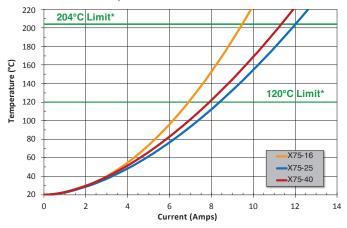
## X50-16 | X50-25 | X50-40 SERIES

Temperature vs. Current at 20°C Ambient



## X75-16 | X75-25 | X75-40 SERIES

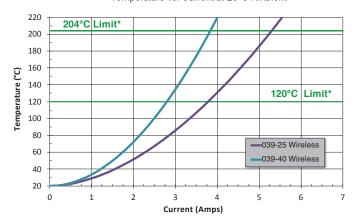
Temperature vs. Current at 20°C Ambient



<sup>\*</sup>Check product specification for temperature limitations

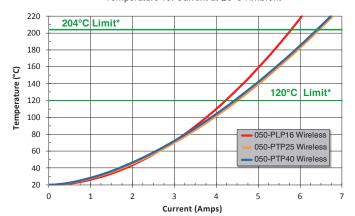
## 039-25 | 039-40 SERIES WIRELESS

Temperature vs. Current at 20°C Ambient



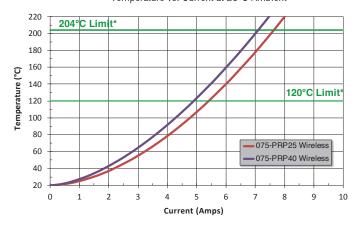
## 050-16 | 050-25 | 050-40 SERIES WIRELESS

Temperature vs. Current at 20°C Ambient



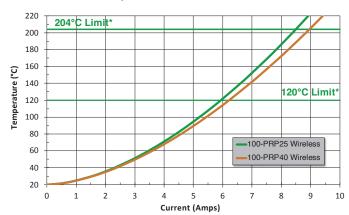
## 075-25 | 075-40 SERIES WIRELESS

Temperature vs. Current at 20°C Ambient



## 100-25 | 100-40 SERIES WIRELESS

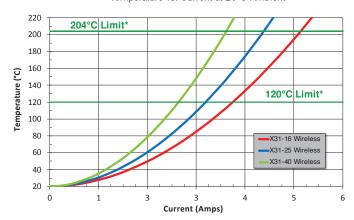
Temperature vs. Current at 20°C Ambient



\*Check product specification for temperature limitations

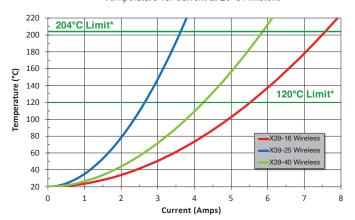
## X31-16 | X31-25 | X31-40 SERIES WIRELESS

Temperature vs. Current at 20°C Ambient



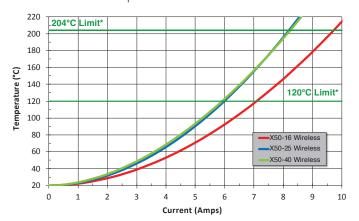
## X39-16 | X39-25 | X39-40 SERIES WIRELESS

Temperature vs. Current at 20°C Ambient



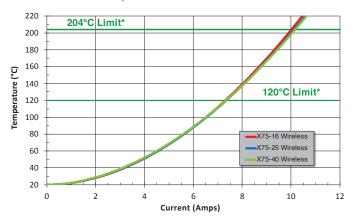
## X50-16 | X50-25 | X50-40 SERIES WIRELESS

Temperature vs. Current at 20°C Ambient



## X75-16 | X75-25 | X75-40 SERIES WIRELESS

Temperature vs. Current at 20°C Ambient



\*Check product specification for temperature limitations

# **Pointing Accuracy**

As space on printed circuit boards (PCBs) becomes increasingly limited, reliable contact of smaller test targets becomes a requirement. By improving manufacturing and assembly methods and designing for testability, false test failures can be greatly reduced.

During the electrical testing of PCBs, spring test probes contact the test targets on the Unit Under Test (UUT). These targets include but are not limited to pads, vias, leads, posts, components, and connectors. In an ideal situation, the probe tip will contact the test target every time. Unfortunately, the manufacturing tolerance stack-up which includes the board, fixture, and probes may cause the probe to miss the target.

The following information is meant to explain the variables, defines the tests, and most importantly, provides engineers and designers with the needed accuracy specifications for probe products made by QA Technology. This can be used in conjunction with tolerances from the test fixture and PCB to properly size test pads for reliable contact.

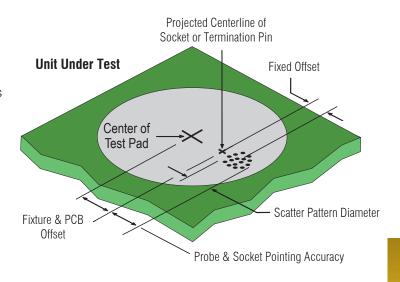
## **Definitions**

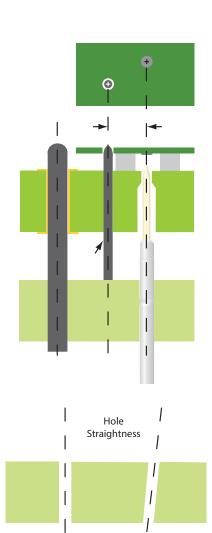
When discussing the ability of a probe to contact its intended target, the effects of standard groups of tolerances must be classified. The tolerances which affect a probe's ability to contact its target on the UUT can be broadly divided into the following groups:

Fixture and PCB Offset: This group of tolerances is controlled by the fixture builder and by the PCB manufacturer.

#### It includes:

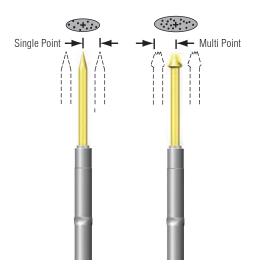
- Registration of UUT to the Fixture
- Artwork registration
- Guide plate clearance to the UUT
- Tooling pin location and straightness Socket or termination pin mounting hole tolerances (or actual position) of the drilled socket mounting holes relative to where they should be
- Tilting of the socket or termination pin in its hole – the angle of the drilled socket mounting hole in the Probe Plate





Probe and Socket Tolerances: This is a roughly circular scatter pattern where the probe tip contacts the UUT.

- Fixed Offsets
  - Socket Straightness
  - Probe to Socket Concentricity
- Scatter Pattern Diameter
  - Probe Tube Straightness
  - Plunger Straightness
  - Single vs. Multi-point Tip Style
  - Clearances within the Probe Assembly

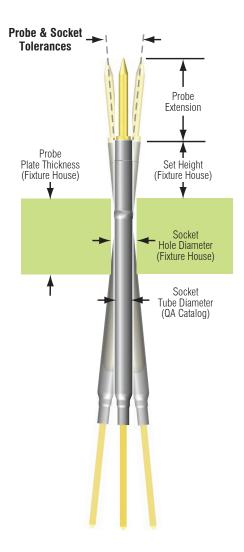


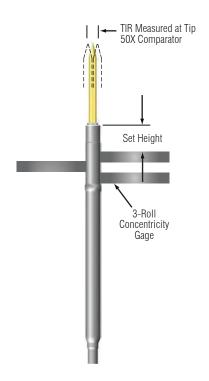
Probe and Socket Pointing Accuracy: The combined effects of the "Fixed Offsets" and one half (1/2) of the "Scatter Pattern Diameter". This is measured directly by rotating a probe and socket assembly around the socket's centerline and measuring the Total Indicator Reading (TIR) at the probes tip. Pointing Accuracy =  $\frac{1}{2}$  TIR.

## **Test Procedure**

Fifty spear point probes from each series were inserted in their appropriate sockets. Each probe and socket assembly was then mounted in a three-roll concentricity gage at a given set-height, then rotated around its axis to record the TIR.

The set height was determined by the location of the socket's press ring so that it did not interfere with the rolls on the concentricity gage during the test. The total deviation of the tip was measured with a 50X comparator to calculate the Minimum, Maximum, Average, and Standard Deviations. Note: The measurements for the X Probe® Series do not include a socket.





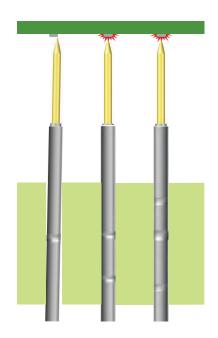
PROBE SERIES	SET HEIGHT	MINIMUM	MAXIMUM	AVERAGE	+/- 2 σ [95.44%]	+/- 3 σ [99.74%]
025-16	0.035 [0.89]	0.0003 [0.008]	0.0035 [0.089]	0.0018 [0.046]	0.0035 [0.088]	0.0043 [0.110]
039-16	0.085 [2.16]	0.0006 [0.015]	0.0037 [0.093]	0.0017 [0.043]	0.0033 [0.084]	0.0041 [0.105]
039-25	0.085 [2.16]	0.0000 [0.000]	0.0052 [0.132]	0.0019 [0.048]	0.0044 [0.112]	0.0057 [0.144]
039-40	0.085 [2.16]	0.0010 [0.024]	0.0093 [0.235]	0.0055 [0.140]	0.0095 [0.242]	0.0116 [0.293]
050-05	0.000 [0.00]	0.0001 [0.003]	0.0020 [0.051]	0.0007 [0.018]	0.0014 [0.035]	0.0017 [0.044]
050-16	0.085 [2.16]	0.0003 [0.006]	0.0022 [0.056]	0.0013 [0.033]	0.0022 [0.056]	0.0027 [0.068]
050-T25	0.085 [2.16]	0.0001 [0.003]	0.0026 [0.066]	0.0011 [0.028]	0.0024 [0.060]	0.0030 [0.076]
050-T40	0.085 [2.16]	0.0004 [0.010]	0.0068 [0.173]	0.0031 [0.079]	0.0058 [0.146]	0.0071 [0.180]
050-R25	0.085 [2.16]	0.0001 [0.003]	0.0038 [0.097]	0.0016 [0.041]	0.0034 [0.086]	0.0043 [0.108]
050-R40	0.085 [2.16]	0.0011 [0.028]	0.0074 [0.188]	0.0034 [0.086]	0.0062 [0.158]	0.0077 [0.195]
075-25	0.085 [2.16]	0.0004 [0.010]	0.0050 [0.127]	0.0023 [0.058]	0.0046 [0.118]	0.0058 [0.147]
075-40	0.085 [2.16]	0.0004 [0.010]	0.0077 [0.196]	0.0034 [0.086]	0.0069 [0.176]	0.0087 [0.221]
100-16	0.065 [1.65]	0.0001 [0.003]	0.0036 [0.091]	0.0014 [0.036]	0.0031 [0.079]	0.0039 [0.100]
100-24	0.085 [2.16]	0.0001 [0.003]	0.0035 [0.089]	0.0020 [0.051]	0.0039 [0.099]	0.0049 [0.123]
100-25	0.085 [2.16]	0.0002 [0.005]	0.0055 [0.140]	0.0023 [0.058]	0.0045 [0.114]	0.0056 [0.143]
100-40	0.085 [2.16]	0.0001 [0.003]	0.0076 [0.193]	0.0029 [0.074]	0.0065 [0.165]	0.0083 [0.211]
125-25	0.085 [2.16]	0.0004 [0.010]	0.0057 [0.145]	0.0031 [0.079]	0.0059 [0.149]	0.0073 [0.185]
156-25	0.100 [2.54]	0.0010 [0.025]	0.0056 [0.142]	0.0034 [0.086]	0.0059 [0.149]	0.0071 [0.180]
187-25	0.100 [2.54]	0.0014 [0.036]	0.0068 [0.173]	0.0043 [0.109]	0.0067 [0.171]	0.0080 [0.202]
X31-16	0.215 [5.46]	0.0007 [0.018]	0.0037 [0.094]	0.0020 [0.051]	0.0021 [0.052]	0.0027 [0.069]
X31-25	0.085 [2.16]	0.0007 [0.018]	0.0034 [0.085]	0.0018 [0.046]	0.0032 [0.081]	0.0039 [0.098]
X31-40	0.085 [2.16]	0.0010 [0.025]	0.0075 [0.189]	0.0036 [0.090]	0.0066 [0.167]	0.0081 [0.206]
X39-16	0.215 [5.46]	0.0001 [0.003]	0.0037 [0.094]	0.0017 [0.043]	0.0016 [0.042]	0.0024 [0.062]
X39-25	0.085 [2.16]	0.0001 [0.003]	0.0027 [0.069]	0.0012 [0.030]	0.0023 [0.059]	0.0029 [0.074]
X39-40	0.085 [2.16]	0.0002 [0.006]	0.0052 [0.133]	0.0024 [0.061]	0.0047 [0.119]	0.0058 [0.148]
X50-16	0.215 [5.46]	0.0001 [0.003]	0.0033 [0.084]	0.0014 [0.036]	0.0016 [0.041]	0.0024 [0.060]
X50-25	0.085 [2.16]	0.0001 [0.003]	0.0033 [0.084]	0.0015 [0.038]	0.0031 [0.078]	0.0039 [0.098]
X50-40	0.085 [2.16]	0.0001 [0.003]	0.0059 [0.150]	0.0031 [0.079]	0.0059 [0.150]	0.0073 [0.186]
X75-16	0.215 [5.46]	0.0003 [0.008]	0.0022 [0.056]	0.0012 [0.030]	0.0013 [0.033]	0.0018 [0.046]
X75-25	0.085 [2.16]	0.0001 [0.003]	0.0040 [0.102]	0.0019 [0.048]	0.0038 [0.098]	0.0048 [0.122]
X75-40	0.085 [2.16]	0.0003 [0.008]	0.0059 [0.149]	0.0024 [0.061]	0.0053 [0.134]	0.0067 [0.170]

All dimensions in inches [mm]

The table summarizes the overall pointing accuracy for each series. The X Probe® series will have better pointing accuracy as it does not utilize a socket. To get a better statistical representation of the data, the standard deviation can be added to the average or mean to show how a population of probes from the same series will respond. These numbers are a more useful average. They give designers a higher confidence level that they will be able to meet design for test (DFT) objectives.

The probe accuracy specifications listed above can be used together with fixture and PCB tolerances to accurately size the smallest test pad necessary for reliable contact.

To improve a probe's TIR in a fixture, use multiple press ring sockets. This feature is offered in our smaller sizes to reduce tilting in the mounting hole. Triple press ring sockets are an exclusive from QA to meet the increased pointing accuracy demands of the ATE industry.



## **Consequences of Improper Alignment**

The goal for the end user is a fixture/PCB that delivers high first pass yields. Ensuring that the fixture is aligned, and the sockets and probes are selected and installed properly, will lead to a longer life because of the reduction of sideloading in the finished assembly.

All of the above characteristics of pointing accuracy should be considered when designing and building a fixture to achieve optimal probe performance and cycle life. Otherwise, probe tips may miss the intended target or contact off center causing sideloading which increases probe wear.

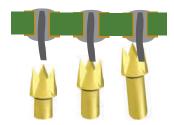


Examples that cause extreme sideloading:

- Improper socket installation in a straight hole
- Hole not drilled straight
- Mis-aligned guide plate
- Improper tip selection to the target

Extreme contact angles create higher internal friction. In the case of a crown point contacting a straight component lead, the lead can fit in the downward sloping valley between the points of the crown and create large sideloads. The plunger will deflect sideways, sometimes to the point where the lead will glance off the side of the head. But before the plunger is pushed sideways enough to break, "test point on" the PCB contacts the probe tip and the plunger is compressed. The compressing of the plunger in this

state causes an increase in friction between the sliding surfaces of the probe tube and plunger resulting in the increase of wear in the probe assembly. While a probe in this condition may operate as designed for the life of the test fixture, high cycle production test environments may experience shorter probe life requiring an increase in fixture maintenance.



## **Summary**

Addressing the factors in the early stages of design will lead to the best possible fixture and probe performance.

The use of Printed Circuit Boards is an important part of our daily lives that is often taken for granted. Designers and manufacturers of PCB's understand the importance of ensuring that the PCB design, manufacturing, and assembly of these boards meets the highest standards to guarantee a long life and reliable operation. While the factors discussed are only a small part of the overall success of a PCB test system, taking them into consideration and utilizing the design data for the construction of test fixtures will provide long term dividends for our customers. QA's recommendations for initial board design and for subsequent test procedure will enable appropriate adherence to best practice probe accuracy specifications while increasing cost efficiency, manufacturing quality, performance, accuracy, and testing of PCB products.

# Frequency Response of **Wireless Probing**

Getting a clean and accurate signal from the tester electronics to the board under test is critical for highspeed testing. Fixture wiring can be a major contributor of distortion and noise in the signal transmission path. To better understand the possibilities of wireless fixturing, QA Technology examined the high frequency performance of wireless socket and termination pins and probes.

QA used a network analyzer to measure the frequency response characteristics of a wide variety of probe configurations. Initial testing of the wireless sockets utilized an RF network analyzer covering the frequency range of 300 KHz to 3 GHz. Subsequent testing using a microwave network analyzer covered the frequency

range of 50 MHz to 20 GHz. For consistency, graphs of the more recent tests extrapolate data below 50 MHz and omit data above 10 GHz. QA used a TDR oscilloscope to look at the impedance of the signal path through the test fixture and obtained time domain impedance information by use of the time domain transform option of the microwave network analyzer.

#### **Test Procedure**

Test fixtures were constructed for 100, 75, 50, and 39mil wireless socket products. These fixtures comprised a 0.250 [6.35] G10 socket mounting plate, a 0.062 [1.57] G10 socket spacer plate, and two electrical interface boards attached to the socket mounting plate with non-conducting standoffs. Test fixtures for the X75, X50, X39, and X31wireless termination pins were built up from multiple G10 plates totaling 1.562 [39.67] and sandwiched between two electrical interface boards. In all the fixtures, the electrical interface boards provided the SMA connectors for the test equipment and copper traces to contact the various probe/socket configurations. Configurations comprised different center spacing for the ground and signal probes, multiple ground probes, and arrangements to measure cross-talk where one pair of probes was "driven" and the "pick up" on an adjacent pair measured.

### Results

The following graphs study the performance of the X75 probes. Comparable data for all other wireless assemblies follow.

Figure 1 shows the frequency response of two X75 probes on 1.00 [25.4] centers. This might be representative of the signal probe to ground probe separation for an IC package. Note the bandwidth roll-off below 100 MHz. This response is dominated by the separation between the signal and ground probe. Plots for the other wireless probe families tested on 1.00 [25.4] centers have very similar performance. In Figure 2, the probes are on their nominal 0.075 [1.91] centers. On these closer centers, a -1dB frequency response to over 400 MHz is achieved. This improvement is the result of the more closely-spaced probes providing a better match to the impedance of the 50 Ohm test environment.

The TDR option of the microwave network analyzer allows measurement of the impedance of a transmission line at any point along its length. Figure 3 shows the impedance of two wireless 0.075 [1.91] QA X Probes® on 0.075 [1.91] centers. In this TDR graph, the transmitted signal has an effective rise time of 50 picoseconds. which equates to a 7 GHz test frequency. The impedance extremes are exaggerated by the high

## X75-25 SERIES | 1.00 [25.4] CENTERS

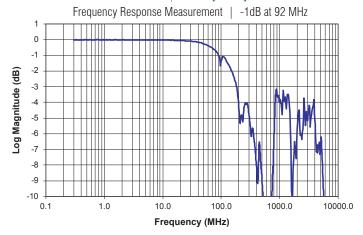


Figure 1: Frequency response of two 0.075 [1.91] wireless X Probes (signal and ground) on 1.00 [25.4] centers.

# X75-25 SERIES | 0.075 [1.91] CENTERS



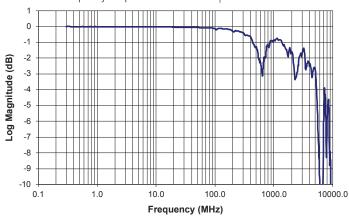


Figure 2: Frequency response of two 0.075 [1.91] wireless X Probes (signal and ground) on 0.075 [1.91] centers.

## X75-25 SERIES | 0.075 [1.91] CENTERS

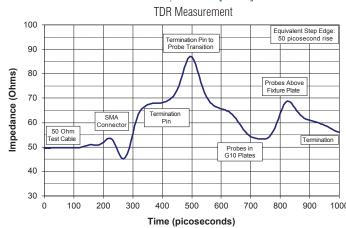


Figure 3: Impedance of the transmission line created by two 0.075 [1.91] wireless X Probes (signal and ground) on 0.075 [1.91] centers. Note: the 50 picosecond equivalent rise time equates to an effective test frequency of 7 GHz.

bandwidth of the measurement; at lower frequencies the impedance differences would be less apparent. These high frequency measurements show three distinct physical regions: the termination pin, the transition from the termination pin to the X Probe, and the X Probe itself. These changes of impedance are caused by the differing diameters of the termination pins and probes as well as the drilled clearances surrounding them. The nature of the dielectric material separating the probes also plays a critical role in determining the characteristic impedance of the transmission line.

Figure 4 shows the performance of a three-probe in-line configuration on 0.075 [1.91] centers with the signal probe placed between two grounds. Although this configuration may not always be practical, its -1dB performance to greater than 1400 MHz is excellent. Figure 5 shows the corresponding TDR plot for the same three-probe configuration.

Crosstalk in a conventional fixture is a complex function of many variables: the characteristics of the test signals, the length and type of wiring used, how the wiring is (or isn't) dressed, and the relative locations of the probes themselves.

Wiring problems are the reason for the existence of wireless probing solutions. Replacing fixture wiring with a translator board provides a more repeatable and controllable environment for routing test signals between the unit under test (UUT) and the test electronics.

The test signals and probe locations are driven by the needs of the UUT. For reference purposes, a plot of the crosstalk between two pairs of 0.075 [1.91] wireless X Probes on 0.075 [1.91] centers is shown in Figure 6.

#### **Conclusions**

A wireless probing solution can deliver excellent high frequency performance. Signal-to-ground probe spacing and the dielectric material separating the probes both play a major role in determining the impedance and the bandwidth of the transmission path. In general, a more constant probe diameter and consistent dielectric material separating the probes makes for fewer impedance changes in the signal path and better overall high frequency performance.

Replacing fixture wiring with a translator board allows the test engineer greater control of length and impedance characteristics of the signal path to the unit under test. This produces cleaner, distortion-free test signals and higher performance testing.

## X75-25 SERIES | 0.075 [1.91] X 3

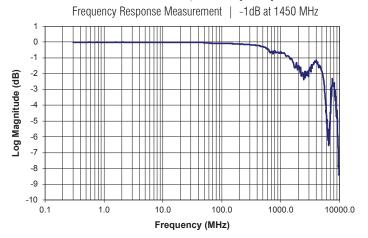


Figure 4: For a three-probe configuration (signal between two grounds) excellent performance to more than 1400MHz was achieved.

## X75-25 SERIES | 0.075 [1.91] X 3

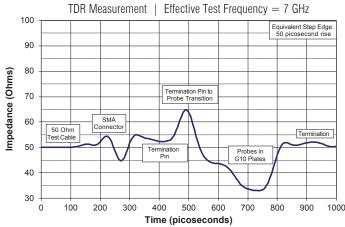


Figure 5: The TDR plot for the three-probe configuration shows a better match to the 50 Ohm test environment. This results in a higher bandwidth frequency response.

## X75-25 SERIES | 0.075 [1.91] CENTERS

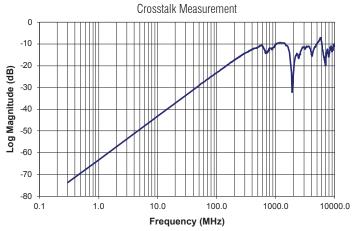
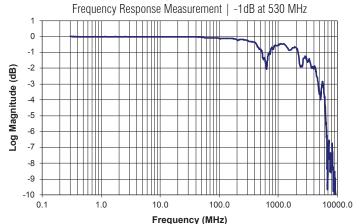
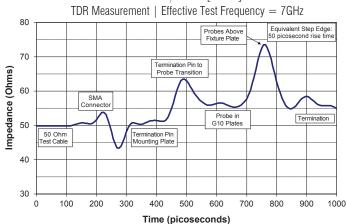


Figure 6: Crosstalk between two pairs of X75 probes on a 0.075 [1.91] grid.

## X50-25 SERIES | 0.050 [1.27] CENTERS

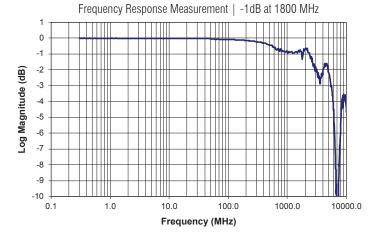


## X50-25 SERIES | 050 [1.27] CENTERS

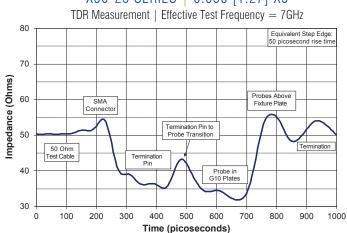


Two X50 wireless probes (signal and ground) on 0.050 [1.27] centers.

## X50-25 SERIES | 0.050 [1.27] X3

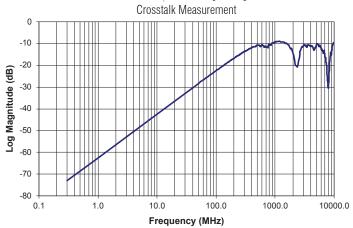


## X50-25 SERIES | 0.050 [1.27] X3



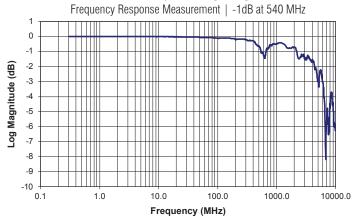
Three X50 wireless probes (ground-signal-ground) on 0.050 [1.27] centers.

## X50-25 SERIES | 0.050 [1.27] CENTERS

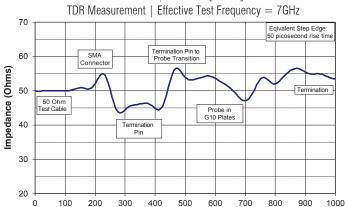


Cross talk for two pairs of X50 wireless probes on a 0.050 [1.27] grid.

## X39-25 SERIES | 0.039 [1.00] CENTERS

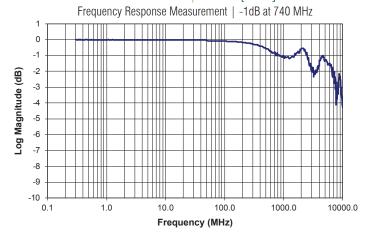


## X39-25 SERIES | 0.039 [1.00] CENTERS



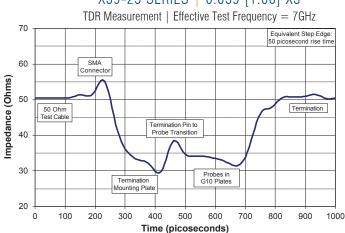
Two X39 wireless probes (signal and ground) on 0.039 [1.00] centers.

## X39-25 SERIES | 0.039 [1.00] X3



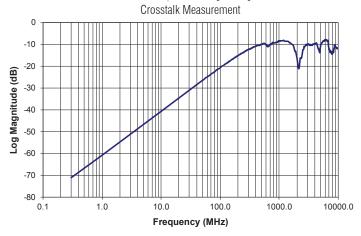
## X39-25 SERIES | 0.039 [1.00] X3

Time (picoseconds)



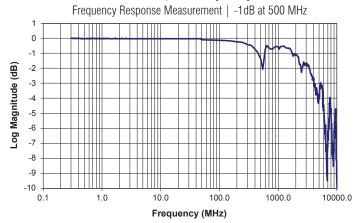
Three X39 wireless probes (ground-signal-ground) on 0.039 [1.00] centers.

## X39-25 SERIES | 0.039 [1.00] CENTERS

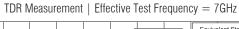


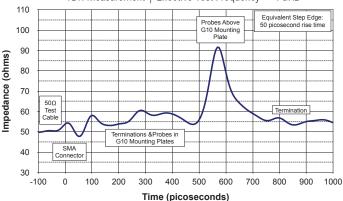
Crosstalk for two pairs of X39 wireless probes on a 0.039 [1.00] grid.

## X31-25 SERIES | 0.031 [0.80] CENTERS



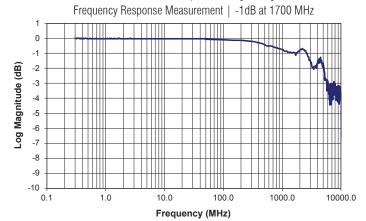
## X31-25 SERIES | 0.031 [0.80] CENTERS



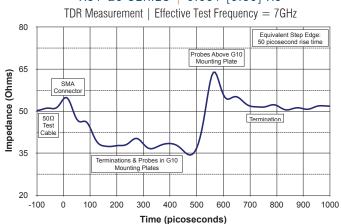


Two X31 wireless probes (signal and ground) on 0.031 [0.80] centers.

## X31-25 SERIES | 0.031 [0.80] X3



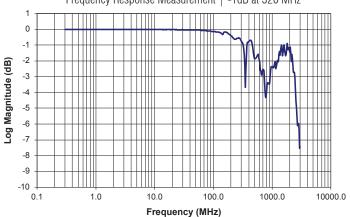
## X31-25 SERIES | 0.031 [0.80] X3



Three X31 wireless probes (ground-signal-ground) on 0.031 [0.80] centers.

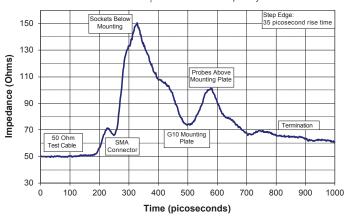
## 100-25 SERIES | 0.100 [2.54]

### Frequency Response Measurement | -1dB at 320 MHz



## 100-25 SERIES | 0.100 [2.54]

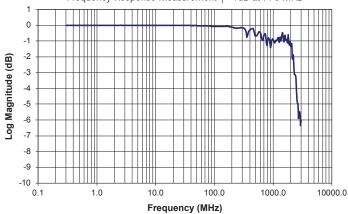
TDR Measurement | Effective Test Frequency = 10GHz



Two 100-25 Series wireless socket assemblies (signal and ground) on 0.100 [2.54] centers.

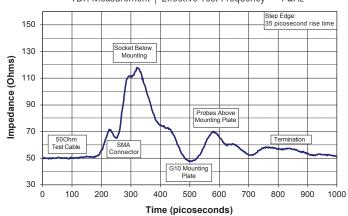
## 100-25 SERIES | 0.100 [2.54] X3

Frequency Response Measurement | -1dB at 770 MHz



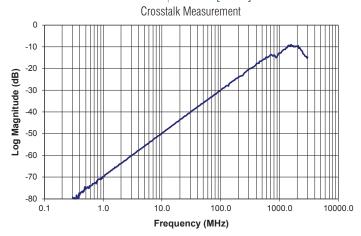
## 100-25 SERIES | 0.100 [2.54] X3

TDR Measurement | Effective Test Frequency = 7GHz



Three 100-25 Series wireless socket assemblies (ground-signal-ground) on 0.100 [2.54] centers.

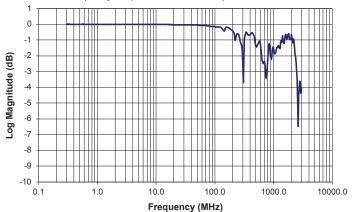
## 100-25 SERIES | 0.100 [2.54] CENTERS



Crosstalk for two pairs of 100-25 Series wireless socket assemblies on a 0.100 [2.54] grid.

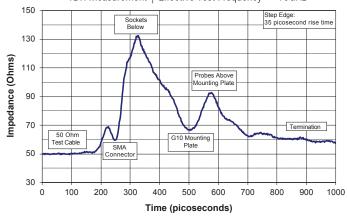
## 075-25 SERIES | 0.075 [1.91] CENTERS

Frequency Response Measurement | -1dB at 220 MHz



## 075-25 SERIES | 0.075 [1.91] CENTERS

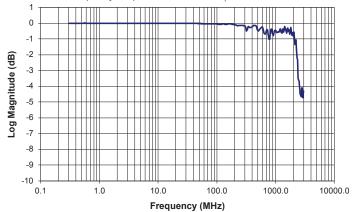
TDR Measurement | Effective Test Frequency = 10GHz



Two 075-25 Series wireless socket assemblies (signal and ground) on 0.075 [1.91] centers.

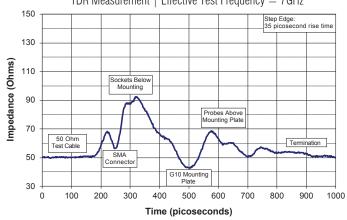
## 075-25 SERIES | 0.075 [1.91] X3

Frequency Response Measurement | -1dB at 770 MHz



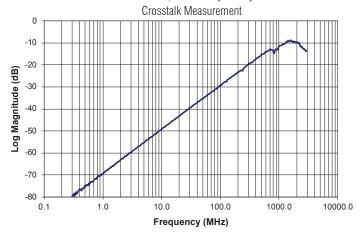
## 075-25 SERIES | 0.075 [1.91] X3

TDR Measurement | Effective Test Frequency = 7GHz



Three 075-25 Series wireless socket assemblies (ground-signal-ground) on 0.075 [1.91] centers.

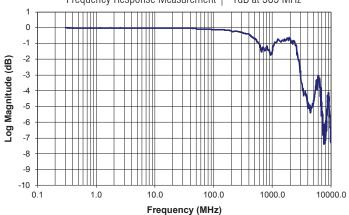
## 075-25 SERIES | 0.075 [1.91] CENTERS



Crosstalk for two pairs of 075-25 Series wireless socket assemblies on a 0.075 [1.91] grid.

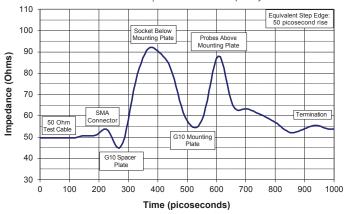
## 050-25 SERIES | 0.050 [1.27] CENTERS

# Frequency Response Measurement | -1dB at 585 MHz



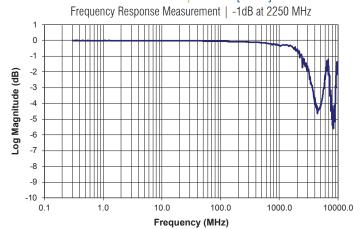
## 050-25 SERIES | 0.050 [1.27] CENTERS

TDR Measurement | Effective Test Frequency = 7GHz

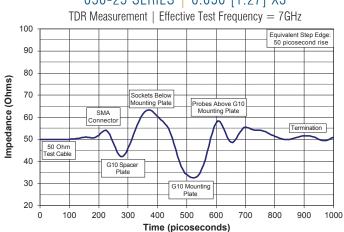


Two 050-25 Series wireless socket assemblies (signal and ground) on 0.050 [1.27] centers.

## 050-25 SERIES | 0.050 [1.27] X3

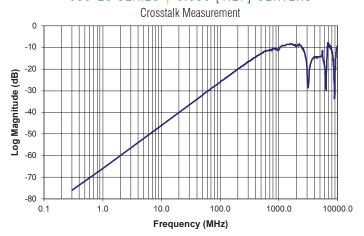


## 050-25 SERIES | 0.050 [1.27] X3



Three 050-25 wireless socket assemblies (ground-signal-ground) on 0.050 [1.27] centers.

## 050-25 SERIES | 0.050 [1.27] CENTERS



Crosstalk for two pairs of 050-25 wireless socket assemblies on a 0.050 [1.27] grid.

#### 050-16 Series Wireless

1.0

0

-1

-2

-3

-4

-5

-6

-7

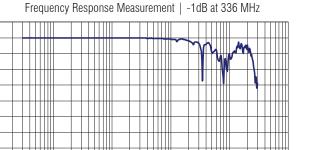
-8

-9 -10

0.1

Log Magnitude (dB)

## 050-16 SERIES | 0.050 [1.27] CENTERS

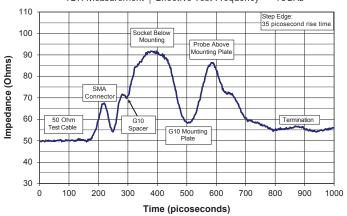


100.0

1000.0

## 050-16 SERIES | 0.050 [1.27] CENTERS

TDR Measurement | Effective Test Frequency = 10GHz



Two 050-16 wireless socket assemblies (signal and ground) on 0.050 [1.27] centers.

10000.0

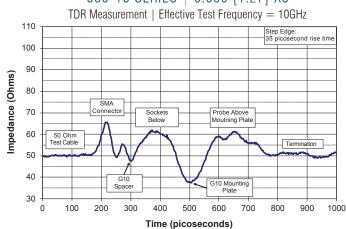
## 050-16 SERIES | 0.050 [1.27] X3

Frequency (MHz)

10.0

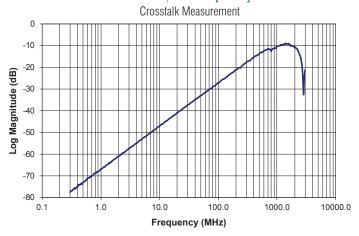
Frequency Response Measurement | -1dB at 2495 MHz 0 -1 -2 Log Magnitude (dB) -3 -4 -5 -6 -7 -8 -9 -10 1.0 10.0 100.0 1000.0 10000.0 0.1 Frequency (MHz)

## 050-16 SERIES | 0.050 [1.27] X3



Three 050-16 wireless socket assemblies (ground-signal-ground) on 0.050 [1.27] centers.

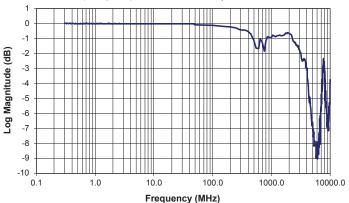
#### 050-16 SERIES | 0.050 [1.27] CENTERS



Crosstalk for two pairs of 050-16 wireless socket assemblies on a 0.050 [1.27] grid.

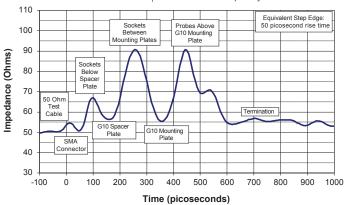
## 039-25 SERIES | 0.039 [1.00] CENTERS

Frequency Response Measurement | -1dB at 500 MHz



## 039-25 SERIES | 0.039 [1.00] CENTERS

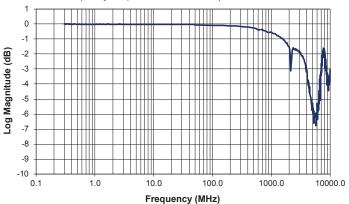
TDR Measurement | Effective Test Frequency = 7GHz



Two 039-25 wireless socket assemblies (signal and ground) on 0.039 [1.00] centers.

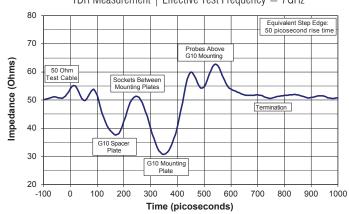
## 039-25 SERIES | 0.039 [1.00] X3

Frequency Response Measurement | -1dB at 1600 MHz



## 039-25 SERIES | 0.039 [1.00] X3

TDR Measurement | Effective Test Frequency = 7GHz



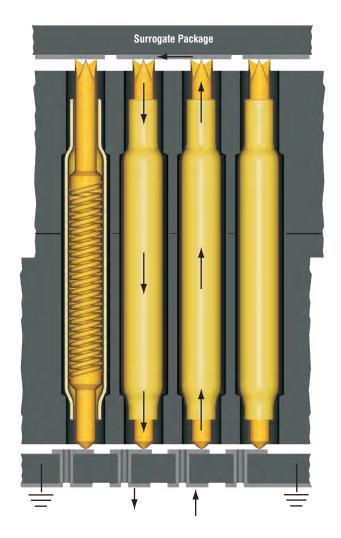
Three 039-25 wireless socket assemblies (ground-signal-ground) on 0.039 [1.00] centers.

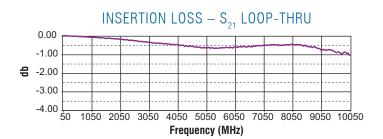
# **High Frequency Performance** for M08-89 Series

The high frequency performance of an IC test contactor is very important in high-speed test applications. QA Technology has conducted high frequency measurements on a surrogate IC test contactor populated with our M08-PRG89 probes. QA used a microwave network analyzer and custom test fixturing to test the contactor in numerous configurations.

For the loop-thru measurement, the test signal travels through the test board via and the first probe to the surrogate package. The isolated trace on the surrogate package couples the signal to the adjacent probe where it is returned back through the second test board via. All the probes surrounding the two signal carrying probes are grounded.

The loop-thru signal path described achieved a -1 db bandwidth of 10GHz, as seen in the Insertion Loss graphs.





Bandwidth: -1 db @ 10.0 GHz Self Inductance: 1.13 nH

# **Mounting Hole Specifications** and Suggestions

## **Hole Specifications**

QA Technology recommends hole sizes as shown in the charts below. Suggested drill sizes are for reference only and were derived using AT7000 epoxy glass fixture

plate material. Factors such as material, drill tolerances, wear, and machining parameters will affect the final hole size. Each combination should be tested and verified for the application. Use QA pin gauge tools to verify proper hole sizes. Undersized holes could damage sockets, terminations, and installation tools. Oversized holes could result in loose sockets and terminations that would allow the part to move in the mounting plate during testing.

#### CONVENTIONAL

SERIES	FIXTURE PLATES	SUGGESTED HOLE SIZES	SUGGESTED DRILL SIZE	PIN GAUGE TOOL P/N
025-16		0.0205/0.0215 [0.521/0.546]	#75 or 0.55 mm	PG25
039-16 039-25 039-40		0.0307/0.0317 [0.780/0.805]	0.8 mm or #67	PG39
050-05 050-16		0.0368/0.0378 [0.935/0.960]	0.95 mm or #62	PG050-05/16
050-T25 050-T40 050-R25 050-R40		0.0380/0.0390 [0.965/0.991]	1.00 mm	PG050-25
075-25 075-40	Probe Plate	0.0530/0.0550 [1.346/1.397]	#54 or 1.40 mm	PG75
100-05 100-16 100-25 100-40 100-50		0.0670/0.0690 [1.702/1.753]	1.75 mm	PG100
125-25		0.0940/0.0960 [2.390/2.440]	2.40 mm or #41	PG125
156-25		0.108/0.110 [2.74/2.79]	7/64" or 2.80 mm	PG156
187-25		0.141/0.143 [3.58/3.63]	3.60 mm	PG187

#### X PROBE® SOCKETLESS

SERIES	FIXTURE PLATES	SUGGESTED HOLE SIZES	SUGGESTED DRILL SIZE	PIN GAUGE TOOL P/N
X31-16	Probe Plate	0.0250/0.0260 [0.635/0.660]	#71 or 0.65 mm	PG-X31-P
X31-25	Optional Spacer Plate	0.027 [0.686] min	0.70 mm or #70	
X31-40	Back Plate	0.0217/0.0225 [0.551/0.572]	#74 or 0.58 mm	PG-X31-T
X39-16	Probe Plate	0.0315/0.0325 [0.800/0.826]	#66 or 0.84 mm	PG-X39
X39-25	Optional Spacer Plate	0.034 [0.860] min	#65 or 0.90 mm	
X39-40	Back Plate	0.0315/0.0325 [0.800/0.826]	#66 or 0.84 mm	PG-X39
X50-16	Probe Plate	0.0415/0.0430 [1.054/1.092]	#57 or 1.10 mm	PG-X50-P
X50-25	Optional Spacer Plate	0.045 [1.14] min	1.15 mm or #56	
X50-40	Back Plate	0.038/0.039 [0.965/0.990]	#61 or 1.00 mm	PG-X50-T
	Probe Plate	0.0545/0.0560 [1.384/1.422]	#54 or 1.40 mm	PG-X75A-P
X75-16	Optional Spacer Plate	0.0625 [1.59] min	1/16 or 1.60 mm	
X75-25 — X75-40	Wired Back Plate	0.0515/0.0525 [1.308/1.333]	#55 or 1.35 mm	PG-X75A-T
7.1.0	Wireless Back Plate	0.0380/0.039 [0.965/0.990]	#61 or 1.00 mm	PG-X50-T

## **Minimum Center Spacing**

The following charts detail the minimum recommended center-to-center spacing for QA's conventional sockets and X Probe termination pins.

Note: headed probes may require larger spacing depending on their diameter.

#### CONVENTIONAL

CENTERS	0.039 [1.00]	0.050 [1.27]	0.075 [1.91]	0.100 [2.54]	0.125 [3.18]	0.156 [3.96]	0.187 [4.75]
0.039 [1.00]	0.039 [1.00]	0.043 [1.09]	0.052 [1.32]	0.060 [1.53]	0.071 [1.80]	0.078 [1.98]	0.095 [2.41]
0.050 [1.27]	0.043 [1.09]	0.048 [1.22]	0.057 [1.45]	0.064 [1.63]	0.077 [1.96]	0.084 [2.13]	0.101 [2.57]
0.075 [1.91]	0.052 [1.32]	0.057 [1.45]	0.068 [1.73]	0.075 [1.91]	0.087 [2.21]	0.094 [2.39]	0.111 [2.82]
0.100 [2.54]	0.060 [1.53]	0.064 [1.63]	0.075 [1.91]	0.085 [2.16]	0.098 [2.49]	0.105 [2.67]	0.122 [3.10]
0.125 [3.18]	0.071 [1.80]	0.077 [1.96]	0.087 [2.21]	0.098 [2.49]	0.111 [2.82]	0.118 [3.00]	0.135 [3.43]
0.156 [3.96]	0.078 [1.98]	0.084 [2.13]	0.094 [2.39]	0.105 [2.67]	0.118 [3.00]	0.133 [3.38]	0.150 [3.81]
0.187 [4.75]	0.095 [2.41]	0.101 [2.57]	0.111 [2.82]	0.122 [3.10]	0.135 [3.43]	0.150 [3.81]	0.166 [4.21]

#### X PROBE SOCKETLESS

CENTERS	X31 [0.80]	X39 [1.00]	X50 [1.27]	X75 [1.91]
X31 [0.80]	0.030 [0.76]	0.035 [0.89]	0.040 [1.02]	0.046 [1.17]
X39 [1.00]	0.035 [0.89]	0.038 [0.97]	0.043 [1.09]	0.052 [1.32]
X50 [1.27]	0.040 [1.02]	0.043 [1.09]	0.048 [1.22]	0.057 [1.45]
X75 [1.91]	0.046 [1.17]	0.052 [1.32]	0.057 [1.45]	0.068 [1.73]

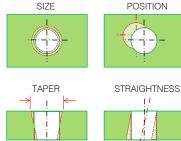
## **Drilling Suggestions**

Producing fixture plates with accurate hole sizes, positions, and straightness will improve the installation, wiring, and accuracy of sockets and termination pins.

QA recommends several drill bit types to achieve optimal holes.

- Center or spot drill
- Carbide circuit board drill
- Extended flute carbide drill
- High speed steel drill





#### STEP 1

Use a short, rigid center or spot drill to locate the center of the hole, to break through the plate surface, and to leave a small divot starting a point for subsequent drilling operations.







#### STEP 2

Use a standard carbide circuit board drill to finish the hole. Use an extended flute drill for thicker plates. For small holes, peck drilling achieves straighter more accurate hole diameters.





### **STEP 3 (WHEN REQUIRED)**

Use a conventional high-speed steel drill bit to finish the hole for engineering change orders (ECOs) or when plates cannot be taken apart after steps 1 and 2. This drill type has a long flute length to accommodate a thicker stack up of plates.







#### STEP 4

Test to determine if the hole is sized correctly by using a pin gauge tool or GO/NO-GO gauges. Verify hole sizes with both sides of the gauge to ensure the hole falls within the correct tolerance. The GO (green) end of the gauge should go into the hole. If it does not, the hole is undersized and must be resized. The NO-GO (red) end of the gauge should not enter the hole. If it enters, the hole is oversized, and the plate may need to be re-drilled.

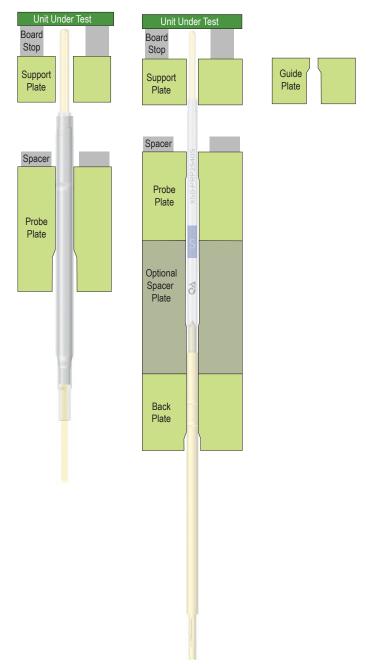


#### **ADDITIONAL CONSIDERATIONS**

With thick mounting plates, drill optional stepped holes or use multiple thinner plates to improve hole straightness. Position the properly sized hole on the critical surface and a larger clearance hole on the non-critical surface.

With X Probe fixtures, the bottom of the spacer plate is critical. It helps guide the end of the probe tube/interconnect housing onto the termination pin during installation and replacement.

When using guide plates, it is necessary to back drill the bottom to make it easier to align the probe tips during installation. This provides added clearance for the probe and socket tubes when the guide plate is actuated.

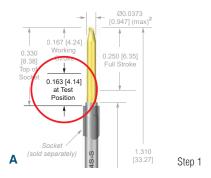


# **Calculating Socket Set Heights**

The socket set height is the distance from the top of the probe plate to the top of the socket. Probe performance and longevity are maximized when sockets are installed to the correct set height. When set too low, the probe is under-stroked, reducing the contact force and the probe's ability to penetrate surface contaminants. When set too high, the probe is over-stroked, which may cause reduced spring life, risk damage to the unit under test (UUT) or incur tip damage due to bottoming. To calculate proper set height, follow these steps:

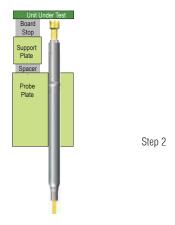
#### STEP 1

Retrieve dimension (A) "at Test Position" from the product series page from our catalog or website. This is simply the distance from the tip of the probe of an unactuated plunger to the top of the socket, minus the working/test stroke. It is important to note that these dimensions may vary from series to series so a separate calculation must be made for each probe series used in the fixture.



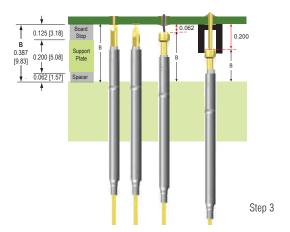
#### STEP 2

Make a cross-sectional sketch of your fixture in the actuated/test position, including board stops, support plates, spacers, etc. This sketch illustrates one example of a typical fixture.



#### STEP 3

Add the thickness of the items that stack up between the top surface of the probe plate and the contact surface of the UUT to get dimension **(B)**. If contacting leads, posts, or components, subtract the average length of these to adjust dimension (B).



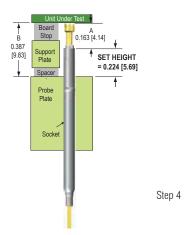
#### STEP 4

Subtract the at test position dimension (A) from total stack up dimension (B).

Example for 100-25 Series:

0.387 [9.83] (B) - 0.163 [4.14] (A)

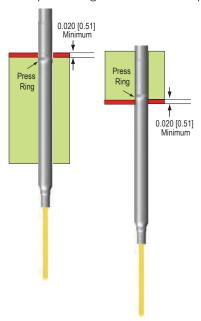
= 0.224 [5.08] set height



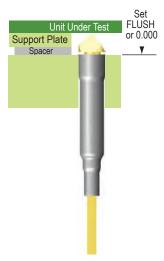
You can now use this set height dimension to install your sockets with our ATR adjustable or ITR preset installation tools.

#### **ADDITIONAL CONSIDERATIONS**

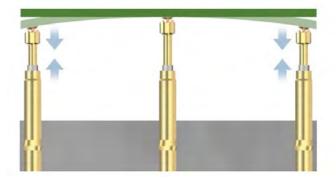
To account for irregularities in the mounting hole, QA recommends a margin of at least 0.020 [0.51] between the press ring and the closest plate surface.



100-05, 050-05, and 025-16 series sockets are all mounted flush (set height is zero).



Users should consider board flexing and bowing as they calculate socket set heights. Be sure that all probes are stroked to at least their working stroke.



#### **Notes**

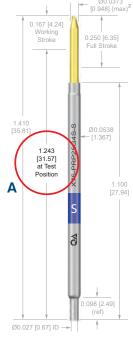
- When the 050-25 and 050-40 Series are used in dual level testing applications, the 050-25 Series socket must be set 0.015 [0.38] higher to achieve the probe's designed 0.150 [3.81] tip height difference when the fixture is in the unactuated state.
- Some tip styles will require an adjusted "at Test Position" dimension. If your chosen tip style has stroke limitations, a new "at Test Position" dimension should be determined before proceeding with a set height calculation.

# Calculating QA X Probe® **Termination Set Heights**

For QA's X Probe® fixtures, the termination pin set height is the distance from the top of the back plate to the shoulder of the termination pin. Probe performance and longevity are maximized when the termination pins are installed to the correct set height. When set too low, the probe is under-stroked, reducing the contact force and the probe's ability to penetrate surface contaminants. When set too high, the probe is over-stroked, which may cause reduced spring life, risk damage to the unit under test (UUT) or incur tip damage due to bottoming. To calculate the proper set height, follow these steps:

## STEP 1

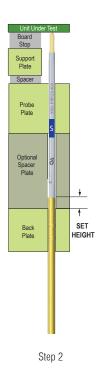
Retrieve dimension (A), the "at Test position" from the product series page of our catalog or website. This is simply the difference between the overall length of the X Probe and the working stroke. It is important to note that these dimensions may vary from series to series, so a separate calculation must be made for each probe series used in the fixture.



Step 1

#### STEP 2

Make a cross-sectional sketch of your fixture to calculate the total thickness of all fixture items that stack up between the top surface of the back plate and the UUT when the fixture is in the actuated position. This includes the probe plate, spacer plate, spacers, support plate, and board stops. This diagram is one example of a typical fixture.



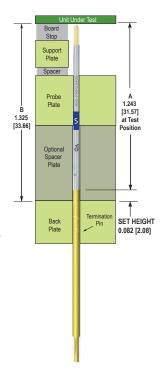
#### STEP 4

Subtract the at test position dimension (A) from total stack-up dimension (B).

Example X50-25:

- 1.325 [33.66] **(B)**
- 1.243 [31.57] (A)
- = 0.082 [2.08] Set Height

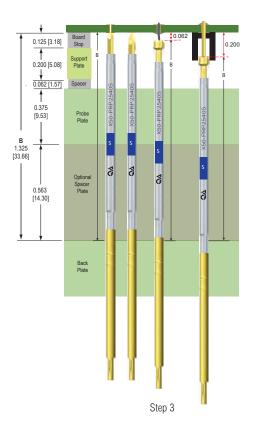
You can now use this set height dimension to install your termination pins with our ITR preset installation tools.



Step 4

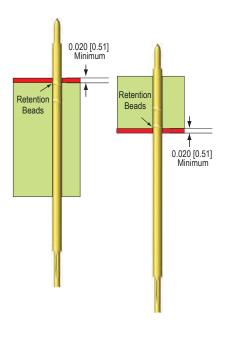
#### STEP 3

Add the thickness of the items that stack up on the top surface of the back plate to the contact surface of the UUT to get dimension **(B)**. If contacting leads, posts, or components, subtract the average length of these to adjust dimension (B).

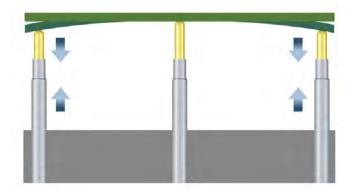


#### **ADDITIONAL CONSIDERATIONS**

To account for irregularities in the hole mounting, a margin of at least 0.020 [0.51] is recommended between the retention beads and the closest plate surface.



Consider board flexing and bowing. Be sure that all probes are stroked to at least their working stroke.



#### **Notes**

- Some calculations may result in a negative set height, which will require setting the termination pin below flush [0.00].
- Some tip styles will require an adjusted "at Test Position" dimension. If your chosen tip style has stroke limitations, a new "at Test Position" dimension should be determined before proceeding with a set height calculation.

# **Probe and Socket Installation** and Extraction

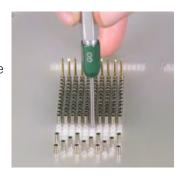
Ensuring that you install sockets and probes correctly provides the best pointing accuracy, retention force, and overall performance. Be sure to select the appropriately sized tool for the product you are using.

#### **Socket Installation**



#### STEP 1

Check that the mounting hole is sized correctly with the proper pin gauge (PG) tool. The RED NO-GO side should not enter the hole. while the GREEN GO side should slide into the hole confirming that the hole size is correct and ready for the socket.



When drilling laminates such as AT7000 and G10/FR4, there is usually a difference between the drill diameter and the actual measured diameter of the finished hole. Drill feed, spindle speed, and material affect choice of the proper diameter drill. QA Technology recommends solid carbide, printed circuit board drills with 1/8" shanks. For 025-16 series sockets, homogeneous plate materials such as Lucite®, Nylon, or Delrin are recommended options.

#### STEP 2

Insert the socket in the mounting hole with the termination side down. The socket should slide easily into the hole until the press ring contacts the top surface of the mounting plate.

If you are using 025-16 sockets with pre-attached wire in multi-plate fixtures, slide the socket threading (ST25) tool, reduced end first, into the plates until it is flush with the top plate. Then feed the 1.0 [25.40] long stripped end of the wire into the tool until it protrudes from the reduced end. Pull the wire through with the tool and slide the socket into the mounting hole.

## STEP 3

Insert the nose of the socket installation tool (ITR or ATR) over the top end of the socket and lightly tap it with a small hammer (THM-1) until the nose of the tool contacts the mounting plate. Take care not to damage the mounting plate. Sockets



installed with several light taps will have at least double the pushout force of sockets installed with a single blow.

For 025-16 sockets, push them flush with a small press or other controlled method such as a hard, flat pusher and apply force perpendicular to the mounting plate.

#### **Probe Installation**

It is important to use our probe installation (PT) tool to prevent damage to the sharpest of tip styles. Do not use a metal object as a pusher because it will damage the tip and plating on the plunger.

#### YOU WILL NEED

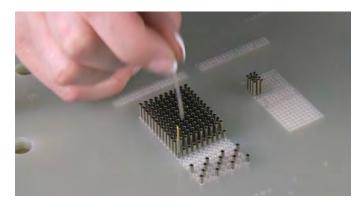
- Probes
- Probe Installation Tool (PT Tool)



Tweezers

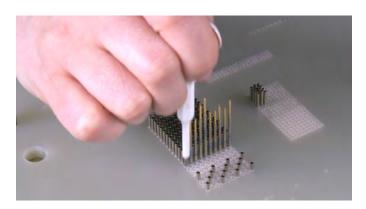
#### STEP 1

Place the probe into the socket by hand or with tweezers, avoiding the mouth area at the top of the probe tube.



#### STEP 2

Push straight down with our probe installation tool (PT) until the probe is seated in socket. You will feel resistance as the probe slides past the retention indents of the socket.



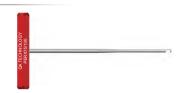
#### **Probe Extraction**

There are times when you will need to replace a worn or damaged probe. Here a few simple steps for this process.

The most effective methods are:

#### YOU WILL NEED -

 Probe Extraction Tool (PERX) or needle-nose pliers



#### STEP 1

For headed probes, slide the hook of the probe extraction tool (PERX) under the head and pull straight up to remove the probe. For headless probes, use needle-nose pliers.



If a plunger comes out or if it is broken off and leaves the probe tube and spring behind in a socket, you can remove it without damaging the socket. Always remove the remaining components such as the plunger or spring with needle-nose pliers to begin with any of the following options:

#### Option 1

#### **YOU WILL NEED**

 Tube Extraction Tool (TERX)



Needle-nose pliers

#### STEP 1

Use needle-nose pliers to remove any of the remaining components, such as the plunger or spring, from the broken probe.

#### STEP 2

Insert the tube extraction tool (TERX) into the broken or damaged probe tube. If the probe tube has become deformed, you can also use this tool to reform the tube. Push firmly into the probe tube, taking care not to push so hard that the socket will move, then pull the broken tube out.



If this tool is not available, we recommended a few other options:

## Option 2: Solder a piece of buss wire on the broken plunger.

#### STEP 1

Insert a plunger, point end first, or insert a buss wire into the damaged probe.

#### STEP 2

Solder the plunger or buss wire into the broken off probe tube. Be careful not to solder the probe tube into the socket. In some cases where the tube does not allow you to install a plunger, use a pointed awl or needle to reform the tube.

#### STEP 3

Pull the damaged tube from the socket with needle-nose pliers.

#### Option 3: Pin Vise and Drill Bit

#### STEP 1

Using a small pin vise and the proper size drill bit\*, insert the drill bit straight down into the broken probe tube and twist it.

#### \* Drill Bit Sizes:

039/X31 = Method #3 is not recommended as standard drill bits are not readily available

050/X39 = #70 Drill bit (.0280) [0.71]

075/X50 = #66 Drill bit (.0330) [0.84]

100/X75 = #57 Drill bit (.0430) [1.09]

#### STEP 2

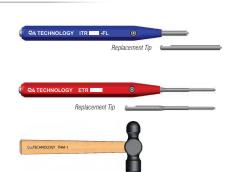
After a few rotations with the pin vise and drill bit, pull straight up. The drill bit will grab the ID of the damaged tube so that you can pull it straight out of its socket.

#### **Socket Extraction**

Extracting sockets on closely-spaced grids is a delicate process. Take care not to damage neighboring probes and not to enlarge the mounting hole. It may be necessary to remove probes from adjacent sockets to allow clearance for the tool.

#### YOU WILL NEED -

- Socket Installation Tool set FLUSH (ITRxxx-FL)
- Socket Extraction Tool (ETR)
- Hammer (THM-1)



#### STEP 1

Identify the socket from the bottom and move adjacent wires and components.

#### STEP 2

We recommend that you set the socket flush to avoid further damage or having it become wedged into the hole. Insert the nose of the flush installation (ITR-FL) tool into the socket and lightly tap until the nose of the tool sits flush with your mounting plate.



For 025-16 series sockets mounted in acrylic or similar plastics, you can remove the socket through the mounting plate by gently pulling on the pre-attached wire or body of the socket with needle nose pliers. It is often better to leave the probe in the socket if you are pulling on the socket with needle nose pliers because the probe helps the socket to resist crushing. If the wire is missing, you can push straight down on the back of the socket with a flat pusher, forcing the socket up through the mounting plate. You can also use a 0.021 [0.53] diameter gauge pin. Place it on top of the socket and gently push or tap the socket out.



#### STEP 3

Insert the nose of the socket extraction (ETR) tool, tapping it lightly several times until the damaged socket drops out the back side of the mounting plate.

There are situations where it is not possible to remove the socket by driving it through the mounting plate with our extraction tools, such as in a wireless fixture, in limited access areas, or when the socket is damaged.

#### Option 1

You can also remove from the top by using the buss wire soldering technique described previously for damaged probes. If the socket is not set flush, use the vise technique.

### Option 2

Remove sockets from the bottom by pulling carefully with needle-nose pliers. The socket tube will be crushed, but it will retain enough strength to allow it to be pulled out. Headless probes need not be removed first. Doing so will make the job easier since the spring inside reduces crushing of the socket tube and it will come through with the socket. Probes that are headed must first be removed from the top.

QA sockets with soldered tailpins may be pulled out by the tailpin since the joint between the socket tube and the tailpin is stronger than the tube itself.

### Option 3

You can also remove sockets from the top by soldering a piece of buss wire along the outside of the socket, then pulling on the wire to remove the socket. Special soldering fluxes are available for soldering to the Stainless Steel sockets.

### Option 4

You can push sockets out from the bottom by snipping off the tailpin and driving the socket out with a hammer (THM-1) and small metal pin. A small countersink on the end of the pin makes it easier to keep it aligned.

# **Socketless Termination** and X Probe® Installation and Extraction

Ensuring that you install termination pins and QA Technology X Probes® correctly provides the best pointing accuracy, retention force, and overall performance. Be sure to select the appropriately sized tool for the product you are using.

Termination pins are installed in the back plate of a fixture and are used to adjust the set height of the probe. They provide the electrical connection from the probe to the fixture wiring.

## **Termination Pin Installation**

## **YOU WILL NEED**

- Termination Pins
- Pin Gauge (PGxxx-xx)
- Termination Pin Insertion Tool (ITRxxx)

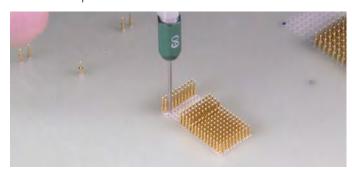




• Hammer (THM-1)

## STEP 1

Check that the mounting hole is sized correctly with the proper pin gauge (PG) tool. The RED NO-GO side should not enter the hole, while the GREEN GO side confirms the hole size is correct and ready for the termination pin.



When drilling laminates such as AT7000 and G10/FR4, there is usually a difference between the drill diameter and the actual measured diameter of the finished hole. Drill feed, spindle speed, and material affect choice of the proper diameter drill. QA Technology recommends solid carbide, printed circuit board drills with 1/8" shanks.

#### STEP 2

Insert the termination pin into the correctly gauged mounting hole, tail end first. The bottom retention bead should sit on top of the back plate. When termination pins have a pre-attached wire, thread the wire through the mounting hole and gently pull on the wire until the first retention bead contacts the back plate. Do not try to pull the retention beads through the plate by the attached wire as the wire could pull apart from the body of the termination pin.

#### STEP 3

Place the nose of the termination pin installation (ITRX) tool over the interconnect pin and tap lightly with a small hammer (THM-1) until the nose of the tool contacts the mounting plate. Because of the delicate nature of the ITRX31 and ITRX39 tools, take extra care so as not to damage the tool.

#### **CONSIDERATIONS**

Inaccurate hole sizes and excessive hammering can cause damage to the termination pins or fixture plates.



Sheared off retention beads leave metal shavings that could cause electrical shorts.



Mounting plate material may be displaced due to excessive hammering.



Damage to the shoulder of the termination pin and inconsistent set heights can occur with undersized holes or excessive hammering.

#### **Probe Installation**

It is important to use our probe installation (PT) tool to prevent damage to the sharpest of tip styles. Do not use a metal pusher because it can damage the tip and plating on the plunger.

#### YOU WILL NEED

- X Probes<sup>®</sup>
- Probe Installation Tool (PT Tool)
- Tweezers

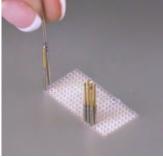


#### STEP 1

After the probe and optional spacer plates are installed, install the probe into the hole onto the termination pin by hand or with tweezers, avoiding the mouth area the probe tube.



Using the probe installation (PT) tool, push on the probe tip guiding it onto the termination pin. Continue pushing until you feel a positive click.





#### **CONSIDERATIONS**

Properly sized holes and installation is key. The following are some things to check if poor electrical contact or shorts are experienced:



Proper X Probe installation, bottom of probe tube is sitting on shoulder of Termination pin.



The X Probe may have missed the termination pin and is not making the connection. Remove the X Probe, verify plate alignment and re-install.



If the X Probe is sitting too high, it may not be seated properly. Continue pushing down until the connection is complete.



### **Probe Extraction**

To replace a worn or damaged probe, the following methods can be used.

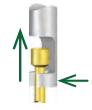
### YOU WILL NEED

 Probe Extraction Tool (PERX) or needle-nose pliers



### STEP 1

For headed probes, slide the hook of the probe extraction tool (PERX) under the head and pull straight up to remove the probe. For headless probes, use needle-nose pliers.



You can also remove a broken probe by using one of the following optional methods. Always remove the remaining components, such as the plunger or spring, with needle-nose pliers to begin.

### Option 1: Tube extraction tool

### YOU WILL NEED

 Tube Extraction Tool (TERX)





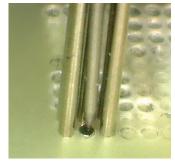
### STEP 1

Insert the tube extraction tool (TERX) into the damaged probe tube. If the tube has become deformed, you can also use this tool to reform the tube. Push firmly into the probe tube, taking care not to push so hard that the termination pin will move.

### STEP 2

Pull the broken tube out.





### Option 2: Solder a piece of buss wire on the broken plunger

### STEP 1

Insert a plunger, point end first, or insert a buss wire into the damaged probe.

### STEP 2

Solder the plunger or buss wire into the broken off probe tube. Be careful not to solder the probe tube into the mounting hole. In some cases where the tube does not allow you to install a plunger, use a pointed awl to reform the tube. Pull the damaged tube from the socket with needle-nose pliers.

#### STEP 3

Pull the damaged tube from the mounting hole with needle-nose pliers.

### Option 3: Pin Vise and Drill Bit

### STEP 1

Using a small pin vise and the proper size drill bit\*, insert the drill bit straight down into the broken probe tube and twist it.

#### \* Drill Bit Sizes:

039/X31 = Method #3 is not recommended as standard drill bits are not readily available

050/X39 = #70 Drill bit (.0280) [0.71]075/X50 = #66 Drill bit (.0330) [0.84]100/X75 = #57 Drill bit (.0430) [1.09]

### STEP 2

After a few rotations with the pin vise and drill bit, pull straight up. The drill bit will grab the ID of the damaged tube so that you can pull it straight from its mounting hole.

### **Termination Pin Extraction**

Damaged termination pins can be removed with or without the probe and optional spacer plates installed.

### YOU WILL NEED

- Termination Installation (□ATECHNOLOGY ITRX TOOI set FLUSH
  (ITRXxx-FL)
- Extraction Tool (ETRX)
- Hammer (THM-1)



### With the Probe and Spacer Plates Removed:

Following these instructions will ensure that the back plate will not be damaged when replacing a termination pin.

### STEP 1

We recommend the termination pin first be set to 0.000 or flush with an insertion (ITRX-FL) tool prior to extraction. (For termination pins set below 0.000, this step is not required).

### STEP 2

Place the nose of extraction (ETRX) tool onto the termination's interconnect pin and lightly tap with a small hammer (THM-1) until it's driven out. With care, the tool will also remove the termination pins with broken interconnect pins.





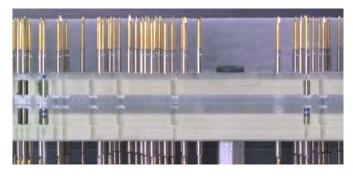
### With the Probe and Spacer Plates Installed:

### YOU WILL NEED

- Extended Extraction Tool (ETRX-E)
- Hammer (THM-1)



At times, it is not practical to remove all of the probes and disassemble the fixture in the field. Use our extended extraction (ETRX-E) tools to remove and re-install terminations pins in fixtures where the probe and spacer plates are installed.



### STEP 1

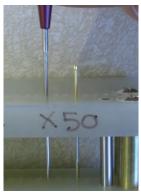
Remove the X Probe from the probe plate (see previous instructions).

### STEP 2

To help prevent damage to nearby contacts during extraction, identify the termination pin from the bottom side of the back plate and move adjacent wires and components.

### STEP 3

Guide the nose of the extended extraction (ETRX-E) tool into the mounting hole in the probe plate until the nose of the tool contacts the termination's interconnect pin.



Proper use of extraction tool with spacer & probe plates installed



Incorrect use of tool. ETRX-E tool may buckle.

### STEP 4

With a pencil or fine line marker, make a small mark on the shank of the tool located at the top of the probe plate. When installing the replacement termination pin, this mark is used to gauge the set height.



### STEP 5

Lightly tap on the extraction tool with a small hammer (THM-1) until the termination pin is driven out.

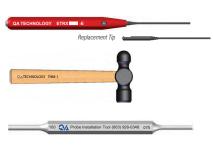
### Re-installing the Termination Pin with the Probe and Spacer Plates Installed:

### **YOU WILL NEED**

 Extended Extraction Tool (ETRX-E)







#### STEP 1

Check the mounting hole to make sure nothing is obstructing it. The extraction (ETRX-E) tool can be inserted into the hole to check this.



### STEP 2

Drop the replacement termination pin into the hole, tail first. If the termination pin hangs up in the hole, use the extraction (ETRX-E) tool to push it to its starting position on the top of the back plate.

### STEP 3

Lightly tap with a small hammer (THM-1) only to the point where the mark (made previously) on the tool shank aligns with the top of the probe plate. This ensures that it is set at the same height as the previously removed termination pin.

### STEP 4

Reinstall the proper X Probe with appropriate probe installation (PT) tool or other plastic pusher.

### STEP 5

Reconnect fixture wiring to the termination pin.

### **Notes**

If termination pins require more than a light tap of the hammer to seat on the back plate, verify the hole size and make modifications if required.

Replacement termination pins can be installed from the bottom side of the back plate without removing the probes or probe and optional spacer plates. A custom tool would have to be fabricated by the user to support the termination pin during installation and provide positioning to be set at the proper set height. On high-density fixtures, the congested wiring on the bottom side of the back plate could make this method particularly challenging.

The tools are designed to remove and install termination pins in back plates up to 0.625 [15.88] in thickness when the fixture is designed around QA's Fixture Layout Examples.

The wireless XTDS termination pins are used with both the X50 and X75 Probes. In cases where an X75 Probe is connected with an XTDS termination, the ETRX50-E tool would be used, not the ETRX75A-E tool.

Because of the delicate nature of the X31 and X39 tools, take extra care to avoid bending or damage.

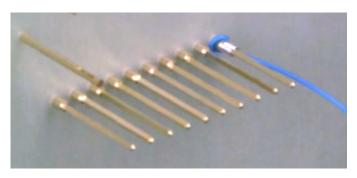
# **Wire Connection Methods**

There are many wiring options for your fixture. QA Technology offers several different methods to ensure that you make a reliable connection for successful testing. These include wire wrapping, soldering, and crimping, as well as wire grip sleeves, wire plugs, and wire jacks for smaller sizes.

# **Wire Wrap Type**

Wire wrapping is the most common wiring method for QA sockets and termination pins. For 75mil and larger centers, use 28AWG solid wire. For 50mil and smaller centers, use 30AWG solid wire to prevent crowding between adjacent sockets. Modified wraps are not recommended on 50mil centers. On all wire wrap pins longer than 0.250 [6.35], multiple wire wraps can be used.

For 50mil centers or smaller QA recommends insulating every other connection to prevent adjacent sockets from shorting. Our heat-shrinkable tubing (INS046-6) is stiffer than other types making installation easier. It is colored to help identify progress during the wrapping process.



### YOU WILL NEED

- "W" termination type socket or termination pin
- Wire wrapping tool
- Unwrapping tool

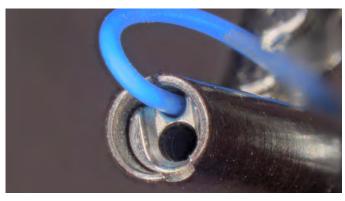


- Solid Kynar<sup>®</sup> insulated copper wire
- INS046 Insulated tubing (for 50mil and smaller)
- Needle-nosed pliers or tweezers

### Instructions

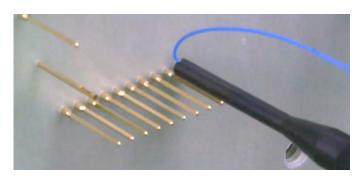
### STEP 1

Cut and strip one end of the wire. A minimum strip length of 0.625 [16] will achieve the recommended six to seven regular wire wrap turns. For 50mil centers or smaller see further insulating instructions.



### STEP 2

Insert the wire into the smaller of the two holes until the wire insulation contacts the face of the tool as shown.



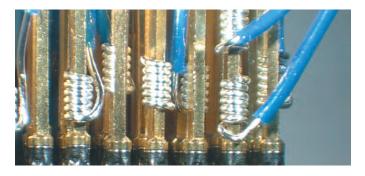
### STEP 3

Align the larger center hole with the pin and slide the tool down to the desired wrap location. The nose of the tool will determine the starting point of the wrap.

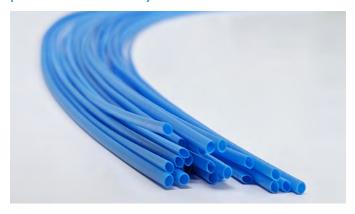


### STEP 4

Holding the insulated end of the wire firmly, apply gentle pressure downward and rotate the (WW) wire wrap tool. Do not pull the tool backwards or push with excessive force. Keep the tool on the pin until the wrap is completed.



# **Insulating Heat-Shrinkable Tubing** (for 50mil and smaller)



### Instructions

### STEP 1

Cut lengths of 0.500 [13] will completely cover the wire wrap post in most applications.

### STEP 2

Slide the tubing on every other wire BEFORE wrapping.

### STEP 3

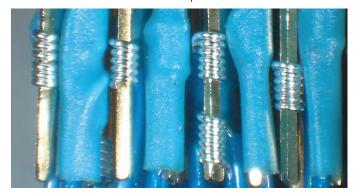
Wire wrap all pins.

### STEP 4

Slide the tubing to cover the wire wrap.

### **STEP 5 (OPTIONAL)**

Heat the tubing with a heat gun to make it shrink around the wire and hold it in place.



### Removal

### STEP 1

If shrink tubing is present, slit it lengthwise with a penknife and pull it off with needle-nose pliers, taking care to avoid damage to the surrounding wires.

### STEP 2

Place the (WU) unwrapping tool on the post, use moderate forward pressure, and rotate it in a direction opposite to the wrap until the coil has loosened enough to be removed by hand. The WU tool is double-ended for both clockwise (CW) and counterclockwise (CCW) wraps.

# Soldering Type

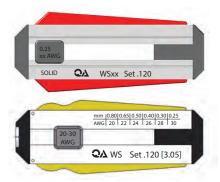
A solder connection is another common method to secure an electrical bond. QA offers a solder cup termination option for 75mil sockets and larger. QA suggests using lead-free solder. If choosing stranded wire, you may need the next smaller gauge. The accompanying chart indicates the maximum solid wire sizes that are suggested for the various solder cup sockets we offer.

SOLDER CUP TYPE Socket Part Number	WIRE DIAMETER In [MM]	WIRE GAUGE (AWG)
075-SDN250S	0.026 [0.660]	22
100-SDN250S	0.036 [0.914]	20 or 18
125-SD_250S	0.042 [1.067]	18
156-SD_250S	0.058 [1.473]	16 or 14
187-SD_250S	0.072 [1.829]	14 or 12

For 125, 156, and 187mil sizes, 12AWG and 10AWG wire can be used for high current testing. However, be sure that the wires are secured, as heavier wires can bend the sockets if not supported and adjacent sockets could touch or short.

# **Termination Types for Small Center Spacing**

Wire connections on small centers can be challenging. QA has wire grips, wire jacks, and wire plugs that are great wiring options. Refer to our catalog or website for connection style availability.



For wire grip, wire plug, or wire jack installation, use a solid Kynar insulated copper wire stripped to 0.120 [3.05] (multi-stranded wire is not recommended). QA offers wire strippers preset to this length for this purpose.

# Wire Grip Sleeve Installation

Wire grip sleeve connection is used with our "G" type termination socket or termination pin.



### YOU WILL NEED

- "G" termination type socket or termination pin
- Wire grip sleeve
- Solid Kynar insulated copper wire (28AWG or 30AWG)
- Needle-nosed pliers or tweezers
- GTR installation tool



# Instructions

### STEP 1

Slide the sleeve onto stripped wire.



### STEP 2

Lay the wire and sleeve into the channel of the wire grip installation tool (GTR) and slide it until the sleeve bottoms on the inner shoulder of the tool.



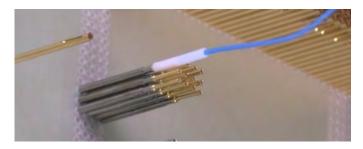
### STEP 3

While holding the wire firmly, push the wire until the insulation bottoms on the "G" type termination. The stripped wire will be exposed through the slot of the termination.



### STEP 4

Continue sliding the sleeve until the stripped wire stops on the shoulder of the socket or termination pin and the exposed wire is completely encased.



### Removal

Use needle-nose pliers to slide the sleeve off the wire, pulling straight back while wiggling the wire back and forth until the wire is freed. Remove any broken pieces to prevent possible shorting in the fixture.



### Wire Plug Installation

Wire plugs connect into any "P" type termination sockets.



### YOU WILL NEED

- "P" termination type socket
- Wire plug connection (28AWG or 30AWG)
- Solid Kynar insulated copper wire (28AWG or 30AWG)
- Needle-nosed pliers or tweezers
- WTR installation tool



### Instructions

### STEP 1

Insert the wire into the wire plug until the insulation stops against the internal shoulder and bare wire protrudes through the end of the wire plug.



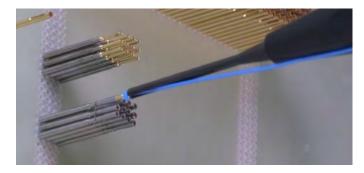
### STEP 2

Lay the wire into the channel of the wire plug installation tool (WTR) and slide it until the wire plug sits at the tip of the tool.



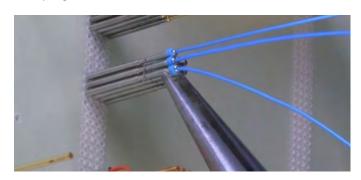
### STEP 3

Push the wire plug assembly into the back of the "P" type socket. You will feel a positive "click" when the assembly is complete.



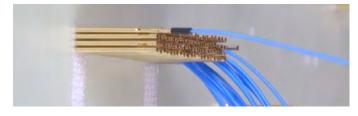
### Removal

Wire plugs are reusable and may be removed by pulling straight back on the wire plug as shown. The wire plug will remain attached to the wire.



### Wire Jack Installation

The wire jacks accepts 28AWG or 30AWG wire sizes and is available with or without pre-crimped wire. Wire jacks connect to "J" type sockets and termination pins.



### **YOU WILL NEED**

- "J" termination type socket or termination pin
- Wire jack connector and Solid Kynar insulated copper wire (28AWG or 30AWG) (use QA's CR2830 wire jack crimping tool or order wire jacks with precrimped wires)
- Needle-nosed pliers or tweezers
- O JTR installation tool



### Instructions

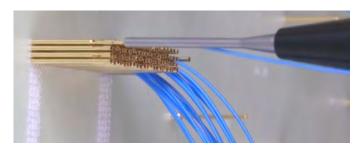
### STEP 1

Place the wire jack assembly into the wire jack installation tool (JTR) seat the wire jack insulator into the tip of the tool.



### STEP 2

Push the wire jack assembly into the back of the "J" type socket or termination pin. You will feel a positive "click" when the assembly is complete.



### Removal

Wire jacks are reusable and can be removed by pulling the wire jack straight back. The wire jack will remain attached to the wire.



### **Notes**

- If wire installation or retention force is noticeably reduced, the wire conductor or insulation could be worn or damaged. Simply cut and re-strip the wire to restore original forces.
- In high probe count or high-density applications where unsupported sockets/termination pins could flex because of wire tension, it may be necessary to add additional insulation to keep adjacent contacts from shorting. Use our INS046-6 heat shrinkable tubing for this purpose.
- Wire wrap tools can be obtained directly from JDV Products www.jdvproducts.com or other electronics tool distributor.

# **How to Verify Probe Stroke**

### YOU WILL NEED

Indicator Probes

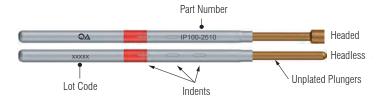
Hand-held calipers

Test probes are designed to be used at their working stroke, typically two thirds of their full stroke capability when testing. Test fixtures should be designed and built so that sockets or QA X Probe® termination pins are set at the correct height for probes to stroke at the working stroke when actuated by the unit under test (UUT).

When set too low, the spring force may be insufficient for a reliable electrical contact with the UUT. When set too high, the plunger will be over-stroked, causing early spring fatigue, tip damage, or other premature failures. Setting probes at the proper working stroke will achieve the highest first pass yields, maximize probe life, and reduce overall maintenance costs.

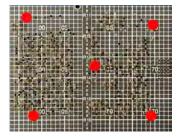
You can easily measure how much a probe is actuated during test by using QA's indicator probes. Indicator probes must not be used as electrical contacts as they remain compressed at the test position when actuated.

### **Indicator Probe Features**



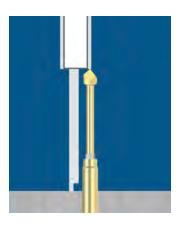
- Indents in the probe tube interfere with the free motion of the plunger and keep it in its deflected position.
- Plungers are un-plated to make it easy for you to identify them.
- Available in both headed and headless tip style versions. Always use a headless style when the fixture support plate has a built-in guided probe feature which uses a small plunger clearance hole.

Before installing indicator probes, remove the support plate and select a location to measure the current stroke of the probes. To get a good indication of the overall probe stroke in a fixture, it is common to measure at each corner of the probe field, and once in the center.



### STEP 1

Measure from the top of the probe plate surface to the tip of the standard, unactuated probe at each location where the indicator probes will be used. This will be used as "Dimension A" in the calculation. Hand-held calipers are perfect for this.



### STEP 2

Replace the standard probes at each of the five locations with indicator probes. Pressing down as far as they will go, the plungers will stick down.

### STEP 3

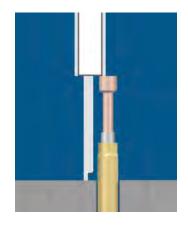
Using tweezers or needle nose pliers, pull up on each of the indicator probe plungers, bringing them back up to their original position. Be careful not to pull the probe out of the socket or termination pin.

### STEP 4

Reassemble the fixture and cycle one time only. The indicator probe plungers will remain in the deflected position, showing their position when the fixture is actuated.

### STEP 5

Measure from the probe plate surface to the actuated indicator probe tip. This will be "Dimension B" in the calculation. Repeat at each indicator probe location to ensure that all are stroked a similar amount across the entire field.



The height difference between the original test probe and the indicator probe is the amount of plunger stroke that occurs when the fixture is actuated in production.

### Example:

0.580	Dimension A (height of the existing	
	probes in the fixture)	
- 0.413	Dimension B (height of indicator probe	
	from the top of probe plate)	
= 0.167	Amount of probe stroke when the fixture	
	is actuated in production	

### STEP 6

Compare the actual plunger stroke findings to the "working stroke" rating for each probe series listed in our catalog/probe guide or website. Sockets or termination pins should be lowered if probes are being over-stroked. If they are being under-stroked, sockets or termination pins must be replaced at a higher set height to achieve the proper stroke.

### STEP 7

Remove the indicator probes and make any necessary modifications to the set height of the socket or termination pins.

### STEP 8

Re-install the original probes and reassemble the support plate back onto the fixture. Now you are ready to use the fixture.

### **Notes**

Select a headless probe in the location that will measure the stroke of probes hitting vias or test pads. Use a headed probe for a location that will test a lead or post.

Replace an indicator probe after a few actuations as it will lose its ability to remain in the deflected position.

# **Probe Maintenance**

Keeping your test probes in good working condition is key to making a reliable test and keeping probes at their optimum performance. Over time, in high volume production environments or even in low volume applications where the fixtures may be stored for months at a time, contaminants and debris can build up and cause false failures, yet you may not find any defects. To help reduce these contact problems, save time and money, QA Technology recommends the following:

# **Maintenance Program**

A practical maintenance program can save considerable time and money. This creates a more reliable test, reducing the chance of false failures and lost rework expense. Use cycle counters on test fixtures to help establish a routine maintenance program, whether it be cleaning the probe tips or replacing the probes after a predetermined number of cycles.



Developing a program requires some tracking to determine the average life of the probes in your application. Certain environments call for probe replacement as often as every few thousand cycles. while in clean applications probes can last far longer. Increased test yields and reduced downtime are the rewards for keeping probes in top condition.

# **Probe Cleaning**

To clean the contaminants that build up on the probes, gently brush the probe tips with QA's natural fiber brush (TBR-1) and vacuum away the dislodged particles. QA does not recommend the use of metallic bristles because they may damage the probe plating.





QA uses a small amount of lubricant to minimize wear caused by the internal sliding contact surfaces of our probes. Never use cleaning solvents on your probes as it may wash particles down into the critical internal surfaces. This could affect the performance and shorten the life of your probes.



### **Good Housekeeping Suggestions**

Here are recommendations to help keep test probes clean and maximize cycle life:



Probe Storage – Good maintenance begins with careful storage. Before populating your fixture, leave probes in their original packaging to protect them from damage and to keep them labeled and organized.

Test Environment – Minimize airborne contamination such as dust, clothing fibers, or particles from nearby wave-solder machines and other manufacturing processes that create airborne particulates.

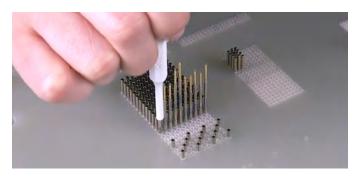
Circuit Boards - Printed circuit boards should be as clean as possible. If you are testing boards coated with no-clean flux, choose low-solids fluxes and fine-tune process controls to minimize the amount of flux applied to the board. Testing contaminated boards will not only cause poor contact on new probes, but also will leave residues behind on the probe tips and thus impede the next test.

Dust Covers - Use dust covers over idle fixtures or receiver bays to prevent airborne contaminants from settling on the probe tips. In the case of vacuum fixtures, dust that settles on the board test area is drawn directly onto the test probes when you first put the fixture into use.

Air Filters - When a vacuum fixture is released, room air rushes into the fixture around the test probes. Protect the probes from airborne contamination by installing an air filter in the release port.

# **Probe Replacement**

Eventually, you will need to replace probes. Do so when cleaning is no longer effective or when you record a decrease in performance. Due to their small sizes and features, worn, blunt or damaged tips may not be readily visible while spring fatigue will often show up as a plunger that does not extend to its full height after being compressed.



Diagnosing contact problems as they arise and replacing individual probes may work in the short term but as probes reach the end of their life, the added maintenance time is more expensive compared to a full maintenance schedule.

# **Tool Tip Replacement** Instructions

QA Technology tools are designed to allow for easy replacement of a damaged or worn-out tip without having to return the tool for repair. We offer several different replacement methods for various tool products. Please see our catalog or website for individual replacement part numbers. The following are instructions for the different tools we offer.

### **Tool Variations**



### SPECIAL NOTES BEFORE YOU BEGIN:

 Since the handles and TIPS are engraved with the specific tool part number, it is important to match the one being replaced to avoid an improper set height or damage to an associated component.



- Applying low heat to the threaded area with a torch will help to loosen threads when Loctite has been applied.
- Clean the internal threads and smooth bore with compressed air or a cotton swab. If needed use a mild solvent to help dissolve contaminants and to dry the part.
- All threaded assemblies are right hand threads.

### **Replacement Instructions**

### STEP 1

Clamp the handle in a vise to remove damaged/worn/ broken tip assembly. Use soft jaws to prevent damage to the handle.

### STEP 2

Remove the tip from the handle.

### Style: ITR-SET

Using the 4.5mm open ended wrench, unscrew the ITR-TIP from the handle.



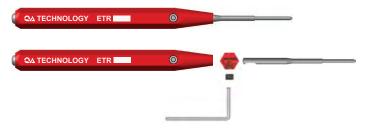
### STEP 3

Thread the replacement tip until it is tightened by using the 4.5mm wrench. Be sure that the tip is tightened securely. Your tool is now ready for use.



### Style: ITR-FL, ETR, WTR, JTR, GTR AND TERX

Using the 1.5mm hex key, loosen the set screw from the handle and pull out the tip.



### STEP 3

Insert the replacement tip into the bottom of the bore while keeping the flat side on the set screw side.

### STEP 4

Tighten the set screw with the 1.5mm hex key. Your tool is now ready for use.

### Style: ATR

### STEP 1

Loosen the two 3mm thimble locking hex screws with the 1.5mm hex wrench key.

### STEP 2

Remove the thimble from the handle by unscrewing the two assemblies.

### STEP 3

Using the 4.5mm wrench, unscrew the stop tube from the thimble.

### STEP 4

Using the 1/16" wrench, unscrew the drive pin from the handle.

### STEP 5

Screw the drive pin with 5-40 thread onto handle, tighten with a 1/16" wrench.

### STEP 6

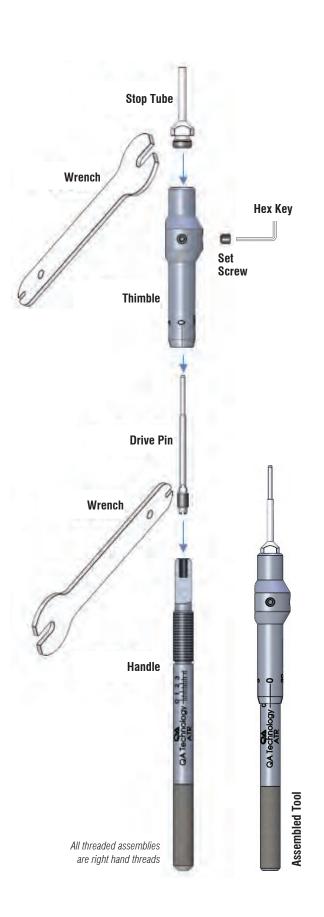
Screw the stop tube with 10-32 thread onto the thimble and tighten it with 4.5mm wrench.

### STEP 7

Thread the thimble onto the handle.

### STEP 8

Set the tool to the desired set height and tighten the 3mm set screws to maintain the setting.



# **Socket Plugs**

QA Technology's socket plugs are a quick and easy solution to plug a conventional socket where a test point is no longer needed. They eliminate the possibility of re-installing a probe that could cause a test error.

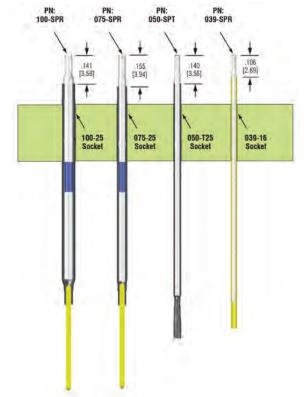
The top of the socket plugs will not contact the UUT when the test probes in the fixture are actuated to the recommended working stroke. For applications where the probes are being over-stroked, it is important to verify that the socket plugs will not contact the UUT when the fixture is actuated.

Socket plugs are available for use the following sockets:

SOCKET SERIES	PART NUMBER	
100-25	100-SPR	
100-40		
075-25	075-SPR	
075-40	0/3-3FN	
050-T25	050-SPT	
050-T40		
039-25	039-SPR	
039-40		

### Instructions

- Insert the applicable socket plug into a conventional socket with the smaller diameter end facing up into a conventional socket until it bottoms.
- o If the test point is to be used again, simply remove the socket plug and re-install the proper probe.





All videos can be found at: https://www.qatech.com/en/resources-videos/resources-videos.html









# **7 Factors that Affect Probe Life**



# **How to Calculate Socket Set Heights**



# **How to Calculate X Probe Termination Pins Set Heights**



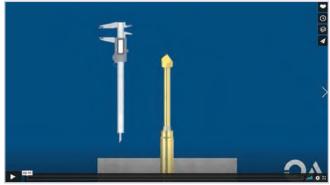
# **Probe and Socket Installation and Extraction**





# Wire Wrapped Tail ull 🜣 :: vimeo





# **X Probe Socketless Installation and Extraction**



# **Wire Connection Methods**



**Tool Tip** Replacement



**How to Measure Probe Stroke** 





# Do probe extraction tools (PERX) remove all probes in all series?

No. They are designed to remove headed probes only. These tools are ideal in cases where many headed probes must be removed quickly without damaging the probe. For headless probes and probes on closer centers, QA recommends miniature precision long nose pliers. Users must be careful when removing probes that are to be reused because pliers can damage the plating and/or bend the plunger.

# Can the probe tube be soldered directly to the termination/fixture?

Probe tubes are typically made from nickel silver and this material is easily soldered to. Take precautions to prevent the solder from flowing into the probe tube ID. Solder in the probe tube ID could cause the plunger to stick or prevent the plunger from fully compressing. This application is common when installing probes directly into PCBs.

# What is the difference between the 050-R25 and 050-T25 Series?

The main difference is that the 050-R25 Series has a longer probe tube compared to the 050-T25 Series. The increased length of the 050-R25 probe tube allows more space for higher force springs to be used. The 050-T25 series is compatible to mix mount with other sized wireless applications.

# What material is recommended for mounting the sockets and termination pins into?

In general, any nonconductive material is suitable with the most popular socket mounting plate made from an epoxy fiberglass AT7000, G10, or FR4. This is the same material used in the manufacturing of printed circuit boards. Other suitable materials include but are not limited to Acrylic, polycarbonate, PVC, and Delrin. The socket retention forces will vary between materials and must be considered in fixture design. For our X Probe® termination pins, we recommend using epoxy fiberglass laminates (G10/FR4, etc.) for the back plate due to the retention requirements of the termination pins. Our published suggested mounting hole sizes are designed for epoxy fiberglass laminates.

# What is the maximum voltage that test probes and sockets can carry?

There is no maximum recommended voltage limits for test probes and sockets/termination pins. However, the spacing between the probes and the dielectric properties of the probe plate must be taken into consideration. Avoid probe plate materials that have hygroscopic tendencies. The test voltage to the fixture/DUT must be applied only after the fixture is activated and the probes are compressed and contacting the DUT. Voltage applied prior to the probe's tips making contact will cause electrical arcing which will damage or melt the tips.

# When and where is the -B option (curved probe tube) used?

The -B option is designed for use with the old-style Pylon brand sockets that do not incorporate a probe retention indent. The bend in the probe tube acts as the retention feature to hold the probe in the socket. As a rule, we do not recommend that the –B option be used with QA sockets as our sockets incorporate probe retention indents. For older sockets where the probe retention indent has been damaged, or if the probes are loose or are being pulled out during test, using the -B option is a suitable solution until a replacement of the socket can be made.

# Can QA Probes be used for Hipot testing

Yes. Hipot testing is an abbreviation for High Potential Testing and is also called Dielectric Withstanding Voltage (DWV) test. This test applies an over voltage condition to the device and is used to verify that the electrical insulation in the device does not break down and is sufficient to protect the operator from electrical shock in PCBs, transformers, electric motors, finished appliances, cables, or other wired and wireless assemblies.

When test probes are used as the interface between the Hipot Tester and UUT, we recommend the following:

- The probes must contact the terminals on the UUT and must be compressed before you run the test.
- Do not retract probes from the UUT until the test is complete and the voltage has been cut off.
- Any contaminants between the tips of the probes and UUT will act as insulation that will cause high resistance at this junction. In turn, the higher resistance will cause loca-lized heating and possible arcing at the tip.
- Maintain sufficient distance and/or insulation between the conductors to prevent the electricity from arcing between the bare plungers.
- Over time, the sliding plated surfaces will degrade faster compared to low voltage applications and may require increased maintenance.
- Use the largest probe you can with the highest spring forces.

# How many times can the same X Probe be reinstalled on a termination pin?

An X Probe can be reinstalled on the same termination pin a maximum of five times. After this, the probe retention is reduced to the point where the probe is loose on the termination pin. The probe retention indents are the mechanical features that hold the probe to the termination pin. Because of the tolerance variability of the mating parts, a probe that is installed onto a different termination pin on which it was originally installed may have lower or higher forces. In the case of low forces, the probe should be replaced with a new one. The probe is designed to be the "wear point" in the system. By replacing the probe, you will restore the retention force.

# Will termination pins wear or degrade over time?

The termination pin is designed to last the life of the fixture under normal operating conditions.

# Can the QA X Probe be used on existing test platforms?

Yes. The X Probe is compatible with Keysight, Genrad, Teradyne, and others. Fixture designs must be able to accommodate the additional plates. In general, the height of the fixture is increased and in the case of Keysight compatible fixtures, wider rails (up to one inch, depending on the set height) are required to maintain the depth of the wiring area to accommodate the personality pins and alignment plate. The X-16 series does not require an increase in the fixture height and can be used on existing test platforms with minimal fixture modifications.

# Can the X Probe be used with pneumatic, mechanical, and vacuum fixtures?

Yes. The X Probe design does not limit the type of fixtures that they can be used on.

# Can standard test probes and sockets be mixed mounted with the X Probe Series?

Yes. With design considerations standard test probes can be mixed mounted with the X Probe Series. A standard socket would mount in the probe plate and clearance holes would have to be drilled in the spacer and back plates. In a vacuum fixture, a method would have to be designed to maintain the integrity of the vacuum. The best approach is to cut out areas in the plates where the sockets will be mounted and design inserts with gaskets to accommodate them.

# Is a spacer plate necessary?

No. The spacer plate is an optional intermediate support plate that, when fixed to the back plate, provides additional strength, and helps with the alignment of the probe to the termination pin during probe installation. On small to medium sized fixtures this can be replaced with fixture standoffs or flanges.

# How are additional X Probes and termination pins added to a completed fixture?

Because the X Probe system relies on accurately drilled and aligned holes, the recommended approach is to remove all the probes and plates. The new hole locations must be accurately registered from the original reference points so that the X Probe and termination pin will align during assembly.

# How much weight will be added to a fixture designed around the X Probe?

20lbs [9.1Kg] for an average sized fixture. An X Probe fixture requires a top (support) plate, a probe plate, a spacer plate, and a back plate while the conventional fixture has a top plate and a probe (socket mounting) plate.

# When comparing the prices of two identical test fixtures, one built with standard probes and the other with QA X Probes, how do their costs compare?

It depends. The purpose of a socketless probe is to put a larger probe on closer centers. Meaning, X Probe socketless technology was developed for fixtures requiring larger quantities of 75mm, 50mm, and 39mm center probes than 100mm center probes.

Please keep in mind that QA does not build fixtures. QA manufactures test probes in service and support of the in-circuit test industry. Only a fixture house can determine actual fixture costs and pricing. The following is a guideline to determine if X Probe technology should be considered for your fixture.

A best guesstimate comparing conventional probe costs to QA X Probe costs would be:

- If a fixture is predominately 100mm centers, the cost of using X Probe socketless technology would be greater than a conventional 100mm center probe fixture.
- If a fixture requires predominately 75mm centers, the cost of using X Probe socketless technology could be equal to or less than a 75mm center conventional probe fixture.
- If a fixture requires predominately 50mm centers, the cost of using X Probe socketless technology could be equal to or less than a conventional 50mm center probe and socket fixture.
- If a fixture requires predominately 39mm and smaller centers, the cost of using X Probe socketless technology should be less than a conventional 39mm center probe and socket fixture.

When my father, Thomas Coe, founded QA Technology in 1981, he committed to build a company that would provide the best quality product and service that our customers demanded and deliver it to them in a timely manner. He knew that to do it he would have to build a team that was similarly committed to that goal and would work together to achieve it. In his own words, QA's guiding principles are:

**QUALITY ALWAYS COMES FIRST** – The quality of our products and services is our number one priority, along with the customer satisfaction and continuous improvement to the excellence of our products and services.

**PEOPLE** – Our people are the source of our strength. They determine our reputation and vitality. Teamwork and involvement are our core human values. We trust and respect each other.

**SERVICE** – We strive to give the best possible service to our customers, who are the focus of what we do. As our service is viewed, so are we viewed.

Sadly, Tom Coe passed away in 2009, just a few days short of his 80th birthday, but happily he saw his vision successfully grow and manifest itself in the globally recognized company that QA is today. All of the people that continue to make up the QA 'team' remain steadfastly committed to his original vision. Please tell us how we can help you solve your probing or interconnect problems.

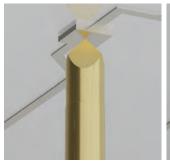
Sincerely,

David S. Coe President

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Harl & Coe











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